4.1. Core dictionary (coreCIF)

BY S. R. HALL, F. H. ALLEN AND I. D. BROWN

This is version 2.4.2 of the core CIF dictionary (coreCIF). A commentary on the use of this dictionary may be found in Chapter 3.2.

The data names defined here are central to the description and reporting of any crystal structure determination, and this dictionary collects the natural set of descriptors for small-unit-cell structures (typically inorganic or small-molecular organic and metal-organic compounds) determined in single-crystal experiments. These data items may be supplemented by additional items designed for use in powder-diffraction experiments (Chapter 3.3), modulated and composite structures (Chapter 3.4), or electron-density studies (Chapter 3.5).

The data items in this dictionary also form a suitable basis for the description of biological macromolecular structures, but the complexity of such structures requires a more extensive dictionary using a rigorously relational data model that expresses dependencies and inheritances between individual items. The macromolecular CIF (mmCIF) dictionary described in Chapter 3.6 and given in Chapter 4.5 provides a complete set of data items within this model, including the content of the core CIF dictionary in a modified formalism.

Categories are described in alphabetic order; data items are arranged alphabetically within each category.

ATOM_SITE

Data items in the ATOM_SITE category record details about the atom sites in a crystal structure, such as the positional coordinates, atomic displacement parameters, and magnetic moments and directions

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

```
loop
_atom_site_label
_atom_site_fract_x
_atom_site_fract_y
atom site fract z
atom site U iso or equiv
atom site adp type
 atom site calc flag
 atom site calc attached atom
                   .5699(1)
                              .3026(0)
  01
        .4154(4)
                                         .060(1)
                                                   Uani
                                                         ?
                                                                ?
                   .5087(2)
  C2
        .5630(5)
                              .3246(1)
                                         .060(2)
                                                   Uani
                                                          ?
                                                                ?
  C3
        .5350(5)
                   .4920(2)
                              .3997(1)
                                         .048(1)
                                                   Uani
                                                                ?
  N4
        .3570(3)
                   .5558(1)
                              .4167(0)
                                         .039(1)
                                                   Uani
                                                                ?
  C5
        .3000(5)
                   .6122(2)
                              .3581(1)
                                         .045(1)
                                                   Uani
                                                          ?
                                                                ?
        .6958(5)
                              .2874(1)
  021
                   .4738(2)
                                         .090(2)
                                                   Uani
                                                                ?
                                                          ?
  C31
       .4869(6)
                   .3929(2)
                              .4143(2)
                                         .059(2)
                                                   Mani
                                                                ?
          - data truncated for brevity
                   .318(3)
  H321C
                              .320(2)
                                                                ?
          .04(1)
                                         .14000
                   .272(4)
                              .475(3)
  H322A
          .25(1)
                                         .19000
                                                   Uiso
                                                          ?
  H322B
          .34976
                   .22118
                              .40954
                                         .19000
                                                   Uiso
                                                          calc C322
  H322C
          .08(1)
                   .234(4)
                              .397(3)
                                         .19000
                                                          ?
                                                   Uiso
```

Affiliations: SYDNEY R. HALL, School of Biomedical and Chemical Sciences, University of Western Australia, Crawley, Perth, WA 6009, Australia; FRANK H. ALLEN, Cambridge Crystallographic Data Centre, 12 Union Road, Cambridge, CB2 1EZ, England; I. DAVID BROWN, Brockhouse Institute for Materials Research, McMaster University, Hamilton, Ontario, Canada L8S 4M1.

```
Example 2 - based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst.
(1991), C47, 2276-2277].
loop
atom site aniso label
atom site aniso B 11
atom site aniso B 22
_atom_site_aniso_B_33
atom_site_aniso_B_12
_atom_site_aniso_B_13
atom_site_aniso_B_23
atom site aniso type symbol
      .071(1) .076(1) .0342(9) .008(1)
                                            .0051(9) -.0030(9) O
01
      .060(2) .072(2) .047(1)
                                 .002(2)
                                            .013(1)
                                                     -.009(1)
C2
C3
      .038(1) .060(2) .044(1)
                                 .007(1)
                                            .001(1)
                                                     -.005(1)
                                                                C
                                 .0025(9)
N4
      .037(1) .048(1)
                       .0325(9)
                                            .0011(9)
                                                     -.0011(9)
                                                                N
      .043(1) .060(1) .032(1)
                                 .001(1)
                                           -.001(1)
                                                       .001(1)
     - - - data truncated for
# -
                               brevity
                                            .038(1)
     .094(2) .109(2) .068(1)
                                 .023(2)
                                 .002(1)
C51
      .048(2) .059(2) .049(1)
                                           -.000(1)
                                                       .007(1)
                                                                C
C511 .048(2) .071(2) .097(3)
                                -.008(2)
                                           -.003(2)
                                                       .010(2)
                                                                C
C512 .078(2) .083(2) .075(2)
                                 .009(2)
                                           -.005(2)
                                                       .033(2)
                                                                C
C513 .074(2) .055(2) .075(2)
                                 004(2)
                                            001(2)
                                                      -.010(2)
                                                                C
# - - - data truncated for brevity
Example 3 - based on data set DPTD of Yamin, Suwandi, Fun, Sivakumar & bin
Shawkataly [Acta Cryst. (1996), C52, 951-953].
loop
atom site label
_atom_site_chemical_conn_number
_atom_site_fract_x
atom_site_fract_y
atom site fract z
atom site U iso or equiv
S1 1 0.74799(9)
                     -0.12482(11)
                                    0.27574(9)
                                                 0.0742(3)
     2 1.08535(10)
                     0.16131(9)
                                    0.34061(9)
                                                 0.0741(3)
S2
       1.0650(2)
                                    0.2918(2)
N1
                     -0.1390(2)
                                                 0.0500(5)
     3
     4 0.9619(3)
                     -0.0522(3)
C1
                                    0.3009(2)
                                                 0.0509(6)
# - - - data truncated for brevity - - -
Example 4 - hypothetical example to illustrate the description of a disordered
methyl group.
100p
  atom site label
                        # * assembly M is a disordered methyl
   atom site occupancy # with configurations 'A' and 'B':
   _atom_site_disorder_assembly #
  atom_site_disorder_group
                                      H11B
                                               H11A
   C1
   H11A
          .5
                  м
                          Α
   H12A
          .5
                 M
                          Α
                                                C1 --
                                                        ----C2---
   H13A
          .5
                  М
                          Α
   H11B
          .5
                  м
                          В
   H12B
          .5
                  м
                          В
```

atom site adp type

. 5

н13в

(char)

H13A

A standard code used to describe the type of atomic displacement parameters used for the site.

H12A

H12B

Appears in list containing _atom_site_label.

М

Related item: _atom_site_thermal_displace_type (alternate).

The data value must be one of the following:

```
Uani anisotropic U^{ij}
Uiso isotropic U
Uovl overall U
Umpe multipole expansion U
Bani anisotropic B^{ij}
Biso isotropic B
Bovl overall B
```

[atom_site]

_atom_site_aniso_B_11
_atom_site_aniso_B_12
_atom_site_aniso_B_13
_atom_site_aniso_B_22
_atom_site_aniso_B_23
_atom_site_aniso_B_33

(numb, su)

These are the standard anisotropic atomic displacement components in ångströms squared which appear in the structure-factor term

$$T = \exp\left\{-(1/4)\sum_{i}\left[\sum_{j}(B^{ij}h_{i}h_{j}a_{i}^{*}a_{j}^{*})\right]\right\},\,$$

where h = the Miller indices and $a^* =$ the reciprocal-space cell lengths.

The unique elements of the real symmetric matrix are entered by row. The IUCr Commission on Nomenclature recommends against the use of **B** for reporting atomic displacement parameters. **U**, being directly proportional to **B**, is preferred.

Appears in list containing _atom_site_aniso_label.

Related item: atom site aniso U (conversion).

[atom site]

atom site aniso label

(chai

Anisotropic atomic displacement parameters are usually looped in a separate list. If this is the case, this code must match the _atom_site_label of the associated atom in the atom coordinate list and conform with the same rules described in _atom_site_label.

Appears in list. Must match parent data name _atom_site_label. [atom_site]

atom site aniso ratio

(nun

Ratio of the maximum to minimum principal axes of displacement (thermal) ellipsoids.

Appears in list containing _atom_site_aniso_label.

The permitted range is $1.0 \rightarrow \infty$.

[atom_site]

_atom_site_aniso_type_symbol (char)

This <u>_atom_type_symbol</u> code links the anisotropic atom parameters to the atom-type data associated with this site and must match one of the <u>_atom_type_symbol</u> codes in this list.

Appears in list containing _atom_site_aniso_label. Must match parent data name _atom_site_type_symbol. [atom_site]

_atom_site_aniso_U_11 _atom_site_aniso_U_12 _atom_site_aniso_U_13 _atom_site_aniso_U_22 _atom_site_aniso_U_23 atom_site_aniso_U_33

(numb, s

These are the standard anisotropic atomic displacement components in ångströms squared which appear in the structure-factor term

$$T = \exp \left\{ -2\pi^2 \sum_i \left[\sum_j (U^{ij} h_i h_j a_i^* a_j^*) \right] \right\},$$

where h = the Miller indices and $a^* =$ the reciprocal-space cell lengths.

The unique elements of the real symmetric matrix are entered by row.

Appears in list containing _atom_site_aniso_label.

Related item: _atom_site_aniso_B_ (conversion).

[atom_site]

atom site attached hydrogens

(numb)

The number of hydrogen atoms attached to the atom at this site excluding any hydrogen atoms for which coordinates (measured or calculated) are given.

Appears in list containing ${\tt _atom_site_label}.$

The permitted range is $0 \rightarrow 8$. Where no value is given, the assumed value is '0'.

Examples: '2' (water oxygen), '1' (hydroxyl oxygen), '4' (ammonium nitrogen).

[atom site]

atom site B equiv geom mean

(numb, su)

Equivalent isotropic atomic displacement parameter, B_{equiv} , in ångströms squared, calculated as the geometric mean of the anisotropic atomic displacement parameters.

$$B_{\text{equiv}} = (B_i B_j B_k)^{1/3},$$

where B_n = the principal components of the orthogonalized B^{ij} .

The IUCr Commission on Nomenclature recommends against the use of **B** for reporting atomic displacement parameters. **U**, being directly proportional to **B**, is preferred.

Appears in list containing _atom_site_label.

The permitted range is $0.0 \rightarrow \infty$.

Related items:

_atom_site_B_iso_or_equiv (alternate),
atom site U equiv geom mean (conversion).

[atom site]

_atom_site_B_iso_or_equiv

(numb, su)

Isotropic atomic displacement parameter, or equivalent isotropic atomic displacement parameter, $B_{\rm equiv}$, in ångströms squared, calculated from anisotropic displacement components.

$$B_{\text{equiv}} = (1/3) \sum_{i} \left[\sum_{j} (B^{ij} A_i A_j a_i^* a_j^*) \right],$$

where A = the real-space cell lengths and a^* = the reciprocal-space cell lengths; $B^{ij} = 8\pi^2 U^{ij}$.

Reference: Fischer, R. X. & Tillmanns, E. (1988). *Acta Cryst*. C44, 775–776.

The IUCr Commission on Nomenclature recommends against the use of **B** for reporting atomic displacement parameters. **U**, being directly proportional to **B**, is preferred.

Appears in list containing _atom_site_label.

The permitted range is $0.0 \rightarrow \infty$.

Related items:

_atom_site_B_equiv_geom_mean (alternate), atom site U iso or equiv (conversion).

[atom site]

atom site calc attached atom

(char

The _atom_site_label of the atom site to which the 'geometry-calculated' atom site is attached.

Appears in list containing <code>_atom_site_label</code>. Where no value is given, the assumed value is '.'. <code>[atom_site]</code>

atom site calc flag

(char)

A standard code to signal whether the site coordinates have been determined from the intensities or calculated from the geometry of surrounding sites, or have been assigned dummy coordinates. The abbreviation 'c' may be used in place of 'calc'.

Appears in list containing **_atom_site_label**.

The data value must be one of the following:

d determined from diffraction measurements calc calculated from molecular geometry

c abbreviation for 'calc'

dum dummy site with meaningless coordinates

Where no value is given, the assumed value is 'd'. [atom_site]

```
_atom_site_Cartn_x
_atom_site_Cartn_y
atom_site_Cartn_z
```

(numb, su)

The atom-site coordinates in ångströms specified according to a set of orthogonal Cartesian axes related to the cell axes as specified by the atom sites Cartn_transform_axes description.

Appears in list containing _atom_site_label.

Related item: _atom_site_fract_ (alternate).

[atom_site]

atom site chemical conn number

(numb)

This number links an atom site to the chemical connectivity list. It must match a number specified by _chemical_conn_atom_number.

Appears in list containing _atom_site_label. Must match parent data name _chemical_conn_atom_number.

The permitted range is $1 \to \infty$.

[atom site]

atom site constraints

(char)

A description of the constraints applied to parameters at this site during refinement. See also _atom_site_refinement_flags and refine ls number constraints.

Appears in list containing **_atom_site_label**. Where no value is given, the assumed value is '.'.

Example: 'pop=1.0-pop(Zn3)'.

[atom_site]

atom site description

(char

A description of special aspects of this site. See also <u>_atom_site_</u>refinement_flags.

Appears in list containing _atom_site_label.

Example: 'Ag/Si disordered'.

[atom_site]

atom site disorder assembly (cha

A code which identifies a cluster of atoms that show long-range positional disorder but are locally ordered. Within each such cluster of atoms, _atom_site_disorder_group is used to identify the sites that are simultaneously occupied. This field is only needed if there is more than one cluster of disordered atoms showing independent local order.

Appears in list containing **_atom_site_label**.

Examples: 'A' (disordered methyl assembly with groups 1 and 2), 'B' (disordered sites related by a mirror), 'S' (disordered sites independent of symmetry). [atom_site]

atom site disorder group

A code which identifies a group of positionally disordered atom sites that are locally simultaneously occupied. Atoms that are positionally disordered over two or more sites (*e.g.* the hydrogen atoms of a methyl group that exists in two orientations) can be assigned to two or more groups. Sites belonging to the same group are simultaneously occupied, but those belonging to different groups are not. A minus prefix (*e.g.* '-1') is used to indicate sites disordered about a special position.

Appears in list containing ${\tt _atom_site_label}.$

Examples: '1' (unique disordered site in group 1), '2' (unique disordered site in group 2), '-1' (symmetry-independent disordered site). [atom_site]

_atom_site_fract_x
_atom_site_fract_y
_atom_site_fract_z
(numb, su)

Atom-site coordinates as fractions of the _cell_length_ values. Appears in list containing _atom_site_label.

Related item: _atom_site_Cartn_ (alternate).

[atom_site]

atom site label

(char)

The atom site label is a unique identifier for a particular site in the crystal. This code is made up of a sequence of up to seven components, atom site label component 0 to * 6, which may be specified as separate data items. Component 0 usually matches one of the specified _atom_type_symbol codes. This is not mandatory if an atom site type symbol item is included in the atomsite list. The atom site type symbol always takes precedence over an atom site label in the identification of the atom type. The label components 1 to 6 are optional, and normally only components 0 and 1 are used. Note that components 0 and 1 are concatenated, while all other components, if specified, are separated by an underscore. Underscore separators are only used if higherorder components exist. If an intermediate component is not used, it may be omitted provided the underscore separators are inserted. For example, the label 'C233_ggg' is acceptable and represents the components C, 233, " and ggg. Different labels may have a different number of components.

```
_atom_site_label_component_0
_atom_site_label_component_1
_atom_site_label_component_2
_atom_site_label_component_3
_atom_site_label_component_4
_atom_site_label_component_5
_atom_site_label_component_6 (char
```

Component 0 is normally a code which matches identically with one of the _atom_type_symbol codes. If this is the case, then the rules governing the _atom_type_symbol code apply. If, however, the data item _atom_site_type_symbol code apply. If, however, the data item _atom_site_type_symbol is also specified in the atom-site list, component 0 need not match this symbol or adhere to any of the _atom_type_symbol rules. Component 1 is referred to as the 'atom number'. When component 0 is the atom-type code, it is used to number the sites with the same atom type. This component code must start with at least one digit which is not followed by a + or - sign (to distinguish it from the component 0 rules). Components 2 to 6 contain the identifier, residue, sequence, asymmetry identifier and alternate codes, respectively. These codes may be composed of any characters except an underscore.

Appears in list containing _atom_site_label.

[atom site]

atom site occupancy

(numb, su)

The fraction of the atom type present at this site. The sum of the occupancies of all the atom types at this site may not significantly exceed 1.0 unless it is a dummy site. The value must lie in the 99.97% Gaussian confidence interval $-3u \le x \le 1 + 3u$. The _enumeration_range of $0.0 \to 1.0$ is thus correctly interpreted as meaning $(0.0 - 3u) \le x \le (1.0 + 3u)$.

Appears in list containing _atom_site_label.

The permitted range is $0.0 \rightarrow 1.0$. Where no value is given, the assumed value is '1 . 0'.

[atom_site]

atom site refinement flags

This definition has been superseded and is retained here only for archival purposes. Use instead _atom_site_refinement_flags_posn, atom site refinement flags adp, atom site refinement flags occupancy.

A concatenated series of single-letter codes which indicate the refinement restraints or constraints applied to this site. This item should not be used. It has been replaced by atom site refinement flags posn, * adp and * occupancy. It is retained in this dictionary only to provide compatibility with legacy CIFs.

Appears in list containing _atom_site_label.

The data value must be one of the following:

- no refinement constraints S special-position constraint on site rigid-group refinement of site G
- R riding-atom site attached to non-riding atom
- D distance or angle restraint on site Т thermal displacement constraints IJ U_{iso} or U^{ij} restraint (rigid bond) D partial occupancy constraint

[atom site]

atom site refinement flags adp

(char)

A code which indicates the refinement restraints or constraints applied to the atomic displacement parameters of this site.

Appears in list containing _atom_site_label.

Related item: _atom_site_refinement_flags (alternate).

The data value must be one of the following:

- no constraints on atomic displacement parameters
- Т special-position constraints on atomic displacement parameters
- $U_{\rm iso}$ or U^{ij} restraint (rigid bond) TT
- TU both constraints applied

[atom site]

(char)

atom site refinement flags occupancy

A code which indicates that refinement restraints or constraints were applied to the occupancy of this site.

Appears in list containing _atom_site_label.

Related item: atom site refinement flags (alternate).

The data value must be one of the following:

- no constraints on site-occupancy parameters
- Р site-occupancy constraint

[atom site]

atom site refinement flags posn (char)

A code which indicates the refinement restraints or constraints applied to the positional coordinates of this site.

Appears in list containing atom site label.

Related item: _atom_site_refinement_flags (alternate).

The data value must be one of the following:

	no constraints on positional coordinates
D	distance or angle restraint on positional coordinates
G	rigid-group refinement of positional coordinates
R	riding-atom site attached to non-riding atom
S	special-position constraint on positional coordinates
DG	combination of the above constraints
DR	combination of the above constraints
DS	combination of the above constraints
GR	combination of the above constraints
GS	combination of the above constraints
RS	combination of the above constraints
DGR	combination of the above constraints
DGS	combination of the above constraints
DRS	combination of the above constraints
GRS	combination of the above constraints
DGRS	combination of the above constraints

[atom site]

atom site restraints

A description of restraints applied to specific parameters at this site during refinement. See also atom site refinement flags and refine 1s number restraints.

Appears in list containing _atom_site_label.

Example: 'restrained to planar ring'.

[atom site]

atom site symmetry multiplicity

(numb)

The multiplicity of a site due to the space-group symmetry as given in International Tables for Crystallography Vol. A (2002).

Appears in list containing _atom_site_label.

The permitted range is $1 \rightarrow 192$.

[atom site]

(char)

atom site thermal displace type

This definition has been superseded and is retained here only for archival purposes. Use instead atom site adp type.

A standard code used to describe the type of atomic displacement parameters used for the site.

Appears in list containing _atom_site_label.

The data value must be one of the following:

Uani anisotropic U^{ij} Uiso isotropic U Uovl $overall\ U$

Umpe multipole expansion U

anisotropic B^{ij} Bani Biso isotropic B Bovl

overall B

[atom site]

atom site type symbol

(char)

A code to identify the atom species (singular or plural) occupying this site. This code must match a corresponding atom type symbol. The specification of this code is optional if component 0 of the atom site label is used for this purpose. See _atom_type_symbol.

Appears in list containing _atom_site_label. Must match parent data name

atom type symbol. May match child data name(s):

_atom_site_aniso_type_symbol.

Examples: 'Cu', 'Cu2+', 'dummy', 'Fe3+Ni2+', 'S-', 'H*', 'H(SDS)'. [atom_site]

atom site U equiv geom mean

Equivalent isotropic atomic displacement parameter, $U_{\rm equiv}$, in ångströms squared, calculated as the geometric mean of the anisotropic atomic displacement parameters.

$$U_{\text{equiv}} = (U_i U_j U_k)^{1/3},$$

where U_n = the principal components of the orthogonalized U^{ij} .

Appears in list containing _atom_site_label.

The permitted range is $0.0 \rightarrow \infty$.

Related items:

atom site U iso or equiv (alternate), _atom_site_B_equiv_geom_mean (conversion).

[atom_site]

atom site U iso or equiv

(numb, su)

Isotropic atomic displacement parameter, or equivalent isotropic atomic displacement parameter, $U_{\rm equiv}$, in ångströms squared, calculated from anisotropic atomic displacement parameters.

$$U_{\text{equiv}} = (1/3) \sum_{i} \left[\sum_{j} (U^{ij} A_i A_j a_i^* a_j^*) \right],$$

where A = the real-space cell lengths and $a^* =$ the reciprocal-space cell lengths.

Reference: Fischer, R. X. & Tillmanns, E. (1988). Acta Cryst. C44, 775-776.

Appears in list containing _atom_site_label.

The permitted range is $0.0 \rightarrow \infty$.

_atom_site_U_equiv_geom_mean (alternate),

_atom_site_B_iso_or_equiv (conversion).

[atom_site]

atom site Wyckoff symbol

(char)

The Wyckoff symbol (letter) as listed in the space-group tables of International Tables for Crystallography Vol. A (2002).

Appears in list containing _atom_site_label.

[atom site]

(numb)

ATOM_SITES

Data items in the ATOM_SITES category record details about the crystallographic cell and cell transformations, which are common to all atom sites.

Example 1 – based on PDB entry 5HVP and laboratory records for the structure corresponding to PDB entry 5HVP.

Matrix elements used to transform fractional coordinates in the ATOM_SITE category to Cartesian coordinates. The axial alignments of this transformation are described in _atom_sites_Cartn_transform_axes. The 3 × 1 translation is defined in atom sites Cartn tran vector.

$$\begin{pmatrix} x' \\ y' \\ z' \end{pmatrix}_{\text{Cartesian}} = \begin{pmatrix} 11 & 12 & 13 \\ 21 & 22 & 23 \\ 31 & 32 & 33 \end{pmatrix} \begin{pmatrix} x \\ y \\ z \end{pmatrix}_{\text{fractional}} + \begin{pmatrix} 1 \\ 2 \\ 3 \end{pmatrix}.$$

[atom_sites]

(numb)

Elements of a 3×1 translation vector used in the transformation of fractional coordinates in the ATOM_SITE category to Cartesian coordinates. The axial alignments of this transformation are described in $_{\tt atom_sites_Cartn_transform_axes}$.

$$\begin{pmatrix} x' \\ y' \\ z' \end{pmatrix}_{\text{fractional}} = \begin{pmatrix} 11 & 12 & 13 \\ 21 & 22 & 23 \\ 31 & 32 & 33 \end{pmatrix} \begin{pmatrix} x \\ y \\ z \end{pmatrix}_{\text{Cartesian}} + \begin{pmatrix} 1 \\ 2 \\ 3 \end{pmatrix}.$$

[atom_sites]

atom sites Cartn transform axes (cl

A description of the relative alignment of the crystal cell axes to the Cartesian orthogonal axes as applied in the transformation matrix atom sites Cartn tran matrix.

Example: 'a parallel to x; b in the plane of y and z'.

[atom_sites]

Matrix elements used to transform Cartesian coordinates in the ATOM_SITE category to fractional coordinates. The axial alignments of this transformation are described in _atom_sites_Cartn_transform_axes. The 3 × 1 translation is defined in atom sites fract tran vector.

$$\begin{pmatrix} x' \\ y' \\ z' \end{pmatrix}_{\text{fractional}} = \begin{pmatrix} 11 & 12 & 13 \\ 21 & 22 & 23 \\ 31 & 32 & 33 \end{pmatrix} \begin{pmatrix} x \\ y \\ z \end{pmatrix}_{\text{Cartesian}} + \begin{pmatrix} 1 \\ 2 \\ 3 \end{pmatrix}.$$

[atom_sites]

Elements of a 3 × 1 translation vector used in the transformation of Cartesian coordinates in the ATOM_SITE category to fractional coordinates. The axial alignments of this transformation are described in _atom_sites_Cartn_transform_axes.

$$\begin{pmatrix} x' \\ y' \\ z' \end{pmatrix}_{\text{fractional}} = \begin{pmatrix} 11 & 12 & 13 \\ 21 & 22 & 23 \\ 31 & 32 & 33 \end{pmatrix} \begin{pmatrix} x \\ y \\ z \end{pmatrix}_{\text{Cartesian}} + \begin{pmatrix} 1 \\ 2 \\ 3 \end{pmatrix}.$$

[atom sites]

atom sites solution primary

(char)

Codes which identify the methods used to locate the initial atom sites. The *_primary code identifies how the first atom sites were determined; the *_secondary code identifies how the remaining non-hydrogen sites were located; and the *_hydrogens code identifies how the hydrogen sites were located.

Reference: Sheldrick, G. M., Hauptman, H. A., Weeks, C. M., Miller, R. and Usón, I. (2001). *Ab initio* phasing. In *International Tables for Crystallography*, Vol. F. *Crystallography of biological macromolecules*, edited by M. G. Rossmann and E. Arnold, ch. 16.1. Dordrecht: Kluwer Academic Publishers.

The data value must be one of the following:

difmap	difference Fourier map
vecmap	real-space vector search
heavy	heavy-atom method
direct	structure-invariant direct methods
geom	inferred from neighbouring sites
disper	anomalous-dispersion techniques
isomor	isomorphous structure methods
notdet	coordinates were not determined
dual	dual-space method (Sheldrick et al., 2001)
iterative	iterative algorithm, <i>e.g.</i> charge flipping [Oszlányi, G. and Süto, A. (2004). <i>Acta Cryst.</i> A 60 , 134-141]
other	a method not included elsewhere in this list

[atom_sites]

atom sites solution secondary

(che

Codes which identify the methods used to locate the initial atom sites. The *_primary code identifies how the first atom sites were determined; the *_secondary code identifies how the remaining non-hydrogen sites were located; and the *_hydrogens code identifies how the hydrogen sites were located.

Reference: Sheldrick, G. M., Hauptman, H. A., Weeks, C. M., Miller, R. and Usón, I. (2001). *Ab initio* phasing. In *International Tables for Crystallography*, Vol. F. *Crystallography of biological macromolecules*, edited by M. G. Rossmann and E. Arnold, ch. 16.1. Dordrecht: Kluwer Academic Publishers.

The data value must be one of the following:

difmap	difference Fourier map
vecmap	real-space vector search
heavy	heavy-atom method
direct	structure-invariant direct methods
geom	inferred from neighbouring sites
disper	anomalous-dispersion techniques
isomor	isomorphous structure methods
notdet	coordinates were not determined
dual	dual-space method (Sheldrick et al., 2001)
iterative	iterative algorithm, e.g. charge flipping [Oszlányi, C and Süto, A. (2004). Acta Cryst. A60, 134-141]
other	a method not included elsewhere in this list

[atom sites]

atom sites solution hydrogens (ch

Codes which identify the methods used to locate the initial atom sites. The *_primary code identifies how the first atom sites were determined; the *_secondary code identifies how the remaining non-hydrogen sites were located; and the *_hydrogens code identifies how the hydrogen sites were located.

Reference: Sheldrick, G. M., Hauptman, H. A., Weeks, C. M., Miller, R. and Usón, I. (2001). *Ab initio* phasing. In *International Tables for Crystallography*, Vol. F. *Crystallography of biological macromolecules*, edited by M. G. Rossmann and E. Arnold, ch. 16.1. Dordrecht: Kluwer Academic Publishers.

The data value must be one of the following:

difmap	difference Fourier map
vecmap	real-space vector search
heavy	heavy-atom method
direct	structure-invariant direct methods
geom	inferred from neighbouring sites
disper	anomalous-dispersion techniques
isomor	isomorphous structure methods
mixed	a mixture of "geom" and "difmap"
notdet	coordinates were not determined
dual	dual-space method (Sheldrick et al., 2001)
iterative	iterative algorithm, <i>e.g.</i> charge flipping [Oszlányi, G. and Süto, A. (2004). <i>Acta Cryst.</i> A 60 , 134-141]
other	a method not included elsewhere in this list

[atom_sites]

atom sites special details

(char

Additional information about the atomic coordinates not coded elsewhere in the CIF.

[atom_sites]

ATOM_TYPE

Data items in the ATOM_TYPE category record details about properties of the atoms that occupy the atom sites, such as the atomic scattering factors.

```
Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].
```

```
loop_
atom type symbol
atom type oxidation number
atom type number in cell
_atom_type_scat_dispersion_real
_atom_type_scat_dispersion_imag
_atom_type_scat_source
 C 0 72 .017 .009 International_Tables_Vol_IV_Table_2.2B
 H 0 100 0
                0
                      International Tables Vol IV Table 2.2B
 0 0 12 .047
               .032
                     International Tables Vol IV Table 2.2B
          .029
                     International Tables Vol IV Table 2.2B
 N 0 4
                .018
```

atom type analytical mass %

(numb)

Mass percentage of this atom type derived from chemical analysis.

Appears in list containing $_{\tt atom_type_symbol}$. The permitted range is $0.0 \rightarrow 100.0$.

[atom_type]

atom type description

(char)

A description of the atom(s) designated by this atom type. In most cases, this will be the element name and oxidation state of a single atom species. For disordered or nonstoichiometric structures it will describe a combination of atom species.

```
Appears in list containing _atom_type_symbol.

Examples: 'deuterium', '0.34Fe+0.66Ni'.
```

[atom_type]

atom type number in cell

(numb)

Total number of atoms of this atom type in the unit cell.

Appears in list containing _atom_type_symbol.

Appears in list containing **_atom_type_symbo**The permitted range is $0 \to \infty$.

```
The permitted range is 0 \to \infty. [atom_type]
```

${\tt _atom_type_oxidation_number}$

(numb)

(numb)

Formal oxidation state of this atom type in the structure.

Appears in list containing _atom_type_symbol.

The permitted range is $-8 \rightarrow 8$. Where no value is given, the assumed value is '0'.

[atom_type]

_atom_type_radius_bond

atom type radius contact

The effective intra- and intermolecular bonding radii in ångströms of this atom type.

Appears in list containing _atom_type_symbol.

The permitted range is $0.0 \rightarrow 5.0$. [atom_type]

```
_atom_type_scat_Cromer_Mann_a1
_atom_type_scat_Cromer_Mann_a2
_atom_type_scat_Cromer_Mann_a3
_atom_type_scat_Cromer_Mann_a4
_atom_type_scat_Cromer_Mann_b1
_atom_type_scat_Cromer_Mann_b2
_atom_type_scat_Cromer_Mann_b3
_atom_type_scat_Cromer_Mann_b4
_atom_type_scat_Cromer_Mann_c (numb)
```

The Cromer–Mann scattering-factor coefficients used to calculate the scattering factors for this atom type.

References: *International Tables for X-ray Crystallography* (1974). Vol. IV, Table 2.2B; *International Tables for Crystallography* (2004). Vol. C, Tables 6.1.1.4 and 6.1.1.5.

Appears in list containing _atom_type_symbol. [atom_type]

_atom_type_scat_dispersion_imag atom type scat dispersion real

(numb)

The imaginary and real components of the anomalous-dispersion scattering factor, f'' and f', in electrons for this atom type and the radiation given in $_{\tt diffrn_radiation_wavelength}$.

Appears in list containing _atom_type_symbol. Where no value is given, the assumed value is '0.0'. [atom_type]

atom type scat dispersion source

(char)

Reference to source of real and imaginary dispersion corrections for scattering factors used for this atom type.

Appears in list containing _atom_type_symbol.

Example: 'International Tables Vol. IV Table 2.3.1'. [atom_type]

_atom_type_scat_length_neutron

(numb)

The bound coherent scattering length in femtometres for the atom type at the isotopic composition used for the diffraction experiment.

Appears in list containing _atom_type_symbol. Where no value is given, the assumed value is '0.0'. [atom_type]

atom type scat source

(char)

Reference to source of scattering factors or scattering lengths used for this atom type.

Appears in list containing _atom_type_symbol.

Example: 'International Tables Vol. IV Table 2.4.6B'. [atom_type]

atom type scat versus stol list

(char)

A table of scattering factors as a function of $(\sin \theta)/\lambda$. This table should be well commented to indicate the items present. Regularly formatted lists are strongly recommended.

Appears in list containing _atom_type_symbol.

[atom_type]

atom type symbol

(char)

The code used to identify the atom species (singular or plural) representing this atom type. Normally this code is the element symbol. The code may be composed of any character except an underscore with the additional proviso that digits designate an oxidation state and must be followed by a + or - character.

Appears in list as essential element of loop structure. May match child data name(s): _atom_site_type_symbol.

Examples: 'C', 'Cu2+', 'H (SDS)', 'dummy', 'FeNi'. [atom_type]

AUDIT

Data items in the AUDIT category record details about the creation and subsequent updating of the data block.

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

```
_audit_block_code TOZ_1991-03-20

_audit_creation_date 1991-03-20

_audit_creation_method from_xtal_archive_file_using_CIFIO
_audit_update_record
; 1991-04-09 text and data added by Tony Willis.
1991-04-15 rec'd by co-editor as manuscript HL0007.
1991-04-17 adjustments based on first referee report.
1991-04-18 adjustments based on second referee report.
```

_audit_block_code

(char)

A code intended to identify uniquely the current data block.

Example: 'TOZ_1991-03-20'. [audit]

audit creation date

(char)

The date that the data block was created. The date format is *yyyy-mm-dd*.

Example: '1990-07-12'. [audit]

audit creation method

(char)

A description of how data were entered into the data block.

Example: 'spawned by the program QBEE'.

. [audit]

_audit_update record

(char)

A record of any changes to the data block. The update format is a date (*yyyy-mm-dd*) followed by a description of the changes. The latest update entry is added to the bottom of this record.

Example: '1990-07-15 Updated by the Co-editor'. [audit]

AUDIT_AUTHOR

Data items in the AUDIT_AUTHOR category record details about the author(s) of the data block.

Example 1 – based on PDB entry 5HVP and laboratory records for the structure corresponding to PDB entry 5HVP.

```
_audit_author_name
_audit_author_address
   'Fitzgerald, Paula M. D.'
  Department of Biophysical Chemistry
  Merck Research Laboratories
  PO Box 2000, Rv80M203
  Rahwav
  New Jersey 07065
  USA
    'Van Middlesworth, J. F.'
  Department of Biophysical Chemistry
  Merck Research Laboratories
  PO Box 2000, Ry80M203
  Rahway
  New Jersey 07065
  TISA
```

audit author address

(char)

The address of an author of this data block. If there are multiple authors, _audit_author_address is looped with _audit_author_name.

Appears in list containing <code>_audit_author_name</code>.

```
Example:
; Department
Institute
Street
City and postcode
COUNTRY
```

[audit_author]

audit author name

(char)

The name of an author of this data block. If there are multiple authors, _audit_author_name is looped with _audit_author_address. The family name(s), followed by a comma and including any dynastic components, precedes the first name(s) or initial(s).

Appears in list as essential element of loop structure.

```
Examples: 'Bleary, Percival R.', 'O'Neil, F.K.', 'Van den Bossche, G.', 'Yang, D.-L.', 'Simonov, Yu.A.', 'M\"uller, H.A.', 'Ross II, C.R.'.
```

[audit_author]

AUDIT CONFORM

Data items in the AUDIT_CONFORM category describe the dictionary versions against which the data names appearing in the current data block are conformant.

Example 1 – any file conforming to the current CIF core dictionary.

```
audit_conform_dict_name cif_core.dic
audit_conform_dict_version 2.4
audit_conform_dict_location
ftp://ftp.iucr.org/pub/cif_core.2.4.dic
```

audit conform dict location

(cho

A file name or uniform resource locator (URL) for the dictionary to which the current data block conforms.

May appear in list containing _audit_conform_dict_name. [audit_conform]

audit conform dict name

(char)

The string identifying the highest-level dictionary defining data names used in this file.

May appear in list as essential element of loop structure. [audit_conform]

audit conform dict version

(char)

The version number of the dictionary to which the current data block conforms.

May appear in list containing _audit_conform_dict_name. [audit_conform]

AUDIT_CONTACT_AUTHOR

Data items in the AUDIT_CONTACT_AUTHOR category record details about the name and address of the author to be contacted concerning the contents of this data block.

Example 1 – based on PDB entry 5HVP and laboratory records for the structure corresponding to PDB entry 5HVP.

```
loop
audit contact author name
audit contact author address
audit contact author email
audit contact author fax
_audit_contact_author_phone
    'Fitzgerald, Paula M. D.'
  Department of Biophysical Chemistry
  Merck Research Laboratories
  PO Box 2000, Ry80M203
  Rahwav
   New Jersey 07065
   USA
    'paula fitzgerald@merck.com
    1(908)5945510
    1(908)5945510
```

audit contact author address

(che

(char)

The mailing address of the author of the data block to whom correspondence should be addressed.

```
Example:
; Department
Institute
```

Street

City and postcode

COUNTRY

[audit_contact_author]

audit_contact_author_email

The electronic mail address of the author of the data block to whom correspondence should be addressed, in a form recognizable to international networks. The format of e-mail addresses is given in Section 3.4, *Address Specification*, of *Internet Message Format*, RFC 2822, P. Resnick (Editor), Network Standards Group, April 2001.

Examples: 'name@host.domain.country', 'bm@iucr.org'.

[audit contact author]

audit contact author fax (char)

The facsimile telephone number of the author of the data block to whom correspondence should be addressed. The recommended style starts with the international dialing prefix, followed by the area code in parentheses, followed by the local number with no spaces.

Examples: '12 (34) 9477334', '12 () 349477334'. [audit_contact_author]

audit contact author name

(char)

The name of the author of the data block to whom correspondence should be addressed. The family name(s), followed by a comma and including any dynastic components, precedes the first name(s) or initial(s).

```
Examples: 'Bleary, Percival R.', 'O'Neil, F.K.', 'Van den Bossche, G.', 'Yang, D.-L.', 'Simonov, Yu.A.', 'M\"uller, H.A.', 'Ross II, C.R.'.

[audit contact author]
```

audit contact author phone

(char)

The telephone number of the author of the data block to whom correspondence should be addressed. The recommended style starts with the international dialing prefix, followed by the area code in parentheses, followed by the local number and any extension number prefixed by 'x', with no spaces.

```
Examples: '12 (34) 9477330', '12 () 349477330', '12 (34) 9477330x5543'.
```

[audit contact author]

AUDIT_LINK

Data items in the AUDIT_LINK category record details about the relationships between data blocks in the current CIF.

Example 1 – multiple structure paper, as illustrated in A Guide to CIF for Authors (1995). IUCr: Chester.

```
loop_
_audit_link_block_code
_audit_link_block_description
_ 'discursive text of paper with two structures'
_morA_(1) 'structure 1 of 2'
_morA_(2) 'structure 2 of 2'
```

Example 2 – example file for the one-dimensional incommensurately modulated structure of K_2SeO_4 .

_audit_link_block_code

(char)

The value of _audit_block_code associated with a data block in the current file related to the current data block. The special value '.' may be used to refer to the current data block for completeness. Appears in list as essential element of loop structure. [audit_link]

${\tt audit_link_block_description}$

(char)

A textual description of the relationship of the referenced data block to the current one.

Appears in list containing _audit_link_block_code. [audit_link]

CELL

Data items in the CELL category record details about the crystallographic cell parameters and their measurement.

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

```
cell_length_a
                                    5.959(1)
cell length b
                                    14.956(1)
cell length c
                                    19.737(3)
_cell_angle_alpha
                                    90
_cell_angle_beta
                                    90
_cell_angle_gamma
                                    90
                                    1759.0(3)
cell volume
                                    293
cell measurement temperature
cell measurement reflns used
                                    25
cell measurement theta min
                                    25
_cell_measurement_theta_max
                                    31
```

cell angle alpha _cell_angle_beta cell_angle gamma

(numb, su)

Unit-cell angles of the reported structure in degrees. The values of $_{\tt refln_index_h}$, $*_{\tt k}$, $*_{\tt l}$ must correspond to the cell defined by these values and _cell_length_a, *_b and *_c. The values of _diffrn_refln_index_h, *_k, *_1 may not correspond to these values if a cell transformation took place following the measurement of the diffraction intensities. See also diffrn reflns transf matrix .

The permitted range is $0.0 \rightarrow 180.0$. Where no value is given, the assumed value is '90.0'. [cell]

cell formula units Z

The number of the formula units in the unit cell as specified by _chemical_formula_structural, _chemical_formula_moiety Or chemical formula sum.

The permitted range is $1 \to \infty$. [cell]

_cell length a _cell_length_b _cell_length_c

(numb, su)

Unit-cell lengths in angströms corresponding to the structure reported. The values of refln index h, * k, * 1 must correspond to the cell defined by these values and cell angle values. The values of diffrn refln index h, * k, * 1 may not correspond to these values if a cell transformation took place following the measurement of the diffraction intensities. See also diffrn reflns transf matrix .

The permitted range is $0.0 \rightarrow \infty$. [cell]

cell measurement pressure

(numb, su)

The pressure in kilopascals at which the unit-cell parameters were measured (not the pressure at which the sample was synthesized).

The permitted range is $0.0 \to \infty$. [cell]

cell measurement radiation

Description of the radiation used to measure the unit-cell data. See also cell measurement wavelength.

Examples: 'neutron', 'Cu K\a', 'synchrotron'. [cell]

cell measurement reflns used

The total number of reflections used to determine the unit cell. These reflections may be specified as cell measurement refln data items.

[cell]

cell measurement temperature

(numb, su)

The temperature in kelvins at which the unit-cell parameters were measured (not the temperature of synthesis).

The permitted range is $0.0 \rightarrow \infty$. [cell]

cell measurement theta max

cell measurement theta min (numb)

The maximum and minimum θ angles of reflections used to measure the unit cell in degrees.

The permitted range is $0.0 \rightarrow 90.0$. [cell]

cell measurement wavelength

The wavelength in angströms of the radiation used to measure the unit cell. If this is not specified, the wavelength is assumed to be the same as that given in diffrn radiation wavelength.

The permitted range is $0.0 \rightarrow \infty$. [cell]

```
cell reciprocal angle alpha
_cell_reciprocal_angle_beta
cell reciprocal angle gamma
```

(numb, su)

The angles defining the reciprocal cell in degrees. These are related to those in the real cell by

```
\cos \alpha^* = (\cos \beta \cos \gamma - \cos \alpha)/(\sin \beta \sin \gamma),
\cos \beta^* = (\cos \gamma \cos \alpha - \cos \beta) / (\sin \gamma \sin \alpha),
\cos \gamma^* = (\cos \alpha \cos \beta - \cos \gamma)/(\sin \alpha \sin \beta).
```

Reference: Buerger, M. J. (1942). X-ray Crystallography, p. 360. New York: John Wiley & Sons Inc.

The permitted range is $0.0 \rightarrow 180.0$. Where no value is given, the assumed value is '90.0'.

```
cell reciprocal length a
cell reciprocal length b
cell reciprocal length c
                                          (numb, su)
```

The reciprocal-cell lengths in inverse angströms. These are related to the real cell by

$$a^* = bc \sin \alpha/V,$$

 $b^* = ca \sin \beta/V,$
 $c^* = ab \sin \gamma/V,$

where *V* is the cell volume.

Reference: Buerger, M. J. (1942). X-ray Crystallography, p. 360. New York: John Wiley & Sons Inc.

The permitted range is $0.0 \rightarrow \infty$. [cell]

cell special details

(char)

(numb, su)

A description of special aspects of the cell choice, noting possible alternative settings.

Examples: 'pseudo-orthorhombic',

'standard setting from 45 deg rotation around c'. [cell]

cell volume Cell volume V in ångströms cubed.

 $V = abc(1 - \cos^2 \alpha - \cos^2 \beta - \cos^2 \gamma + 2\cos \alpha \cos \beta \cos \gamma)^{1/2},$

where $a = _cell_length_a$, $b = _cell_length_b$, $c = _cell_length_b$ length_c, α = _cell_angle_alpha, β = _cell_angle_beta and $\gamma =$ cell angle gamma.

The permitted range is $0.0 \rightarrow \infty$. [cell]

CELL_MEASUREMENT_REFLN

Data items in the CELL MEASUREMENT REFLN category record details about the reflections used in the determination of the crystallographic cell parameters. The _cell_measurement_refln_ data items would in general be used only for diffractometer mea-

Example 1 – extracted from the CAD-4 listing for $Rb_2S_2O_6$ at room temperature (unpublished).

```
loop_
{\tt \_cell\_measurement\_refln\_index\_h}
 _cell_measurement_refln_index_k
 _cell_measurement_refln_index_l
 cell measurement refln theta
    0
               2
         3
                           9.45
    3
          0
               2
                           9.46
   - 3
          4
               1
                           8.93
   - 2
         1
              -2
                           7.53
```

0

0

- 5 11.14 - - - data truncated for brevity - - - -

23.77

23.78

10

0 10

0

cell measurement refln index h _cell_measurement_refln_index_k

cell measurement refln index 1

Miller indices of a reflection used for measurement of the unit cell. Appears in list as essential element of loop structure. [cell measurement refln]

cell measurement refln theta

(numb)

 θ angle in degrees for the reflection used for measurement of the unit cell with the indices cell measurement refln index .

Appears in list containing _cell_measurement_refln_index_.

The permitted range is $0.0 \rightarrow 90.0$.

[cell_measurement_refln]

CHEMICAL

Data items in the CHEMICAL category record details about the composition and chemical properties of the compound. The formula data items must agree with those that specify the density, unit-cell and Z values.

Example 1 – based on data set 9597gaus of Alyea, Ferguson & Kannan [Acta Cryst. (1996), C52, 765-767].

chemical name systematic

 $\verb|trans-bis|(tricyclohexylphosphine)| tetracarbonylmolybdenum(0)|$

chemical absolute configuration

(char)

Necessary conditions for the assignment of chemical absolute configuration are given by H. D. Flack and G. Bernardinelli (1999, 2000).

References: Flack, H. D. & Bernardinelli, G. (1999). Acta Cryst. A55, 908-915; Flack, H. D. & Bernardinelli, G. (2000). J. Appl. Cryst. 33, 1143-1148.

The data value must be one of the following:

Absolute configuration established by the structure determination of a compound containing a chiral reference molecule of known absolute configuration.

Absolute configuration established by anomalous-dispersion effects ad in diffraction measurements on the crystal.

Absolute configuration established by the structure determination of rmad a compound containing a chiral reference molecule of known absolute configuration and confirmed by anomalous-dispersion effects in diffraction measurements on the crystal.

Absolute configuration has not been established by anomaloussyn dispersion effects in diffraction measurements on the crystal. The enantiomer has been assigned by reference to an unchanging chiral centre in the synthetic procedure.

Absolute configuration is unknown, there being no firm chemical eviunk dence for its assignment to hand and it having not been established by anomalous-dispersion effects in diffraction measurements on the crystal. An arbitrary choice of enantiomer has been made.

Inapplicable.

[chemical]

chemical compound source

Description of the source of the compound under study, or of the parent molecule if a simple derivative is studied. This includes the place of discovery for minerals or the actual source of a natural product.

Examples: 'From Norilsk (USSR)'.

'Extracted from the bark of Cinchona Naturalis'. [chemical]

chemical enantioexcess bulk (numb, su)

The enantioexcess of the bulk material from which the crystals were grown. A value of 0.0 indicates the racemate. A value of 1.0 indicates that the compound is enantiomerically pure. Enantioexcess is defined in the IUPAC Recommendations (Moss et al., 1996). The composition of the crystal and bulk must be the same.

Reference: Moss G. P. et al. (1996). Basic Terminology of Stereochemistry. Pure Appl. Chem. 68, 2193–2222. http://www.chem.qmul.ac.uk/iupac/stereo/index.html

The permitted range is $0.0 \rightarrow 1.0$. [chemical]

chemical enantioexcess bulk technique

The experimental technique used to determine the enantioexcess of the bulk compound.

The data value must be one of the following:

Enantioexcess determined by measurement of the specific rotation of the optical activity of the bulk compound in solution.

CD Enantioexcess determined by measurement of the visible/near UV circular dichroism spectrum of the bulk compound in solution

EC Enantioexcess determined by enantioselective chromatography of the bulk compound in solution.

other Enantioexcess determined by a technique not included elsewhere in this list.

[chemical]

chemical enantioexcess crystal

(numb, su)

The enantioexcess of the crystal used for the diffraction study. A value of 0.0 indicates the racemate. A value of 1.0 indicates that the crystal is enantiomerically pure. Enantioexcess is defined in the IUPAC Recommendations (Moss et al., 1996).

Reference: Moss G. P. et al. (1996). Basic Terminology of Stereochemistry. Pure Appl. Chem. 68, 2193-2222. http://www.chem.qmul.ac.uk/iupac/stereo/index.html

The permitted range is $0.0 \rightarrow 1.0$.

[chemical]

chemical enantioexcess crystal technique (char) The experimental technique used to determine the enantioexcess of the crystal.

The data value must be one of the following:

CD Enantioexcess determined by measurement of the visible/near UV circular dichroism spectrum of the crystal taken into solution.

Enantioexcess determined by enantioselective chromatography of the crystal taken into solution.

Enantioexcess determined by a technique not included elsewhere in other

this list.

[chemical]

chemical identifier inchi

(char)

The IUPAC International Chemical Identifier (InChI) is a textual identifier for chemical substances, designed to provide a standard and human-readable way to encode molecular information and to facilitate the search for such information in databases and on the

Reference: McNaught, A. (2006). Chem. Int. (IUPAC), 28 (6), 12–14. http://www.iupac.org/inchi/

Example: 'InChI=1/C10H8/c1-2-6-10-8-4-3-7-9 (10) 5-1/h1-8H'

[chemical]

chemical identifier inchi key

(char)

The InChIKey is a compact hashed version of the full InChI (IUPAC International Chemical Identifier), designed to allow for easy web searches of chemical compounds. See http://www.iupac.org/inchi/

Example: 'InChIKey=OROGSEYTTFOCAN-DNJOTXNNBG' (codeine). [chemical]

chemical identifier inchi version

The version number of the InChI standard to which the associated chemical identifier string applies.

Example: '1.03'. [chemical]

chemical melting point

(numb, su)

The temperature in kelvins at which the crystalline solid changes to a liquid.

The permitted range is $0.0 \rightarrow \infty$.

[chemical]

chemical melting_point_gt chemical melting point lt

A temperature in kelvins below which (* 1t) or above which (* gt) the melting point (the temperature at which the crystalline solid changes to a liquid) lies. These items allow a range of temperatures to be given. _chemical_melting_point should always be used in preference to these items whenever possible.

The permitted range is $0.0 \rightarrow \infty$.

Related item: _chemical_melting_point (alternate). [chemical]

chemical name common

(cha

Trivial name by which the compound is commonly known.

Example: '1-bromoestradiol'.

[chemical]

chemical name mineral

(char)

Mineral name accepted by the International Mineralogical Association. Use only for natural minerals. See also _chemical_compound source.

Example: 'chalcopyrite'.

[chemical]

chemical name structure type

(char)

Commonly used structure-type name. Usually only applied to minerals or inorganic compounds.

Examples: 'perovskite', 'sphalerite', 'A15'.

[chemical]

chemical name systematic

(char)

IUPAC or *Chemical Abstracts* full name of the compound.

Example: '1-bromoestra-1,3,5(10)-triene-3,17\b-diol'. [chemical]

chemical optical rotation

(char)

(char)

The optical rotation in solution of the compound is specified in the following format:

 $[\alpha]_{\text{WAVE}}^{\text{TEMP}} = \text{SORT} \quad (c = \text{CONC}, \text{SOLV}),$

where TEMP is the temperature of the measurement in degrees Celsius, WAVE is an indication of the wavelength of the light used for the measurement, CONC is the concentration of the solution given as the mass of the substance in g per 100 ml of solution, SORT is the signed value (preceded by a + or a - sign) of $100\alpha/(lc)$, where α is the signed optical rotation in degrees measured in a cell of length l in dm and c is the value of CONC as defined above, and SOLV is the chemical formula of the solvent.

Example: $([a]^25^-D^- = +108 (c = 3.42, CHCl^3)'$. [chemical]

chemical properties biological

A free-text description of the biological properties of the material. Examples:

```
; diverse biological activities including use as a
  laxative and strong antibacterial activity against
S. aureus and weak activity against
  cyclooxygenase-1 (COX-1)
;
; antibiotic activity against Bacillus subtilis
  (ATCC 6051) but no significant activity against
  Candida albicans (ATCC 14053), Aspergillus flavus
  (NRRL 6541) and Fusarium verticillioides (NRRL
  25457)
;
; weakly potent lipoxygenase nonredox inhibitor
;
; no influenza A virus sialidase inhibitory and
  plaque reduction activities
;
; low toxicity against Drosophila melanogaster
  [chemical]
```

chemical properties physical

(char)

A free-text description of the physical properties of the material.

Examples: 'air-sensitive', 'moisture-sensitive', 'hygroscopic', 'deliquescent', 'oxygen-sensitive', 'photo-sensitive', 'pyrophoric', 'semiconductor', 'ferromagnetic at low temperature', 'paramagnetic and thermochromic'. [chemical]

_chemical_temperature_decomposition

(numb, su)

The temperature in kelvins at which the solid decomposes.

The permitted range is $0.0 \to \infty$.

Example: '350'. [chemical]

```
_chemical_temperature_decomposition_gt
```

chemical temperature decomposition lt

A temperature in kelvins below which (*_lt) or above which (*_gt) the solid is known to decompose. These items allow a range of temperatures to be given. _chemical_temperature_decomposition should always be used in preference to these items whenever possible.

The permitted range is $0.0 \rightarrow \infty$.

Related item: _chemical_temperature_decomposition (alternate).

Example: '350'. [chemical]

chemical temperature sublimation

(numb, su)

The temperature in kelvins at which the solid sublimes.

The permitted range is $0.0 \rightarrow \infty$.

Example: '350'.

[chemical]

_chemical_temperature_sublimation_gt chemical temperature sublimation lt

(numb)

A temperature in kelvins below which (*_1t) or above which (*_gt) the solid is known to sublime. These items allow a range of temperatures to be given. _chemical_temperature_sublimation should always be used in preference to these items whenever possible

The permitted range is $0.0 \to \infty$.

Related item: _chemical_temperature_sublimation (alternate).

Example: '350'. [chemical]

CHEMICAL_CONN_ATOM

Data items in the _chemical_conn_atom_ and _chemical_conn_bond_ categories record details about the two-dimensional (2D) chemical structure of the molecular species. They allow a 2D chemical diagram to be reconstructed for use in a publication or in a database search for structural and substructural relationships. The _chemical_conn_atom_ data items provide information about the chemical properties of the atoms in the structure. In cases where crystallographic and molecular symmetry elements coincide, they must also contain symmetry-generated atoms, so that the _chemical_conn_atom_ and _chemical_conn_bond_ data items will always describe a complete chemical entity.

Example 1 – based on data set DPTD of Yamin, Suwandi, Fun, Sivakumar & bin Shawkataly [Acta Cryst. (1996), C52, 951–953].

```
loop
chemical_conn_atom_number
chemical_conn_atom_type_symbol
_chemical_conn_atom_display_x
chemical conn atom display y
chemical conn atom NCA
chemical conn atom NH
   1
        S
              .39
                   .81
                         1
                              0
   2
        S
              .39
                   .96
                         2
                              n
        N
                   .88
    3
              .14
        C
              .33
                   .88
              .11
                   .96
    6
        C
              .03
                   .96
        C
              .03
                   .80
        C
    8
              .11
                   .80
                         2
    9
        S
              . 54
                   . 81
                         1
                   .96
    10
        s
              .54
                         2
                              0
   11
        N
              .80
                   .88
                         3
    12
        C
              .60
                   .88
    13
        C
              .84
                   .96
    14
        C
              .91
                         2
                   .96
    15
        C
              .91
                         2
                              2
                   .80
    16
        C
              . 84
                   . 80
                         2
```

_chemical_conn_atom_charge

(numb)

The net integer charge assigned to this atom. This is the formal charge assignment normally found in chemical diagrams.

Appears in list containing _chemical_conn_atom_type_symbol.

The permitted range is $-6 \rightarrow 6$. Where no value is given, the assumed value is '0'.

Examples: '1' (for an ammonium nitrogen), '-1' (for a chloride ion).

[chemical_conn_atom]

```
_chemical_conn_atom_display_x
chemical conn atom display y
```

(numh

The 2D Cartesian coordinates (x, y) of the position of this atom in a recognizable chemical diagram. The coordinate origin is at the lower left corner, the x axis is horizontal and the y axis is vertical. The coordinates must lie in the range 0.0 to 1.0. These coordinates can be obtained from projections of a suitable uncluttered view of the molecular structure.

Appears in list containing $_{\tt chemical_conn_atom_type_symbol}$. The permitted range is $0.0 \to 1.0$. [chemical conn atom]

chemical conn atom NCA

(numh

The number of connected atoms excluding terminal hydrogen atoms.

Appears in list containing _chemical_conn_atom_type_symbol.

The permitted range is $0 \to \infty$. [chemical_conn_atom]

chemical conn atom NH

(numb)

The total number of hydrogen atoms attached to this atom, regardless of whether they are included in the refinement or the <code>_atom_site_</code> list. This number will be the same as <code>_atom_site_attached_hydrogens</code> only if none of the hydrogen atoms appear in the <code>_atom_site_</code> list.

Appears in list containing _chemical_conn_atom_type_symbol.

The permitted range is $0 \to \infty$. [chemical_conn_atom]

chemical conn atom number

(numb

(char)

The chemical sequence number to be associated with this atom. Appears in list containing _chemical_conn_atom_type_symbol. May match child data name(s): _atom_site_chemical_conn_number,

_chemical_conn_bond_atom_1, _chemical_conn_bond_atom_2.

The permitted range is $1 \to \infty$. [chemical_conn_atom]

chemical conn atom type symbol

A code identifying the atom type. This code must match an _atom_type_symbol code in the _atom_type_ list or be a recognizable element symbol.

Appears in list as essential element of loop structure.

[chemical_conn_atom]

CHEMICAL_CONN_BOND

Data items in the _chemical_conn_atom_ and _chemical_conn_bond_ categories record details about the two-dimensional (2D) chemical structure of the molecular species. They allow a 2D chemical diagram to be reconstructed for use in a publication or in a database search for structural and substructural relationships. The _chemical_conn_bond_ data items specify the connections between the atoms in the _chemical_conn_atom_ list and the nature of the chemical bond between these atoms.

Example 1 – based on data set DPTD of Yamin, Suwandi, Fun, Sivakumar & bin Shawkataly [Acta Cryst. (1996), C52, 951–953].

```
loop
```

```
_chemical_conn_bond_atom_1
_chemical_conn_bond_atom_2
chemical conn bond type
                doub
                                 3
                                        sing
   4
                sina
                                 3
                                        sing
   6
         5
                sina
                                 6
                                        sing
                sing
                                        sing
   8
         7
                          8
                                 3
   10
         2
                          12
                                 9
                                        doub
                sing
   12
         11
                sing
                          12
                                 10
                                        sing
   13
         11
                sing
                                 13
                                        sing
   15
         14
                sing
                          16
                                 15
                                        sing
   16
         11
                          17
                sina
                                 5
                                        sing
                sing
   18
         5
                          19
                                 6
                                        sing
   20
         6
                sing
                          21
                                 7
                                        sing
   22
         7
                                 8
                sing
                          23
                                        sing
   24
         8
                sing
                          25
                                 13
                                        sing
   26
         13
                sing
                                 14
                                        sing
   28
         14
                sing
                          29
                                 15
                                        sing
   30
         15
                          31
                                 16
                sing
                                        sing
   32
         16
                sing
```

```
_chemical_conn_bond_atom_1
chemical conn bond atom 2
```

(numb)

Atom numbers which must match with chemical sequence numbers specified as _chemical_conn_atom_number values. These link the bond connection to the chemical numbering and atom sites.

Appears in list. Must match parent data name $_chemical_conn_atom_number$. The permitted range is $1 \to \infty$. [chemical conn bond]

chemical conn bond type

(char)

The chemical bond type associated with the connection between the two sites chemical conn bond atom 1 and * 2.

Appears in list containing _chemical_conn_bond_atom_.

The data value must be one of the following:

sing single bond
doub double bond
trip triple bond
quad quadruple bond
arom aromatic bond
poly polymeric bond
delo delocalized double bond
pi π bond

Where no value is given, the assumed value is 'sing'.

[chemical_conn_bond]

CHEMICAL_FORMULA

chemical_formula_ items specify the composition and chemical properties of the compound. The formula data items must agree with those that specify the density, unit-cell and Z values. The following rules apply to the construction of the data items chemical formula analytical, * structural and * sum. For the data item * moiety, the formula construction is broken up into residues or moieties, i.e. groups of atoms that form a molecular unit or molecular ion. The rules given below apply within each moiety but different requirements apply to the way that moieties are connected (see chemical formula moiety). (1) Only recognized element symbols may be used. (2) Each element symbol is followed by a 'count' number. A count of '1' may be omitted. (3) A space or parenthesis must separate each cluster of (element symbol + count). (4) Where a group of elements is enclosed in parentheses, the multiplier for the group must follow the closing parenthesis. That is, all element and group multipliers are assumed to be printed as subscripted numbers. (An exception to this rule exists for * moiety formulae where pre- and post-multipliers are permitted for molecular units.) (5) Unless the elements are ordered in a manner that corresponds to their chemical structure, as in chemical formula structural, the order of the elements within any group or moiety depends on whether carbon is present or not. If carbon is present, the order should be: C, then H, then the other elements in alphabetical order of their symbol. If carbon is not present, the elements are listed purely in alphabetical order of their symbol. This is the 'Hill' system used by Chemical Abstracts. This ordering is used in chemical formula moiety and chemical formula sum.

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

Example 2 – based on data set 9597gaus of Alyea, Ferguson & Kannan [Acta Cryst. (1996), C52, 765–767].

_chemical_formula_iupac '[Mo (C 0)4 (C18 H33 P)2]'
_chemical_formula_moiety 'C40 H66 Mo O4 P2'
_chemical_formula_structural '((C 0)4 (P (C6 H11)3)2)Mo'
_chemical_formula_sum 'C40 H66 Mo O4 P2'
_chemical_formula_weight '768.81

chemical formula analytical

(cho

Formula determined by standard chemical analysis including trace elements. See the CHEMICAL_FORMULA category description for rules for writing chemical formulae. Parentheses are used only for standard uncertainties (e.s.d.'s).

Example: 'Fe2.45(2) Ni1.60(3) S4'.

[chemical formula]

chemical formula iupac

(char)

Formula expressed in conformance with IUPAC rules for inorganic and metal-organic compounds where these conflict with the rules for any other _chemical_formula_entries. Typically used for formatting a formula in accordance with journal rules. This should appear in the data block in addition to the most appropriate of the other chemical formula data names.

Reference: IUPAC (1990). Nomenclature of Inorganic Chemistry. Oxford: Blackwell Scientific Publications.

Example: '[Co Re (C12 H22 P)2 (C O)6].0.5C H3 O H'.

[chemical_formula]

chemical formula moiety

(char)

Formula with each discrete bonded residue or ion shown as a separate moiety. See the CHEMICAL_FORMULA category description for rules for writing chemical formulae. In addition to the general formulae requirements, the following rules apply: (1) Moieties are separated by commas ','. (2) The order of elements within a moiety follows general rule (5) in the CHEMICAL_FORMULA category description. (3) Parentheses are not used within moieties but may surround a moiety. Parentheses may not be nested. (4) Charges should be placed at the end of the moiety. The charge '+' or '-' may be preceded by a numerical multiplier and should be separated from the last (element symbol + count) by a space. Pre- or post-multipliers may be used for individual moieties.

Examples: 'C7 H4 Cl Hg N O3 S', 'C12 H17 N4 O S 1+, C6 H2 N3 O7 1-', 'C12 H16 N2 O6, 5 (H2 O1)', '(Cd 2+)3, (C6 N6 Cr 3-)2, 2 (H2 O)'.

[chemical_formula]

chemical formula structural

(char)

See the CHEMICAL_FORMULA category description for the rules for writing chemical formulae for inorganics, organometallics, metal complexes *etc.*, in which bonded groups are preserved as discrete entities within parentheses, with post-multipliers as required. The order of the elements should give as much information as possible about the chemical structure. Parentheses may be used and nested as required. This formula should correspond to the structure as actually reported, *i.e.* trace elements not included in atom-type and atom-site lists should not be included in this formula (see also _chemical_formula_analytical).

Examples: 'Ca ((Cl O3)2 O)2 (H2 O)6',

'(Pt (N H3)2 (C5 H7 N3 O)2) (C1 O4)2'. [chemical_formula]

chemical formula sum

(chai

See the CHEMICAL_FORMULA category description for the rules for writing chemical formulae in which all discrete bonded residues and ions are summed over the constituent elements, following the ordering given in general rule (5) in the CHEMICAL_FORMULA category description. Parentheses are not normally used.

Example: 'C18 H19 N7 O8 S'.

[chemical_formula]

chemical formula weight

numb

Formula mass in daltons. This mass should correspond to the formulae given under _chemical_formula_structural, *_iupac, *_moiety or *_sum and, together with the Z value and cell parameters, should yield the density given as _exptl_crystal_density_diffrn.

The permitted range is $1.0 \rightarrow \infty$.

[chemical_formula]

chemical formula weight meas

(numb)

Formula mass in daltons measured by a non-diffraction experiment.

The permitted range is $1.0 \rightarrow \infty$.

[chemical formula]

CITATION

Data items in the CITATION category record details about the literature cited as being relevant to the contents of the data block.

Example 1 – based on PDB entry 5HVP and laboratory records for the structure corresponding to PDB entry 5HVP.

```
1000
citation id
citation coordinate linkage
citation title
citation country
citation page first
_citation_page_last
citation year
citation journal abbrev
citation journal volume
citation journal issue
_citation_journal_id_ASTM
citation journal id ISSN
citation book title
citation_book_publisher
citation book id ISBN
citation special details
 primary yes
 Crystallographic analysis of a complex between human
 immunodeficiency virus type 1 protease and
 acetyl-pepstatin at 2.0-Angstroms resolution.
    14209 14219 1990 'J. Biol. Chem.' 265
 HBCHA3 0021-9258 .
 The publication that directly relates to this coordinate
 set.
 2 no
 Three-dimensional structure of aspartyl-protease from
 human immunodeficiency virus HIV-1.
 UK 615 619 1989 'Nature' 337 .
 NATUAS 0028-0836 . .
 Determination of the structure of the unliqued enzyme.
 3 no
 Crystallization of the aspartylprotease from human
 immunodeficiency virus, HIV-1.
    1919 1921 1989 'J. Biol. Chem.'
                                        264
 HBCHA3 0021-9258 . .
 Crystallization of the unliganded enzyme.
```

citation abstract

(char)

Abstract for the citation. This is used most when the citation is extracted from a bibliographic database that contains full text or abstract information.

Appears in list containing _citation_id

[citation]

_citation_abstract_id_CAS

(cnar

The *Chemical Abstracts* Service (CAS) abstract identifier; relevant for journal articles.

Appears in list containing _citation_id.

[citation]

citation book id ISBN

(char)

The International Standard Book Number (ISBN) code assigned to the book cited; relevant for books or book chapters.

Appears in list containing _citation_id.

[citation]

citation book publisher

(char)

The name of the publisher of the citation; relevant for books or book chapters.

Appears in list containing $_\mathtt{citation}_\mathtt{id}.$

Example: 'John Wiley'.

[citation]

citation_book_publisher_city

(char)

The location of the publisher of the citation; relevant for books or book chapters.

Appears in list containing _citation_id.

Example: 'New York'. [citation]

citation book title

The title of the book in which the citation appeared; relevant for books or book chapters.

Appears in list containing citation id.

[citation]

_citation_coordinate_linkage

(char)

_citation_coordinate_linkage states whether or not this citation is concerned with precisely the set of coordinates given in the data block. If, for instance, the publication described the same structure, but the coordinates had undergone further refinement prior to creation of the data block, the value of this data item would be 'no'.

Appears in list containing _citation_id.

The data value must be one of the following:

no citation unrelated to current coordinates

n abbreviation for 'no'

citation related to current coordinates yes

abbreviation for 'yes' У

[citation]

citation country

(char)

The country of publication; relevant for books and book chapters. Appears in list containing _citation_id.

citation database id CSD

(char)

Identifier ('refcode') of the database record in the Cambridge Structural Database that contains details of the cited structure.

Appears in list containing _citation_id.

Example: 'LEKKUH'.

[citation]

citation database id Medline

(numb)

Accession number used by Medline to categorize a specific bibliographic entry.

Appears in list containing citation id.

The permitted range is $1 \to \infty$.

Example: '89064067'.

[citation]

citation id

(char)

The value of citation id must uniquely identify a record in the citation list. The citation id 'primary' should be used to indicate the citation that the author(s) consider to be the most pertinent to the contents of the data block. Note that this item need not be a number; it can be any unique identifier.

Appears in list as essential element of loop structure. May match child data name(s): _citation_author_citation_id, _citation_editor_citation_id.

Examples: 'primary', '1', '2', '3'. [citation]

citation journal abbrev

(char)

Abbreviated name of the journal cited as given in the Chemical Abstracts Service Source Index.

Appears in list containing _citation_id.

Example: 'J. Mol. Biol.'.

[citation]

citation journal full

(char)

Full name of the journal cited; relevant for journal articles.

Appears in list containing citation id.

Example: 'Journal of Molecular Biology'.

[citation]

citation journal id ASTM

The American Society for Testing and Materials (ASTM) code assigned to the journal cited (also referred to as the CODEN designator of the Chemical Abstracts Service); relevant for journal articles.

Appears in list containing _citation_id.

[citation]

citation journal id CSD

(char)

The Cambridge Structural Database (CSD) code assigned to the journal cited; relevant for journal articles. This is also the system used at the Protein Data Bank (PDB).

Appears in list containing _citation_id.

Example: '0070'.

[citation]

citation journal id ISSN

(char)

The International Standard Serial Number (ISSN) code assigned to the journal cited; relevant for journal articles.

Appears in list containing _citation_id.

[citation]

citation journal issue

(char)

Issue number of the journal cited; relevant for journal articles.

Appears in list containing _citation_id.

Example: '2' [citation]

citation journal volume

(char)

Volume number of the journal cited; relevant for journal articles.

Appears in list containing _citation_id.

Example: '174'. [citation]

citation language

(char)

[citation]

Language in which the cited article is written.

Appears in list containing _citation_id.

Example: 'German'.

_citation_page_first

citation page last

(char)

The first and last pages of the citation; relevant for journal articles, books and book chapters.

Appears in list containing citation id.

[citation]

citation special details

(char)

A description of special aspects of the relationship of the contents of the data block to the literature item cited.

Appears in list containing citation id.

Examples:

```
; citation relates to this precise coordinate set
; citation relates to earlier low-resolution structure
: citation relates to further refinement of structure
  reported in citation 2
                                                      [citation]
```

citation title

(char)

The title of the citation; relevant for journal articles, books and book chapters.

Appears in list containing _citation_id.

Example:

; Structure of diferric duck ovotransferrin at 2.35 \%A resolution.

[citation]

citation year

(numb)

The year of the citation; relevant for journal articles, books and book chapters.

Appears in list containing _citation_id.

Example: '1984'. [citation]

CITATION_AUTHOR

Data items in the CITATION_AUTHOR category record details about the authors associated with the citations in the _citation_ list

Example 1 – based on PDB entry 5HVP and laboratory records for the structure corresponding to PDB entry 5HVP.

```
loop
citation author citation id
_citation_author_name
 primary 'Fitzgerald, P.M.D.'
 primary
           'McKeever, B.M.'
 primary
           'Van Middlesworth, J.F.'
           'Springer, J.P.
 primary
           'Heimbach, J.C.'
 primary
 primarv
           'Leu. C.-T.'
 primary
           'Herber, W.K.'
 primary
           'Dixon, R.A.F.'
 primary
           'Darke, P.L.'
           'Navia, M.A.'
           'Fitzgerald, P.M.D.'
  2
            'McKeever, B.M.'
            'Leu, C.-T.'
 2
           'Heimbach, J.C.'
 2
 2
           'Herber, W.K.'
 2
           'Sigal, I.S.'
  2
           'Darke, P.L.'
  2
           'Springer, J.P.'
  3
           'McKeever, B.M.
            'Navia, M.A.'
  3
  3
           'Fitzgerald, P.M.D.
  3
           'Springer, J.P.'
  3
           'Leu, C.-T.'
  3
           'Heimbach, J.C.'
           'Herber, W.K.'
  3
  3
           'Sigal, I.S.
  3
           'Darke, P.L.'
```

citation author citation id

(cha

The value of _citation_author_citation_id must match an identifier specified by _citation_id in the _citation_ list.

Appears in list as essential element of loop structure. **Must** match parent data name <code>_citation_id</code>. <code>[citation_author]</code>

citation author name

(che

Name of an author of the citation; relevant for journal articles, books and book chapters. The family name(s), followed by a comma and including any dynastic components, precedes the first name(s) or initial(s).

Appears in list as essential element of loop structure.

Examples: 'Bleary, Percival R.','O'Neil, F.K.','Van den Bossche, G.', 'Yang, D.-L.', 'Simonov, Yu.A.','M\"uller, H.A.', 'Ross II, C.R.'.

[citation_author]

citation author ordinal

5

5

(char

This data name defines the order of the author's name in the list of authors of a citation.

Appears in list. [citation_author]

CITATION_EDITOR

Data items in the CITATION_EDITOR category record details about the editor associated with the book or book chapter citations in the _citation_ list.

```
Example 1 - hypothetical example.

loop_
_citation_editor_citation_id
_citation_editor_name
5 'McKeever, B.M.'
5 'Navia, M.A.'
```

'Fitzgerald, P.M.D.

'Springer, J.P.'

```
_citation_editor_citation_id
```

(char)

The value of _citation_editor_citation_id must match an identifier specified by _citation_id in the _citation_ list.

```
Appears in list as essential element of loop structure. Must match parent data name _citation_id. [citation_editor]
```

```
citation editor name
```

(chai

Name of an editor of the citation; relevant for books and book chapters. The family name(s), followed by a comma and including any dynastic components, precedes the first name(s) or initial(s).

Appears in list as essential element of loop structure.

```
Examples: 'Bleary, Percival R.', 'O'Neil, F.K.', 'Van den Bossche, G.', 'Yang, D.-L.', 'Simonov, Yu.A.', 'M\"uller, H.A.', 'Ross II, C.R.'.
```

[citation editor]

citation editor ordinal

(char)

This data name defines the order of the editor's name in the list of editors of a citation.

Appears in list. [citation_editor]

COMPUTING

Data items in the COMPUTING category record details about the computer programs used in the crystal structure analysis.

```
Example 1 – Rodrìguez-Romero, Ruiz-Pérez & Solans [Acta Cryst. (1996), C52, 1415–1417].
```

```
computing_data_collection 'CAD-4 (Enraf-Nonius, 1989)'
computing_cell_refinement 'CAD-4 (Enraf-Nonius, 1989)'
computing_data_reduction 'CFEO (Solans, 1978)'
computing_structure_solution 'SHELXS86 (Sheldrick, 1990)'
computing_structure_refinement 'SHELXL93 (Sheldrick, 1993)'
computing_publication_material 'PARST (Nardelli, 1983)'
```

```
_computing_cell_refinement
_computing_data_collection
_computing_data_reduction
_computing_molecular_graphics
_computing_publication_material
_computing_structure_refinement
_computing_structure_solution (char)
```

Software used in the processing of the data. Give the program or package name and a brief reference.

```
Examples: 'CAD-4 (Enraf-Nonius, 1989)',
'DIFDAT, SORTRF, ADDREF (Hall & Stewart, 1990)',
'FRODO (Jones, 1986), ORTEP (Johnson, 1965)',
'CRYSTALS (Watkin, 1988)', 'SHELX85 (Sheldrick, 1985)'.
```

[computing]

DATABASE

Data items in the DATABASE category record details about the database identifiers of the data block. These data items are assigned by database managers and should only appear in a CIF if they originate from that source.

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

_database_code_CSD 'VOBYUG'

```
_database_code_CAS
_database_code_COD
_database_code_CSD
_database_code_ICSD
_database_code_MDF
_database_code_NBS
_database_code_PDB
_database_code_PDF
```

(char)

The codes are assigned by databases: *Chemical Abstracts*; Crystallography Open Database (COD); Cambridge Structural Database

(organic and metal-organic compounds); Inorganic Crystal Structure Database; Metals Data File (metal structures); NBS (NIST) Crystal Data Database (lattice parameters); Protein Data Bank; and the Powder Diffraction File (JCPDS/ICDD).

[database]

database code depnum ccdc archive

(chai

Deposition numbers assigned by the Cambridge Crystallographic Data Centre (CCDC) to files containing structural information archived by the CCDC.

[database]

database code depnum ccdc fiz

(char

Deposition numbers assigned by the Fachinformationszentrum Karlsruhe (FIZ) to files containing structural information archived by the Cambridge Crystallographic Data Centre (CCDC).

[database]

database code depnum ccdc journal

'slow cooled with dir

Deposition numbers assigned by various journals to files containing structural information archived by the Cambridge Crystallographic Data Centre (CCDC).

[database]

database CSD history

(char)

A history of changes made by the Cambridge Crystallographic Data Centre and incorporated into the Cambridge Structural Database (CSD).

[database]

_database_journal_ASTM database journal CSD

(char)

The ASTM CODEN designator for a journal as given in the *Chemical Source List* maintained by the *Chemical Abstracts* Service, and the journal code used in the Cambridge Structural Database.

[database]

DIFFRN

Data items in the DIFFRN category record details about the intensity measurements.

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

diffrn_special_details

; \q scan width (1.0 + 0.14tan\q)\%, \q scan rate
1.2\% min^-1^. Background counts for 5 s on each side
every scan.

diffrn_ambient_temperature

293

diffrn ambient environment

(char)

The gas or liquid surrounding the sample, if not air.

Examples: 'He', 'vacuum', 'mother liquor'.

[diffrn]

diffrn ambient pressure

The mean hydrostatic pressure in kilopascals at which the intensities were measured.

The permitted range is $0.0 \to \infty$.

[diffrn]

_diffrn_ambient_pressure_gt

diffrn ambient pressure lt

(numb)

The mean hydrostatic pressure in kilopascals above which (*_gt) or below which (*_lt) the intensities were measured. These items allow for a pressure range to be given. _diffrn_ambient_pressure should always be used in preference to these items whenever possible.

The permitted range is $0.0 \to \infty$.

Related item: _diffrn_ambient_pressure (alternate). [diffrn]

diffrn ambient temperature

(numb, su)

The mean temperature in kelvins at which the intensities were measured.

The permitted range is $0.0 \rightarrow \infty$.

[diffrn]

_diffrn_ambient_temperature_gt diffrn ambient temperature lt

(numb)

The mean temperature in kelvins above which (*_gt) or below which (*_lt) the intensities were measured. These items allow a range of temperatures to be given. _diffrn_ambient_temperature should always be used in preference to these items whenever possible.

The permitted range is $0.0 \rightarrow \infty$.

Related item: _diffrn_ambient_temperature (alternate). [diffrn]

diffrn crystal treatment

(char)

Remarks about how the crystal was treated prior to the intensity measurements. Particularly relevant when intensities were measured at low temperature.

Examples: 'equilibrated in hutch for 24 hours',

'flash frozen in liquid nitrogen',

'slow cooled with direct air stream'.

out to diffrn reflns theta full.

[diffrn]

_diffrn_measured_fraction_theta_full (numb)
Fraction of unique (symmetry-independent) reflections measured

The permitted range is $0 \rightarrow 1.0$.

[diffrn]

(numb)

diffrn measured fraction theta max

Fraction of unique (symmetry-independent) reflections measured out to diffrn reflns theta max.

The permitted range is $0 \rightarrow 1.0$.

[diffrn]

diffrn special details

(char)

Special details of the intensity-measurement process. Should include information about source instability, crystal motion, degradation and so on.

Example:

```
; The results may not be entirely reliable as the measurement was made during a heat wave when the air-conditioning had failed.
```

[diffrn]

diffrn symmetry description

(char)

Observed diffraction point symmetry, systematic absences and possible space group(s) or superspace group(s) compatible with these.

[diffrn]

DIFFRN_ATTENUATOR

Data items in the DIFFRN_ATTENUATOR category record details about the diffraction attenuator scales employed.

Example 1 – hypothetical example.

```
loop_
_diffrn_attenuator_code
_diffrn_attenuator_scale
0 1.00
1 16.97
2 33.89
```

_diffrn_attenuator_code

(char)

A code associated with a particular attenuator setting. This code is referenced by the _diffrn_refln_attenuator_code which is stored with the intensities. See _diffrn attenuator scale.

Appears in list as essential element of loop structure. May match child data name(s):

 $_\mathtt{diffrn}\mathtt{_refln}\mathtt{_attenuator}\mathtt{_code}.$

[diffrn_attenuator]

_diffrn_attenuator_material

(char)

Material from which the attenuator is made.

Appears in list containing _diffrn_attenuator_code. [diffrn_attenuator

${\tt _diffrn_attenuator_scale}$

(numb)

The scale factor applied when an intensity measurement is reduced by an attenuator identified by <u>_diffrn_attenuator_code</u>. The measured intensity must be multiplied by this scale to convert it to the same scale as unattenuated intensities.

Appears in list containing _diffrn_attenuator_code.

The permitted range is $1.0 \rightarrow \infty$. [diffrn_attenuator]

DIFFRN_DETECTOR

Data items in the DIFFRN DETECTOR category describe the detector used to measure the scattered radiation, including any analyser and post-sample collimation.

Example 1 – based on PDB entry 5HVP and laboratory records for the structure corresponding to PDB entry 5HVP.

'multiwire' diffrn detector 'Siemens

diffrn detector

(char)

The general class of the radiation detector.

Related item: _diffrn_radiation_detector (alternate).

Examples: 'photographic film', 'scintillation counter', 'CCD plate', 'BF~3~ counter'. [diffrn detector]

diffrn detector area resol mean

The resolution of an area detector, in pixels mm^{-1} .

The permitted range is $0.0 \rightarrow \infty$. [diffrn detector]

diffrn detector details

A description of special aspects of the radiation detector.

[diffrn detector]

diffrn detector dtime

(numb)

The deadtime in microseconds of the detector used to measure the diffraction intensities.

The permitted range is $0.0 \rightarrow \infty$.

Related item: diffrn radiation detector dtime (alternate).

[diffrn detector]

diffrn detector type

(char)

The make, model or name of the detector device used.

[diffrn_detector]

diffrn radiation detector

This definition has been superseded and is retained here only for archival purposes. Use instead diffrn detector.

The detector used to measure the diffraction intensities.

[diffrn detector]

[diffrn detector]

diffrn radiation detector dtime

This definition has been superseded and is retained here only for archival pur $poses.\ Use\ instead\ _{\tt diffrn_detector_dtime}.$

The deadtime in microseconds of the detector used to measure the diffraction intensities.

The permitted range is $0.0 \rightarrow \infty$.

DIFFRN_MEASUREMENT

Data items in the DIFFRN MEASUREMENT category refer to the mounting of the sample and to the goniometer on which it is mounted.

Example 1 - based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276-2277].

_diffrn_measurement_device_type

'Philips PW1100/20 diffractometer $\q/2\q$

diffrn_measurement_method

diffrn measurement details

(char)

A description of special aspects of the intensity measurement.

Example: '440 frames of 0.25\%'. [diffrn measurement]

diffrn_measurement_device

The general class of goniometer or device used to support and orient the specimen.

Examples: 'three-circle diffractometer',

'four-circle diffractometer'. '\k-geometry diffractometer'.

'oscillation camera', 'precession camera'. [diffrn measurement]

diffrn measurement device details

A description of special aspects of the device used to measure the diffraction intensities.

```
; commercial goniometer modified locally to
 allow for 90\% \t arc
                                           [diffrn_measurement]
```

diffrn measurement device type

(char)

The make, model or name of the measurement device (goniometer) used.

[diffrn_measurement]

diffrn measurement method

(char)

(char)

Method used to measure the intensities.

Example: 'profile data from $\q/2\q$ scans'. [diffrn measurement]

diffrn measurement specimen support

The physical device used to support the crystal during data collec-

Examples: 'glass capillary', 'quartz capillary', 'fiber', 'metal loop'. [diffrn measurement]

DIFFRN_ORIENT_MATRIX

Data items in the DIFFRN ORIENT MATRIX category record details about the orientation matrix used in the measurement of the diffraction intensities.

Example 1 – data set n-alkylation_C-4 of Hussain, Fleming, Norman & Chang [Acta Cryst. (1996), C52, 1010-1012].

```
diffrn_orient_matrix_UB_11
                                      -0.04170
diffrn orient matrix UB 12
                                      -0.01429
_diffrn_orient_matrix_UB_13
                                      -0.02226
_diffrn_orient_matrix_UB_21
                                      -0.00380
_diffrn_orient_matrix_UB_22
                                      -0.05578
_diffrn_orient_matrix_UB_23
                                      -0.05048
_diffrn_orient_matrix_UB_31
                                       0.00587
diffrn orient matrix UB 32
                                      -0.13766
diffrn orient matrix UB 33
                                       0.02277
```

diffrn orient matrix type

A description of the orientation matrix type and how it should be applied to define the orientation of the crystal precisely with respect to the diffractometer axes.

diffrn_orient_matrix_type 'TEXSAN convention (MSC, 1989)'

[diffrn_orient_matrix]

```
diffrn orient matrix UB 11
diffrn orient matrix UB 12
diffrn orient matrix UB 13
diffrn orient matrix UB 21
diffrn orient matrix UB 22
diffrn orient matrix UB 23
diffrn orient matrix UB 31
diffrn orient matrix UB 32
diffrn_orient_matrix_UB_33
                                          (numb)
```

The elements of the diffractometer orientation matrix. These define the dimensions of the reciprocal cell and its orientation to the local diffractometer axes. See diffrn orient matrix type.

[diffrn_orient_matrix]

DIFFRN_ORIENT_REFLN

Data items in the DIFFRN ORIENT REFLN category record details about the reflections that define the orientation matrix used in the measurement of the diffraction intensities.

Example 1 – typical output listing from an Enraf-Nonius CAD-4 diffractometer.

```
diffrn orient refln index h
diffrn orient refln index k
diffrn orient refln index l
diffrn orient refln angle theta
diffrn orient refln angle phi
_diffrn_orient_refln_angle_omega
diffrn_orient_refln_angle_kappa
                7.35
                                        17.53
      2
          3
                       44.74
                               2.62
                9.26
                       83.27
                                8.06
                                         5.79
  0
      0
          6
                5.85
                      -43.93 -25.36
                                        86.20
                     -57.87
  2
      1
          3
                7.36
                               6.26
                                         5.42
  0
      0
                5.85 -161.59
         -6
                              36.96
                                       -86.79
 - 3
      1
          0
                6.74
                       80.28
                               5.87
                                        2.60
  2
      0
          3
                5.86
                      -76.86
                              -0.17
                                        21.34
      0
         12
               11.78
                      -44.02 -19.51
  0
                                        86.41
      0
               11.78 -161.67
  0
         -12
                              42.81
                                       -86.61
  - 5
      1
          0
               11.75
                       86.24
  0
               11.82
                      -19.82 10.45
      4
          6
                                         4.19
      0
  5
          6
               14.13
                      -77.28
                              10.17
                                        15.34
                     -77.08 25.30
  8
      0
          0
               20.79
                                       -13.96
```

```
diffrn orient refln angle chi
diffrn_orient_refln_angle_kappa
diffrn_orient_refln_angle_omega
diffrn orient refln angle phi
diffrn orient refln angle psi
```

diffrn orient refln angle theta

Diffractometer angles of a reflection used to define the orientation matrix in degrees. See diffrn orient matrix UB and _diffrn_orient_refln_index_h, *_k and *_1.

Appears in list containing _diffrn_orient_refln_index_.

[diffrn_orient_refln]

```
diffrn orient refln index h
_diffrn_orient_refln_index_k
diffrn_orient_refln_index_l
                                            (numb)
```

The indices of a reflection used to define the orientation matrix. See diffrn orient matrix .

Appears in list as essential element of loop structure. [diffrn_orient_refln]

DIFFRN_RADIATION

Data items in the DIFFRN RADIATION category describe the radiation used in measuring the diffraction intensities, its collimation and monochromatization before the sample. Post-sample treatment of the beam is described by data items in the DIFFRN DETECTOR category.

Example 1 - based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276-2277].

_diffrn_radiation_type 'Cu K\a' diffrn radiation monochromator 'graphite'

diffrn radiation collimation

(char)

The collimation or focusing applied to the radiation.

Examples: '0.3 mm double-pinhole', '0.5 mm', 'focusing mirrors'.

[diffrn radiation]

_diffrn_radiation_filter_edge

(numb)

Absorption edge in ångströms of the radiation filter used.

The permitted range is $0.0 \rightarrow \infty$. [diffrn radiation]

diffrn radiation inhomogeneity

Half-width in millimetres of the incident beam in the direction perpendicular to the diffraction plane.

The permitted range is $0.0 \rightarrow \infty$.

[diffrn radiation]

diffrn radiation monochromator

(char)

The method used to obtain monochromatic radiation. If a monochromator crystal is used, the material and the indices of the Bragg reflection are specified.

Examples: 'Zr filter', 'Ge 220', 'none', 'equatorial mounted graphite'.

[diffrn radiation]

diffrn radiation polarism norm

The angle in degrees, as viewed from the specimen, between the perpendicular component of the polarization and the diffraction plane. See diffrn radiation polarism ratio.

The permitted range is $-180.0 \rightarrow 180.0$.

[diffrn radiation]

diffrn radiation polarisn ratio

Polarization ratio of the diffraction beam incident on the crystal. It is the ratio of the perpendicularly polarized to the parallel polarized components of the radiation. The perpendicular component forms an angle of diffrn radiation polarism norm to the normal to the diffraction plane of the sample (i.e. the plane containing the incident and reflected beams).

The permitted range is $0.0 \rightarrow \infty$.

[diffrn radiation]

diffrn radiation probe

The nature of the radiation used (i.e. the name of the subatomic particle or the region of the electromagnetic spectrum). It is strongly recommended that this information be given, so that the probe radiation can be simply determined.

The data value must be one of the following:

x-ray neutron electron gamma

[diffrn_radiation]

diffrn_radiation_type

(char)

The type of the radiation. This is used to give a more detailed description than diffrn radiation probe and is typically a description of the X-ray wavelength in Siegbahn notation.

Examples: 'Cu K\a', 'Cu K\a~1~', 'Cu K-L~2,3~', 'white-beam'.

[diffrn radiation]

diffrn radiation xray symbol

(char)

The IUPAC symbol for the X-ray wavelength for the probe radiation.

The data value must be one of the following:

 $K\alpha_1$ in older Siegbahn notation K-L~3~ K-L~2~ $K\alpha_2$ in older Siegbahn notation K-M~3~ $K\beta$ in older Siegbahn notation use where $K-L_3$ and $K-L_2$ are not resolved K-L~2,3~

[diffrn_radiation]

DIFFRN_RADIATION_WAVELENGTH

Data items in the DIFFRN RADIATION WAVELENGTH category describe the wavelength of the radiation used in measuring the diffraction intensities. Items may be looped to identify and assign weights to distinct wavelength components from a polychromatic beam.

Example 1 - based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276-2277].

_diffrn_radiation_wavelength

1.5418

diffrn radiation wavelength

(numb)

The radiation wavelength in angströms.

May appear in list containing _diffrn_radiation_wavelength_id.

The permitted range is $0.0 \rightarrow \infty$.

[diffrn radiation wavelength]

diffrn radiation wavelength details Information about the determination of the radiation wavelength that is not conveyed completely by an enumerated value of diffrn radiation wavelength determination.

May appear in list containing _diffrn_radiation_wavelength_id.

[diffrn radiation wavelength]

 $\verb|_diffrn_radiation_wavelength_determination| (\textit{char})$

The method of determination of incident wavelength.

May appear in list containing _diffrn_radiation_wavelength_id.

The data value must be one of the following:

fundamental Wavelength that is a fundamental property of matter $e.s. \text{ Mo } K\alpha$.

estimated Estimated from secondary information e.g. monochro-

mator angle or time of flight.

refined Based on refinement using a standard material with known cell parameters.

wii ceii parameters.

[diffrn_radiation_wavelength]

diffrn radiation wavelength id

An arbitrary code identifying each value of _diffrn_radiation_wavelength. Items in the DIFFRN_RADIATION category are looped when multiple wavelengths are used. This code is used to link with the _diffrn_refln_ list. It must match with one of the _diffrn_refln wavelength id codes.

 $Appears \ in \ list \ as \ essential \ element \ of \ loop \ structure. \ May \ match \ child \ data \ name(s):$

_diffrn_refln_wavelength_id.

Examples: 'x1', 'x2', 'neut'. [diffrn_radiation_wavelength]

diffrn radiation wavelength wt

(numb)

The relative weight of a wavelength identified by the code diffrn radiation wavelength id in the list of wavelengths.

Appears in list containing _diffrn_radiation_wavelength_id.

The permitted range is $0.0 \rightarrow 1.0$. Where no value is given, the assumed value is '1.0'.

[diffrn_radiation_wavelength]

DIFFRN REFLN

Data items in the DIFFRN_REFLN category record details about the intensities measured in the diffraction experiment. The DIFFRN_REFLN data items refer to individual intensity measurements and must be included in looped lists. (The DIFFRN_REFLNS data items specify the parameters that apply to all intensity measurements. The DIFFRN_REFLNS data items are not looped.)

Example I – extracted from the CAD-4 listing for $Tl_2Cd_2(SO_4)_3$ at 85 K (unpublished).

```
loop_
   _diffrn_refln_index_h
    _diffrn_refln_index_k
    diffrn refln index l
    diffrn refln angle chi
    diffrn refln scan rate
    diffrn refln counts bg 1
    diffrn refln counts total
   _diffrn_refln_counts_bg_2
    _diffrn_refln_angle_theta
    _diffrn_refln_angle_phi
    diffrn refln angle omega
    diffrn refln angle kappa
    _diffrn_refln_scan_width
    diffrn refln elapsed time
   0 -16 0. 4.12 28 127 36 33.157 -75.846 16.404
50.170 1.516 19.43
0 0 -15 0. 4.12 38 143 28
                             30.847
                                    -75.846 14.094
50.170 1.516 19.82
0 0 -14 0. 1.03 142 742 130
                             28.592
                                     -75.846
                                             11.839
50.170 1.516 21.32
0 0 -13 0. 4.12 26 120 37 26.384
                                     -75.846
                                               9.631
50.170 1.450 21.68
0 0 -12 0. 0.97 129 618 153 24.218
                                     -75.846
                                               7.464
50.170 1.450 23.20
0 0 -11 0. 4.12 33 107 38 22.087
                                     -75.846
                                               5.334
50.170 1.384 23.55
0 0 -10 0. 4.12 37 146 33
                             19.989
                                     -75.846
                                               3.235
50.170 1.384 23.90
0 0 -9 0. 4.12 50 179 49 17.918
50.170 1.384 24.25
# - - - data truncated for brevity - - -
     -4 0. 1.03 69 459 73 30.726 -53.744 46.543
-47.552 1.516 2082.58
3 4 -5 0. 1.03 91 465 75 31.407 -54.811 45.519
-42.705 1.516 2084.07
3 14 -6 0. 1.03 84 560 79 32.228 -55.841 44.745
-38.092 1.516 2085.57
     - - data truncated for brevity - - - -
```

```
__diffrn_refln_angle_chi
__diffrn_refln_angle_kappa
__diffrn_refln_angle_omega
__diffrn_refln_angle_phi
__diffrn_refln_angle_psi
__diffrn_refln_angle_theta (numb)
```

The diffractometer angles of a reflection in degrees. These correspond to the specified orientation matrix and the original measured cell before any subsequent cell transformations.

Appears in list containing _diffrn_refln_index_. [diffrn_refln]

diffrn refln attenuator code

(char)

The code identifying the attenuator setting for this reflection. This code must match one of the _diffrn_attenuator_code values.

Appears in list containing _diffrn_refln_index_. Must match parent data name _diffrn_attenuator_code. [diffrn_refln]

diffrn refln class code

(char)

The code identifying the class to which this reflection has been assigned. This code must match a value of <code>_diffrn_reflns_class_code</code>. Reflections may be grouped into classes for a variety of purposes. For example, for modulated structures each reflection class may be defined by the number $m = \sum |m_i|$, where the m_i are the integer coefficients that, in addition to h, k, l, index the corresponding diffraction vector in the basis defined for the reciprocal cell

Appears in list containing _diffrn_refln_index_. Must match parent data name diffrn reflns class code. [diffrn refln]

```
_diffrn_refln_counts_bg_1
_diffrn_refln_counts_bg_2
_diffrn_refln_counts_net
_diffrn_refln_counts_peak
_diffrn_refln_counts_total
```

(numb)

The diffractometer counts for the measurements: background before the peak, background after the peak, net counts after background removed, counts for peak scan or position, and the total counts (background plus peak).

Appears in list containing _diffrn_refln_index_. [diffrn_refln]

diffrn refln crystal id

(char)

Code identifying each crystal if multiple crystals are used. Is used to link with _exptl_crystal_id in the _exptl_crystal_list.

Appears in list containing _diffrn_refln_index_. Must match parent data name exptl crystal id. [diffrn refln]

_diffrn_refln_detect_slit_horiz

diffrn refln detect slit vert

Total slit apertures in degrees in the diffraction plane (*_horiz) and perpendicular to the diffraction plane (* vert).

Appears in list containing _diffrn_refln_index_.

The permitted range is $0.0 \rightarrow 90.0$.

[diffrn_refln]

diffrn refln elapsed time

(numb)

Elapsed time in minutes from the start of the diffraction experiment to the measurement of this intensity.

Appears in list containing _diffrn_refln_index_.

The permitted range is $0.0 \rightarrow \infty$.

[diffrn_refln]

```
_diffrn_refln_index_h
_diffrn_refln_index_k
_diffrn_refln_index_l
```

(numb)

Miller indices of a measured reflection. These need not match the <code>refln_index_h</code>, *_k, *_1 values if a transformation of the original measured cell has taken place. Details of the cell transformation are given in <code>_diffrn_reflns_reduction_process</code>. See also <code>_diffrn_reflns_transf_matrix_</code>.

Appears in list as essential element of loop structure.

[diffrn_refln]

diffrn refln intensity net

(numb)

Net intensity calculated from the diffraction counts after the attenuator and standard scales have been applied.

Appears in list containing $_diffrn_refln_index_.$

The permitted range is $0 \to \infty$. [diffrn_refln]

diffrn refln intensity sigma

This definition has been superseded and is retained here only for archival purposes. Use instead diffrn refln intensity u.

Standard uncertainty (e.s.d.) of the net intensity calculated from the diffraction counts after the attenuator and standard scales have been

Appears in list containing _diffrn_refln_index_.

The permitted range is $0 \to \infty$.

[diffrn_refln]

diffrn refln_intensity_u

(numb)

Standard uncertainty of the net intensity calculated from the diffraction counts after the attenuator and standard scales have been applied.

Appears in list containing _diffrn_refln_index_

The permitted range is $0 \to \infty$.

Related item: _diffrn_refln_intensity_sigma (alternate). [diffrn refln]

diffrn_refln_scale_group_code

(char)

The code identifying the scale applicable to this reflection. This code must match with a specified _diffrn_scale_group_code

Appears in list containing _diffrn_refln_index_. Must match parent data name _diffrn_scale_group_code. [diffrn_refln]

diffrn refln scan mode

(char)

The code identifying the mode of scanning for measurements using a diffractometer. See diffrn refln scan width and _diffrn_refln_scan_mode_backgd.

Appears in list containing _diffrn_refln_index_

The data value must be one of the following:

ω scan \circ m

ot $\omega/2\theta$ scan Q scans (arbitrary reciprocal directions)

[diffrn refln]

diffrn refln scan mode backgd

(char)

The code identifying the mode of scanning a reflection to measure the background intensity.

Appears in list containing _diffrn_refln_index_.

The data value must be one of the following:

st stationary counter background moving counter background mo

[diffrn_refln]

diffrn refln scan rate

The rate of scanning a reflection in degrees per minute to measure the intensity.

Appears in list containing _diffrn_refln_index_.

The permitted range is $0.0 \to \infty$.

[diffrn refln]

diffrn refln scan time backgd (numb)

The time spent measuring each background in seconds.

Appears in list containing _diffrn_refln_index_.

The permitted range is $0.0 \rightarrow \infty$. [diffrn_refln]

diffrn refln scan width

(numb)

The scan width in degrees of the scan mode defined by the code diffrn refln scan mode.

Appears in list containing diffrn refln index .

The permitted range is $0.0 \rightarrow 90.0$.

[diffrn_refln]

diffrn refln sint/lambda

The $(\sin \theta)/\lambda$ value in reciprocal angströms for this reflection.

Appears in list containing _diffrn_refln_index_.

The permitted range is $0.0 \rightarrow \infty$. [diffrn refln]

diffrn refln standard code (char)

A code indicating that this reflection was measured as a standard reflection. The value must be '.' or match one of the diffrn standard refln code values.

Appears in list containing _diffrn_refln_index_. Must match parent data name _diffrn_standard_refln_code.

Examples: '1', '2', '3', 's1', 's2', 's3', 'A', 'B', 'C'. [diffrn refln]

diffrn refln wavelength

(numb)

The mean wavelength in ångströms of the radiation used to measure the intensity of this reflection. This is an important parameter for reflections measured using energy-dispersive detectors or the Laue method

Appears in list containing diffrn refln index .

The permitted range is $0.0 \rightarrow \infty$.

[diffrn_refln]

diffrn refln wavelength id

(char)

Code identifying the wavelength in the diffrn radiation list. Appears in list containing diffrn refln index . Must match parent data name

diffrn radiation_wavelength_id.

Examples: 'x1', 'x2', 'neut'.

[diffrn refln]

DIFFRN_REFLNS

Data items in the DIFFRN REFLNS category record details about the set of intensities measured in the diffraction experiment. The DIFFRN REFLNS data items specify the parameters that apply to all intensity measurements. The DIFFRN REFLNS data items are not looped. (The DIFFRN REFLN data items refer to individual intensity measurements and must be included in looped lists.)

Example 1 - based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276-2277].

_diffrn_reflns_number	1592	
_diffrn_reflns_av_R_equivalents	0	
_diffrn_reflns_av_unetI/netI	.027	
_diffrn_reflns_limit_h_min	0	
_diffrn_reflns_limit_h_max	6	
_diffrn_reflns_limit_k_min	-17	
_diffrn_reflns_limit_k_max	0	
_diffrn_reflns_limit_l_min	0	
_diffrn_reflns_limit_l_max	22	
_diffrn_reflns_theta_min	3.71	
_diffrn_reflns_theta_max	61.97	

diffrn_reflns_av_R_equivalents

The residual $[\sum av]\Delta(I)|/\sum |av(I)|]$ for symmetry-equivalent reflections used to calculate the average intensity av(I). The $\operatorname{av}|\Delta(I)|$ term is the average absolute difference between $\operatorname{av}(I)$ and the individual symmetry-equivalent intensities.

The permitted range is $0.0 \rightarrow \infty$.

[diffrn reflns]

diffrn reflns av sigmaI/netI

This definition has been superseded and is retained here only for archival purposes. Use instead _diffrn_reflns_av_unetI/netI.

Measure $[\sum |u(\text{net}I)|/\sum |\text{net}I|]$ for all measured reflections.

The permitted range is $0.0 \rightarrow \infty$. [diffrn_reflns]

diffrn reflns av unetI/netI

(numb)

Measure $\left[\sum |u(\text{net}I)|/\sum |\text{net}I|\right]$ for all measured reflections. The permitted range is $0.0 \rightarrow \infty$.

Related item: _diffrn_reflns_av_sigmaI/netI (alternate). [diffrn_reflns]

diffrn reflns Laue measured_fraction_full(numb) Fraction of Laue unique reflections (symmetry-independent group) measured out to the resoluthe Laue in _diffrn_reflns_resolution full given in diffrn reflns theta full. The Laue group always contains a centre of symmetry so that the reflection h, k, l is always equivalent to the reflection -h, -k, -l even in space groups without a centre of symmetry. This number should not be less than 0.95, since it represents the fraction of reflections measured in the part of the diffraction pattern that is essentially complete.

The permitted range is $0.95 \rightarrow 1.0$.

Related item: _diffrn_measured_fraction_theta_full (alternate).

[diffrn reflns]

_diffrn_reflns_Laue_measured_fraction_max (numb) Fraction of Laue unique reflections (symmetry-independent in the Laue group) measured out to the resolution given in _diffrn_reflns_resolution_max or _diffrn_reflns_theta_max. The Laue group always contains a centre of symmetry so that the reflection h, k, l is always equivalent to the reflection -h, -k, -l even in space groups without a centre of symmetry.

The permitted range is $0 \rightarrow 1.0$.

Related item: _diffrn_measured_fraction_theta_max (alternate).

[diffrn reflns]

```
_diffrn_reflns_limit_h_max
_diffrn_reflns_limit_h_min
_diffrn_reflns_limit_k_max
_diffrn_reflns_limit_k_min
_diffrn_reflns_limit_l_max
_diffrn_reflns_limit_l_min
```

(numb)

The limits on the Miller indices of the intensities specified by _diffrn_refln_index_h, *_k, *_1.

[diffrn_reflns]

diffrn reflns number

numb

The total number of measured intensities, excluding reflections that are classed as systematically absent arising from translational symmetry in the crystal unit cell.

The permitted range is $0 \to \infty$.

[diffrn reflns]

_diffrn_reflns_point_group_measured_fraction_full (numb)

Fraction of crystal point-group unique reflections (i.e. symmetry-independent in the crystal point group) measured out to the resolution given in $_{\tt diffrn_reflns_resolution_full}$ or $_{\tt diffrn_reflns_theta_full}$. For space groups that do not contain a centre of symmetry the reflections h, k, l and -h, -k, -l are independent. This number should not be less than 0.95, since it represents the fraction of reflections measured in the part of the diffraction pattern that is essentially complete.

The permitted range is $0.95 \rightarrow 1.0$.

 $Related\ item: \verb|_diffrn_measured_fraction_theta_full\ (alternate).$

[diffrn reflns]

_diffrn_reflns_point_group_measured_fraction_max (numb)

Fraction of crystal point-group unique reflections (i.e. symmetry-independent in the crystal point group) measured out to the resolution given in $_{\tt diffrn_reflns_resolution_max}$ or $_{\tt diffrn_reflns_theta_max}$. For space groups that do not contain a centre of symmetry the reflections h, k, l and -h, -k, -l are independent.

The permitted range is $0\,\rightarrow\,1.0.$

Related item: _diffrn_measured_fraction_theta_max (alternate).

[diffrn reflns]

diffrn reflns reduction process (char

A description of the process used to reduce the intensities into structure-factor magnitudes.

Example: 'data averaged using Fisher test'. [diffrn reflns]

diffrn reflns resolution full

(numb)

The resolution in reciprocal angströms at which the measured reflection count is close to complete. The fraction of unique reflections measured out to this angle is given by diffrn measured_fraction_theta_full.

The permitted range is $0.0 \rightarrow \infty$.

Related item: _diffrn_reflns_theta_full (alternate). [diffrn_reflns]

diffrn reflns resolution max

(numb)

Maximum resolution in reciprocal ångströms of the measured diffraction pattern. The fraction of unique reflections measured out to this angle is given by $_{\tt diffrn_measured_fraction_theta_max}$ The permitted range is $0.0 \to \infty$.

 $Related\ item: \verb|_diffrn_reflns_theta_max| (alternate).$

[diffrn_reflns]

diffrn reflns theta full

(numb)

The θ angle (in degrees) at which the measured reflection count is close to complete. The fraction of unique reflections measured out to this angle is given by diffrn_measured_fraction_theta_full.

The permitted range is $0.0 \rightarrow 90.0$.

[diffrn reflns]

diffrn reflns theta max

(numb)

Maximum θ angle in degrees for the measured intensities. The fraction of unique reflections measured out to this angle is given by diffrn measured fraction theta max

The permitted range is $0.0 \rightarrow 90.0$.

[diffrn reflns]

diffrn reflns theta min

(numb)

Minimum θ angle in degrees for the measured intensities.

The permitted range is $0.0 \rightarrow 90.0$.

[diffrn_reflns]

```
_diffrn_reflns_transf_matrix_11
_diffrn_reflns_transf_matrix_12
_diffrn_reflns_transf_matrix_13
_diffrn_reflns_transf_matrix_21
_diffrn_reflns_transf_matrix_22
_diffrn_reflns_transf_matrix_23
_diffrn_reflns_transf_matrix_31
_diffrn_reflns_transf_matrix_32
_diffrn_reflns_transf_matrix_33
_diffrn_reflns_transf_matrix_33
```

Elements of the matrix used to transform the diffraction reflection indices _diffrn_refln_index_h, *_k, *_1 into the _refln_index_h, *_k, *_1 indices.

$$(h \quad k \quad l)_{\text{diffraction}} \begin{pmatrix} 11 & 12 & 13 \\ 21 & 22 & 23 \\ 31 & 32 & 33 \end{pmatrix} = (h' \quad k' \quad l').$$

[diffrn_reflns]

DIFFRN_REFLNS_CLASS

Data items in the DIFFRN_REFLNS_CLASS category record details about the classes of reflections measured in the diffraction experiment.

Example 1 – example corresponding to the one-dimensional incommensurately modulated structure of K_2SeO_4 .

Each reflection class is defined by the number $m = \sum |m_i|$, where the m_i are the integer coefficients that, in addition to h, k, l, index the corresponding diffraction vector in the basis defined for the reciprocal lattice.

```
loop_

_diffrn_reflns_class_number

_diffrn_reflns_class_d_res_high

_diffrn_reflns_class_d_res_low

_diffrn_reflns_class_av_R_eq

_diffrn_reflns_class_code

_diffrn_reflns_class_description

1580 0.551 6.136 0.015 'Main' 'm=0; main reflections'

1045 0.551 6.136 0.010 'Satl' 'm=1; first-order satellites'
```

diffrn reflns class av R eq

(numb)

For each reflection class, the residual $[\sum \operatorname{av}|\Delta(I)|/\sum |\operatorname{av}(I)|]$ for symmetry-equivalent reflections used to calculate the average intensity $\operatorname{av}(I)$. The $\operatorname{av}|\Delta(I)|$ term is the average absolute difference between $\operatorname{av}(I)$ and the individual symmetry-equivalent intensities.

```
Appears in list containing _diffrn_reflns_class_code.
```

The permitted range is $0.0 \rightarrow \infty$.

[diffrn_reflns_class]

_diffrn_reflns_class_av_sgI/I

(numb)

This definition has been superseded and is retained here only for archival purposes. Use instead _diffrn_reflns_class_av_uI/I.

Measure $\left[\sum |u(\text{net}I)|/\sum |\text{net}I|\right]$ for all measured intensities in a reflection class.

Appears in list containing _diffrn_reflns_class_code.

The permitted range is $0.0 \to \infty$. [diffrn_reflns_class]

diffrn reflns class av uI/I

Measure $\left[\sum |u(\text{net}I)|/\sum |\text{net}I|\right]$ for all measured intensities in a reflection class.

Appears in list containing _diffrn_reflns_class_code.

The permitted range is $0.0 \rightarrow \infty$.

Related item: diffrn reflns class av sgI/I (alternate).

[diffrn_reflns_class]

diffrn reflns class code

(char)

The code identifying a certain reflection class.

Appears in list as essential element of loop structure. May match child data name(s):

_diffrn_refln_class_code.

Examples: '1', 'm1', 's2'.

[diffrn reflns class]

diffrn reflns class d res high

(numb)

The smallest value in angströms of the interplanar spacings of the reflections in each reflection class. This is called the highest resolution for this reflection class.

Appears in list containing _diffrn_reflns_class_code.

The permitted range is $0.0 \to \infty$.

[diffrn reflns class]

diffrn reflns class d res low

(numb)

The highest value in angströms of the interplanar spacings of the reflections in each reflection class. This is called the lowest resolution for this reflection class.

Appears in list containing _diffrn_reflns_class_code

The permitted range is $0.0 \rightarrow \infty$.

[diffrn_reflns_class]

diffrn reflns class description

(char)

Description of each reflection class.

Appears in list containing _diffrn_reflns_class_code.

Examples: 'm=1 first order satellites',

'HOLO common projection reflections'.

[diffrn reflns class]

diffrn reflns class number

The total number of measured intensities for each reflection class, excluding the systematic absences arising from centring transla-

Appears in list containing diffrn reflns class code

The permitted range is $0 \to \infty$.

[diffrn_reflns_class]

DIFFRN_SCALE_GROUP

Data items in the DIFFRN SCALE GROUP category record details of the scaling factors applied to place all intensities in the reflection lists on a common scale. Scaling groups might, for instance, correspond to each film in a multi-film data set or each crystal in a multi-crystal data set.

Example 1 – hypothetical example.

loop

_diffrn_scale_group_code

1 .86473

1.0654

diffrn scale group code

The code identifying a specific measurement group (e.g. for multifilm or multi-crystal data). The code must match a diffrn refln_scale_group_code in the reflection list.

Appears in list as essential element of loop structure. May match child data name(s):

_diffrn_refln_scale_group_code.

[diffrn_scale_group]

diffrn scale group I net

Examples: '1', '2', '3', 's1', 'A', 'B', 'c1', 'c2', 'c3'.

The scale for a specific measurement group which is to be multiplied with the net intensity to place all intensities in the _diffrn_refln_ or _refln_ list on a common scale.

Appears in list containing _diffrn_scale_group_code.

The permitted range is $0.0 \rightarrow \infty$.

[diffrn_scale_group]

DIFFRN_SOURCE

Data items in the DIFFRN SOURCE category record details of the source of radiation used in the diffraction experiment.

Example 1 – based on PDB entry 5HVP and laboratory records for the structure corresponding to PDB entry 5HVP.

diffrn source 'rotating anode X-ray tube diffrn source type 'Rigaku RU-200'

diffrn source power 50

diffrn source current 180 _diffrn_source_size '8 mm x 0.4 mm broad focus'

diffrn radiation source

(char)

This definition has been superseded and is retained here only for archival purposes. Use instead diffrn source.

The source of radiation.

[diffrn source]

diffrn source

(char)

The general class of the source of radiation.

Related item: diffrn radiation source (alternate).

Examples: 'sealed X-ray tube', 'nuclear reactor', 'spallation source', 'electron microscope', 'rotating-anode X-ray tube', 'synchrotron'.

[diffrn source]

diffrn source current

(numb)

The current in milliamperes at which the radiation source was operated.

The permitted range is $0.0 \rightarrow \infty$.

[diffrn source]

_diffrn_source_details

(char)

A description of special aspects of the source.

[diffrn_source]

diffrn source power

(numb)

The power in kilowatts at which the radiation source was operated. The permitted range is $0.0 \rightarrow \infty$. [diffrn source]

diffrn source size

(char)

The dimensions of the source as viewed from the sample.

Examples: '8mm x 0.4 mm fine-focus', 'broad focus'. [diffrn_source]

diffrn source take-off angle

The complement of the angle in degrees between the normal to the surface of the X-ray tube target and the primary X-ray beam for beams generated by traditional X-ray tubes.

The permitted range is $0 \rightarrow 90$.

Example: '1.53'.

[diffrn source]

diffrn source target

The chemical element symbol for the X-ray target (usually the anode) used to generate X-rays. This can also be used for spallation sources.

The data value must be one of the following:

H He Li Be B C N O F Ne Na Mg Al Si P Cl Ar K Ca Sc Ti V Cr Mn Fe Co Ni Cu Zn

Ga Ge As Se Br Kr Rb Sr Y Zr Nb Mo Tc Ru Rh Pd Aq Cd In Sn Sb Te I Xe Cs Ba La Ce Pr Nd

Pm Sm Eu Gd Tb Dy Ho Er Tm Yb Lu Hf Ta W Re Os Ir Pt Au Hg Tl Pb Bi Po At Rn Fr Ra Ac Th

[diffrn_source]

diffrn source type

(char)

The make, model or name of the source of radiation.

Pa U Np Pu Am Cm Bk Cf Es Fm Md No Lr

Examples: 'NSLS beamline X8C', 'Rigaku RU200'.

[diffrn_source]

diffrn source voltage

The voltage in kilovolts at which the radiation source was oper-

The permitted range is $0.0 \rightarrow \infty$.

[diffrn source]

DIFFRN_STANDARD_REFLN

Data items in the DIFFRN STANDARD REFLN category record details about the reflections treated as standards during the measurement of the diffraction intensities. Note that these are the individual standard reflections, not the results of the analysis of the standard reflections.

Example 1 - based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276-2277].

loop_ diffrn standard refln index h diffrn standard refln index k diffrn standard refln index 1 191 3 0 10

diffrn standard refln code

(char)

The code identifying a reflection measured as a standard reflection with the indices diffrn standard refln index. This is the same code as the diffrn refln standard code in the diffrn refln list.

Appears in list containing diffrn standard refln index . May match child data name(s): diffrn refln standard code.

Examples: '1', '2', '3', 's1', 'A', 'B'.

[diffrn standard refln]

diffrn standard refln index h diffrn standard refln index k diffrn_standard_refln_index_1

(numb)

Miller indices of standard reflections used in the diffraction measurement process.

Appears in list as essential element of loop structure.

[diffrn standard refln]

DIFFRN_STANDARDS

Data items in the DIFFRN STANDARDS category record details about the set of standard reflections used to monitor intensity stability during the measurement of diffraction intensities. Note that these records describe properties common to the set of standard reflections, not the standard reflections themselves.

Example 1 - based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276-22771.

diffrn standards number _diffrn_standards_interval_time 120 diffrn standards decay %

diffrn standards decay %

(numb, su)

The percentage decrease in the mean intensity of the set of standard reflections measured at the start of the measurement process and at the finish. This value usually affords a measure of the overall decay in crystal quality during the diffraction measurement process. Negative values are used in exceptional instances where the final intensities are greater than the initial ones. If no measurable decay has occurred, the standard uncertainty should be quoted to indicate the maximum possible value the decay might have. A range of 3 standard uncertainties is considered possible. Thus 0.0(1) would indicate a decay of less than 0.3% or an enhancement of less than 0.3%.

The permitted range is $-\infty \to 100$.

Examples: '0.5 (1)' (represents a decay between 0.2% and 0.8%), '-1 (1)' (the change in the standards lies between a decay of 2% and an increase of 4%), '0.0(2)' (the change in the standards lies between a decay of 0.6% and an increase of 0.6%.)

[diffrn standards]

diffrn standards interval count diffrn standards interval time

The number of reflection intensities, or the time in minutes, between the measurement of standard reflection intensities.

The permitted range is $0 \to \infty$. [diffrn standards]

diffrn standards number

The number of unique standard reflections used during the measurement of the diffraction intensities.

The permitted range is $0 \to \infty$. [diffrn standards]

diffrn standards scale sigma

This definition has been superseded and is retained here only for archival purposes. Use instead diffrn standards scale u.

The standard uncertainty (e.s.d.) of the individual mean standard scales applied to the intensity data.

The permitted range is $0.0 \rightarrow \infty$.

[diffrn standards]

diffrn standards scale u

(numb)

The standard uncertainty of the individual mean standard scales applied to the intensity data.

The permitted range is $0.0 \rightarrow \infty$.

Related item: diffrn standards scale sigma (alternate).

[diffrn standards]

EXPTL

Data items in the EXPTL category record details about the experimental work prior to the intensity measurements and details about the absorption-correction technique employed.

Example 1 – based on a paper by Steiner [Acta Cryst. (1996), C52, 2554–2556].

```
_exptl_absorpt_coefficient_mu
                                  0.962
_exptl_absorpt_correction_type
                                  psi-scan
exptl absorpt process details
         'North, Phillips & Mathews (1968)'
exptl absorpt correction T min
                                  0.929
exptl absorpt correction T max
                                  0.997
```

exptl absorpt coefficient mu

(numb)

The absorption coefficient μ in reciprocal millimetres calculated from the atomic content of the cell, the density and the radiation wavelength.

The permitted range is $0.0 \rightarrow \infty$.

[expt1]

_exptl_absorpt_correction T max exptl absorpt correction T min

(numb)

The maximum and minimum transmission factors applied to the diffraction pattern measured in this experiment. These factors are also referred to as the absorption correction A or 1/A*. As this value is the one that is applied to the measured intensities, it includes the correction for absorption by the specimen mount and diffractometer as well as by the specimen itself.

The permitted range is $0.0 \rightarrow 1.0$.

[exptl]

exptl absorpt correction type

(char)

The absorption-correction type and method. The value 'empirical' should not be used unless more detailed information is not avail-

The data value must be one of the following:

analytical analytical from crystal shape cylindrical cylinder empirical from intensities empirical gaussian Gaussian from crystal shape integration integration from crystal shape multi-scan symmetry-related measurements none no absorption correction applied numerical from crystal shape numerical psi-scan ψ -scan corrections refdelf refined from ΔF sphere spherical

[expt1]

exptl absorpt process details

Description of the absorption process applied to the intensities. A literature reference should be supplied for ψ -scan techniques.

Examples: 'Tompa analytical', 'MolEN (Fair, 1990)', '(North, Phillips & Mathews, 1968)'.

[expt1]

exptl crystals number

(numb)

The total number of crystals used for the measurement of intensi-

The permitted range is $1 \to \infty$. [expt1]

exptl special details

Any special information about the experimental work prior to the intensity measurements. See also exptl crystal preparation.

[exptl]

exptl transmission factor max

(numb, su)

The calculated maximum value of the transmission factor for the specimen. Its value does not include the effects of absorption in the specimen mount. The presence of this item does not imply that the structure factors have been corrected for absorption. The applied correction should be given by exptl absorpt correction T max.

The permitted range is $0.0 \rightarrow 1.0$.

[exptl]

exptl transmission factor min

(numb, su)

The calculated minimum value of the transmission factor for the specimen. Its value does not include the effects of absorption in the specimen mount. The presence of this item does not imply that the structure factors have been corrected for absorption. The applied correction should be given by exptl absorpt correction T min.

The permitted range is $0.0 \rightarrow 1.0$.

[exptl]

EXPTL_CRYSTAL

Data items in the EXPTL CRYSTAL category record details about experimental measurements on the crystal or crystals used, such as shape, size or density.

Example 1 - based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276-2277].

_exptl_crystal_description	prism
_exptl_crystal_colour	colourless
_exptl_crystal_size_max	0.32
_exptl_crystal_size_mid	0.27
exptl crystal size min	0.10
exptl crystal density diffrn	1.146
exptl crystal density meas	?
exptl crystal density method	'not measured'
_exptl_crystal_F_000	656

Example 2 – using separate items to define upper and lower limits for a value.

```
exptl_crystal_density_meas_gt
                                    2.5
exptl_crystal_density_meas_lt
```

Example 3 – here the density was measured at some unspecified temperature below room temperature.

exptl_crystal_density_meas_temp_lt

exptl_crystal_colour

(char)

The colour of the crystal.

May appear in list containing _exptl_crystal_id.

Related items:

exptl crystal colour lustre (alternate),

_exptl_crystal_colour_modifier (alternate),

exptl_crystal_colour_primary (alternate).

Example: 'dark green'.

[exptl_crystal]

exptl crystal colour lustre

The enumeration list of standardized names developed for the International Centre for Diffraction Data. The colour of a crystal is given by the combination of exptl crystal colour modifier with exptl crystal colour primary, as in 'dark-green' or 'bluish-violet', if necessary combined with exptl crystal colour_lustre, as in 'metallic-green'.

May appear in list containing _exptl_crystal_id.

Related item: _exptl_crystal colour (alternate).

The data value must be one of the following:

metallic

dull

clear

[exptl crystal]

```
exptl crystal colour modifier
```

The enumeration list of standardized names developed for the International Centre for Diffraction Data. The colour of a crystal is given by the combination of exptl crystal colour modifier with exptl crystal colour primary, as in 'dark-green' or 'bluish-violet', if necessary combined with _exptl_crystal_ colour lustre, as in 'metallic-green'.

```
May appear in list containing _exptl_crystal_id.
```

Related item: exptl crystal colour (alternate).

The data value must be one of the following:

light dark whitish

blackish

grayish

brownish

reddish

pinkish

orangish vellowish

greenish

bluish

[exptl crystal]

exptl crystal colour primary

The enumeration list of standardized names developed for the International Centre for Diffraction Data. The colour of a crystal is given by the combination of exptl crystal colour modifier with exptl crystal colour primary, as in 'dark-green' or 'bluish-violet', if necessary combined with exptl crystal colour lustre, as in 'metallic-green'.

May appear in list containing _exptl_crystal_id.

Related item: exptl crystal colour (alternate).

The data value must be one of the following:

colourless

white

black gray

brown

red

pink orange

yellow

green

blue

violet

[exptl crystal]

exptl crystal density diffrn

Density values calculated from the crystal cell and contents. The units are megagrams per cubic metre (grams per cubic centimetre). May appear in list containing _exptl_crystal_id.

The permitted range is $0.0 \rightarrow \infty$.

[exptl crystal]

exptl crystal density_meas

(numb, su)

Density values measured using standard chemical and physical methods. The units are megagrams per cubic metre (grams per cubic centimetre).

May appear in list containing _exptl_crystal_id.

The permitted range is $0.0 \rightarrow \infty$.

[exptl crystal]

exptl crystal density meas gt

The value above which the density measured using standard chemical and physical methods lies. The units are megagrams per cubic metre (grams per cubic centimetre). exptl crystal density_meas_gt and _exptl_crystal_density_meas_lt Should not be used to report new experimental work, for which _exptl_crystal_density_meas should be used. These items are intended for use in reporting information in existing databases and archives which would be misleading if reported under exptl crystal density meas.

May appear in list containing <code>_exptl_crystal_id</code>.

The permitted range is $0.0 \rightarrow \infty$.

Related item: _exptl_crystal_density_meas (alternate).

Example: '2.5' (lower limit for the density (only the range within which the density lies was given in the original paper)). [exptl crystal]

exptl crystal density meas lt

(numb

The value below which the density measured using standard chemical and physical methods lies. The units are megagrams per cubic metre (grams per cubic centimetre). _exptl_crystal_density_meas_gt and _exptl_crystal_density_meas_lt should not be used to report new experimental work, for which _exptl_crystal_density_meas should be used. These items are intended for use in reporting information in existing databases and archives which would be misleading if reported under exptl crystal density meas.

May appear in list containing _exptl_crystal_id.

The permitted range is $0.0 \rightarrow \infty$.

Related item: _exptl_crystal_density_meas (alternate).

Examples: '1.0' (specimen floats in water), '5.0' (upper limit for the density (only the range within which the density lies was given in the original paper)). [exptl_crystal]

exptl crystal density meas temp (numb, su)

Temperature in kelvins at which _exptl_crystal_density_meas was determined.

May appear in list containing _exptl_crystal_id.

The permitted range is $0.0 \rightarrow \infty$.

[exptl_crystal]

exptl crystal density meas temp gt (number of temp)

Temperature in kelvins above which _exptl_crystal_density_meas was determined. _exptl_crystal_density_meas_temp_gt and _exptl_crystal_density_meas_temp_lt should not be used for reporting new work, for which the correct temperature of measurement should be given. These items are intended for use in reporting information stored in databases or archives which would be misleading if reported under exptl crystal density meas temp.

May appear in list containing _exptl_crystal_id.

The permitted range is $0.0 \rightarrow \infty$.

 $Related \ item: \verb|_exptl_crystal_density_meas_temp| (alternate).$

[exptl_crystal]

exptl crystal density meas temp lt (numb)

Temperature in kelvins below which <code>_exptl_crystal_density_meas</code> was determined. <code>_exptl_crystal_density_meas_temp_gt</code> and <code>_exptl_crystal_density_meas_temp_lt</code> should not be used for reporting new work, for which the correct temperature of measurement should be given. These items are intended for use in reporting information stored in databases or archives which would be misleading if reported under <code>exptl_crystal_density_meas_temp</code>.

May appear in list containing <code>_exptl_crystal_id</code>.

The permitted range is $0.0 \to \infty$.

 $Related \ item: \verb|_exptl_crystal_density_meas_temp| (alternate).$

Example: '300' (The density was measured at some unspecified temperature below room temperature.). [exptl_crystal]

exptl crystal density method (char

The method used to measure exptl crystal_density_meas.

May appear in list containing _exptl_crystal_id.

Examples: 'flotation in aqueous KI', 'not measured',

'Berman density torsion balance'. [exptl_crystal]

exptl crystal description (char)

A description of the quality and habit of the crystal. The crystal dimensions should not normally be reported here; use instead <code>_exptl_crystal_size_</code> for the gross dimensions of the crystal and <code>_exptl_crystal_face_</code> to describe the relationship between individual faces.

May appear in list containing $\tt exptl_crystal_id$.

[exptl_crystal]

exptl crystal F 000

(numb)

The effective number of electrons in the crystal unit cell contributing to F(000). This may contain dispersion contributions and is calculated as

$$F(000) = \left[\left(\sum f_r \right)^2 + \left(\sum f_i \right)^2 \right]^{1/2},$$

where f_r = real part of the scattering factors at $\theta = 0^{\circ}$, f_i = imaginary part of the scattering factors at $\theta = 0^{\circ}$ and the sum is taken over each atom in the unit cell.

May appear in list containing exptl_crystal_id.

The permitted range is $0.0 \rightarrow \infty$.

[exptl_crystal]

exptl crystal id

(char)

Code identifying each crystal if multiple crystals are used. It is used to link with _diffrn_refln_crystal_id in the intensity measurements and with _refln_crystal_id in the _refln_ list.

Appears in list as essential element of loop structure. May match child data name(s):

_diffrn_refln_crystal_id, _refln_crystal_id. [exptl_crystal]

exptl crystal preparation

(char)

Details of crystal growth and preparation of the crystal (e.g. mounting) prior to the intensity measurements.

May appear in list containing <code>_exptl_crystal_id</code>.

Example: 'mounted in an argon-filled quartz capillary'.

[exptl crystal]

exptl crystal pressure history

(char)

Relevant details concerning the pressure history of the sample.

May appear in list containing exptl_crystal_id. [exptl_crystal]

_exptl_crystal_recrystallization_method (char) Describes the method used to recrystallize the sample. Sufficient

details should be given for the procedure to be repeated. The temperature or temperatures should be given as well as details of the solvent, flux or carrier gas with concentrations or pressures and ambient atmosphere.

[exptl_crystal]

_exptl_crystal_size_length

exptl crystal size max

exptl crystal size mid

exptl_crystal_size_min

exptl crystal size rad

(numb)

The maximum, medial and minimum dimensions in millimetres of the crystal. If the crystal is a sphere, then the *_rad item is its radius. If the crystal is a cylinder, then the *_rad item is its radius and the *_length item is its length. These may appear in a list with _exptl_crystal_id if multiple crystals are used in the experiment.

May appear in list containing _exptl_crystal_id.

The permitted range is $0.0 \to \infty$.

[exptl_crystal]

exptl crystal thermal history

(char)

Relevant details concerning the thermal history of the sample.

May appear in list containing _exptl_crystal_id.

[exptl_crystal]

EXPTL_CRYSTAL_FACE

Data items in the EXPTL CRYSTAL FACE category record details of the crystal faces.

Example 1 – based on structure PAWD2 of Vittal & Dean [Acta Cryst. (1996), C52, 1180-11821.

```
1000
exptl crystal face index h
_exptl_crystal_face index k
exptl crystal face index 1
_exptl_crystal_face_perp_dist
             -2
                    .18274
        -1
     1
          0
              -2
                     .17571
              -2
                    .17845
    -1
         1
               0
                     .21010
    -2
          1
                    .18849
    -1
         0
               2
    1
         -1
               2
                     .20605
     2
         -1
               0
                     .24680
               0
                     .19688
          2
               2
                     .15206
```

```
exptl crystal face diffr chi
exptl crystal face diffr kappa
exptl crystal face diffr phi
exptl crystal face diffr psi
```

The goniometer angle settings in degrees when the perpendicular to the specified crystal face is aligned along a specified direction (e.g. the bisector of the incident and reflected beams in an optical goniometer).

Appears in list containing _exptl_crystal_face_index_

[exptl crystal face]

```
_exptl_crystal_face_index_h
 exptl_crystal_face_index_k
 exptl_crystal_face_index_l
                                                (numb)
Miller indices of the crystal face associated with the value
```

exptl crystal face perp dist.

Appears in list as essential element of loop structure. [exptl crystal face]

```
exptl crystal face perp dist
                                             (numb)
```

The perpendicular distance in millimetres from the face to the centre of rotation of the crystal.

```
Appears in list containing _exptl_crystal_face_index_
The permitted range is 0.0 \rightarrow \infty.
                                                            [exptl_crystal_face]
```

GEOM

Data items in the GEOM and related (GEOM ANGLE, GEOM BOND, GEOM CONTACT, GEOM HBOND and GEOM TORSION) categories record details about the molecular and crystal geometry as calculated from the ATOM, CELL and SYMMETRY data. Geometry data are usually redundant, in that they can be calculated from other more fundamental quantities in the data block. However, they serve the dual purposes of providing a check on the correctness of both sets of data and of enabling the most important geometric data to be identified for publication by setting the appropriate publication flag.

Example 1 - based on data set bagan of Yamane & DiSalvo [Acta Cryst. (1996), C52, 760-761].

```
_geom_special_details
```

All esds (except the esd in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell esds are taken into account individually in the estimation of esds in distances, angles and torsion angles; correlations between esds in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell esds is used for estimating esds involving 1.s. planes.

```
geom special details
```

(char)

The description of geometrical information not covered by the existing data names in the geometry categories, such as leastsquares planes.

[geom]

GEOM_ANGLE

Data items in the GEOM ANGLE category record details about the bond angles as calculated from the ATOM, CELL and SYMMETRY

Example 1 - based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–22771.

```
_geom_angle_atom_site_label_1
_geom_angle_atom_site_label_2
geom angle atom site label 3
geom angle
geom angle site symmetry 1
_geom_angle_site_symmetry_2
_geom_angle_site_symmetry_3
_geom_angle_publ_flag
    01 C5
             111.6(2)
                      1_555 1_555 1_555
    C2 C3
             110.9(2)
                      1 555
                             1 555 1 555
                                           ves
    C2 021
            122.2(3)
                      1 555
                             1 555
                                    1 555
                                           yes
C3
    C2 O21 127.0(3)
                      1 555
                             1 555
                                    1 555
                                           ves
C2
    C3 N4
             101.3(2)
                      1 555
                             1 555
                                           yes
                                    1 555
C2
    C3 C31 111.3(2)
                      1 555
                             1 555
                                    1 555
                                           yes
                      1_555
C2
    С3 Н3
             107(1)
                             1 555
                                    1 555
N4
    C3
       C31 116.7(2)
                     1 555
                             1 555
                                    1_555
   - - - data truncated for brevity - - - -
```

geom angle

Angle in degrees defined by the three sites _geom_angle_atom_ site label 1, * 2 and * 3. The site at * 2 is at the apex of the

```
Appears in list containing _geom_angle_atom_site_label_.
                                                             [geom angle]
```

```
_geom_angle_atom_site label 1
geom angle atom site label 2
geom angle atom site label 3
```

The labels of the three atom sites which define the angle given by _geom_angle. These must match labels specified as atom site label in the atom list. Label 2 identifies the site at the apex of the angle.

Appears in list as essential element of loop structure. Must match parent data name _atom_site_label. [geom angle]

geom angle publ flag

(char)

This code signals whether the angle is referred to in a publication or should be placed in a table of significant angles.

Appears in list containing _geom_angle_atom_site_label_

The data value must be one of the following:

```
do not include angle in special list
no
n
           abbreviation for 'no
```

do include angle in special list yes Where no value is given, the assumed value is 'no'.

abbreviation for 'yes' V

[geom angle]

```
_geom_angle_site_symmetry 1
_geom_angle_site_symmetry 2
geom angle site symmetry 3
```

The symmetry code of each atom site as the symmetry-equivalent position number 'n' and the cell translation number 'klm'. These numbers are combined to form the code 'n klm' or $n \, klm$. The character string $n \, klm$ is composed as follows: n refers to the symmetry operation that is applied to the coordinates stored in atom_site_fract_x, _atom_site_fract_y and _atom_site_fract_z. It must match a number given in $_$ space $_$ group $_$ symop $_$ id. k, l and m refer to the translations that are subsequently applied to the symmetry-transformed coordinates to generate the atom used in calculating the angle. These translations (x, y, z) are related to (k, l, m) by the relations k = 5 + x,

У

l = 5 + y, m = 5 + z. By adding 5 to the translations, the use of negative numbers is avoided.

Appears in list containing _geom_angle_atom_site_label_

Examples: '.' (no symmetry or translation to site), '4' (4th symmetry operation applied), '7-645' (7th symmetry position: +a on x, -b on y). [geom_angle]

GEOM BOND

Data items in the GEOM_BOND category record details about bonds as calculated from the ATOM, CELL and SYMMETRY data.

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

```
1000
_geom_bond_atom_site_label 1
_geom_bond_atom_site_label_2
geom bond distance
geom bond site symmetry 1
geom bond site symmetry 2
geom bond publ flag
          1.342(4) 1 555 1 555
 01 C2
                                  yes
     C5
          1,439(3)
                    1 555
                          1 555
 01
                                  ves
 C2
     C3
          1.512(4)
                    1 555
                          1 555
                                  yes
 C2
     021 1.199(4)
                    1 555
                          1 555
                                  yes
 C3
     N4
          1.465(3)
                    1_555
                           1 555
     C31 1.537(4)
                    1 555
                          1 555
                                  yes
 C3
     нз
          1.00(3)
                    1 555
                          1 555
          1.472(3) 1 555 1 555
 N4
    C5
                                 yes
 - - - data truncated for brevity - - -
```

Example 2 – An example showing a listing of only symmetry-unique bonds. In high-symmetry structures when many bonds are related by symmetry, it may not be necessary or desirable to list all the bonds in the environment of the first named atom. Some users may wish to give only the symmetry-independent distances and supply a multiplicity to indicate how many such bonds are found in the atomic environment.

```
loop
_geom_bond_atom_site_label_1
_geom_bond_atom_site_label_2
_geom_bond_distance
_geom_bond_multiplicity
Ca1
      F1
           2.495(9)
           2.291(10)
Ca1
      F2
Ca1
      F2
           2.391(11)
                        2
Ca1
      F3
           2.214(11)
                        2
Cr1
      F1
           1.940(11)
Cr1
      F2
           1.918(9)
           1.848(10)
```

Example 3 — The same structure as in Example 2, but where the multiplicity is given with a full bond list. Note the use of a value of 0 for geom bond multiplicity in such a case.

```
geom_bond_atom_site_label_1
_geom_bond_atom_site_label_2
geom_bond_site_symmetry_2
geom bond distance
geom bond multiplicity
Ca1
     F1
          1 555 2.495(9)
           1 555 2.291(10)
Ca1
     F2
Ca1
     F2
           2 555
                 2,291(10)
Ca1
      F2
           3_565 2.391(11)
Ca1
      F2
           4 555
                  2.391(11)
Ca1
           2 545
                  2.214(11)
           5 555
Ca1
     F3
                  2.214(11)
Cr1
     F1
           1 555
                  1.940(11)
Cr1
     F1
           2 555
                  1.940(11)
Cr1
     F2
           1 555
                  1.918(9)
                  1.918(9)
Cr1
     F2
           2_555
                               0
Cr1
     F3
           1 555
                  1.848(10)
           2 555 1.848(10)
```

```
_geom_bond_atom_site_label_1
_geom_bond_atom_site_label_2
(char)
```

The labels of two atom sites that form a bond. These must match labels specified as atom site label in the atom list.

```
Appears in list as essential element of loop structure. Must match parent data name _atom_site_label. [geom_bond]
```

```
geom bond distance
```

(numb, su)

The intramolecular bond distance in ångströms.

Appears in list containing _geom_bond_atom_site_label_.

The permitted range is $0.0 \rightarrow \infty$.

[geom_bond]

_geom_bond_multiplicity

(numb)

The number of times the given bond appears in the environment of the atoms labelled <code>_geom_bond_atom_site_label_1</code>. In cases where the full list of bonds is given, one of the series of equivalent bonds may be assigned the appropriate multiplicity while the others are assigned a value of 0.

Appears in list containing _geom_bond_atom_site_label_.

The permitted range is $0 \to \infty$. Where no value is given, the assumed value is '1'.

[geom_bond]

geom bond publ flag

(char)

This code signals whether the bond distance is referred to in a publication or should be placed in a list of significant bond distances.

Appears in list containing _geom_bond_atom_site_label_

The data value must be one of the following:

do not include bond in special list

n abbreviation for 'no'

yes do include bond in special list

abbreviation for 'yes'

Where no value is given, the assumed value is 'no'. [geom_bond]

```
_geom_bond_site_symmetry_1
geom bond site symmetry 2
```

(char)

The symmetry code of each atom site as the symmetry-equivalent position number 'n' and the cell translation number 'klm'. These numbers are combined to form the code 'n klm' or n_klm . The character string n_klm is composed as follows: n refers to the symmetry operation that is applied to the coordinates stored in $atom_site_fract_x$, $atom_site_fract_y$ and $atom_site_fract_z$. It must match a number given in $_space_group_symop_id$. k, l and m refer to the translations that are subsequently applied to the symmetry-transformed coordinates to generate the atom used in calculating the bond. These translations (x, y, z) are related to (k, l, m) by the relations k = 5 + x, l = 5 + y, m = 5 + z. By adding 5 to the translations, the use of negative numbers is avoided.

Appears in list containing <code>_geom_bond_atom_site_label_</code>.

Examples: '.' (no symmetry or translation to site), '4' (4th symmetry operation applied),

'7_645' (7th symmetry position: +a on x, -b on y). [geom_bond]

geom bond valence

(numb)

The bond valence calculated from geom bond distance.

Appears in list containing _geom_bond_atom_site_label_. [geom_bond]

GEOM_CONTACT

Data items in the GEOM_CONTACT category record details about interatomic contacts as calculated from the ATOM, CELL and SYMMETRY data.

Example 1 – based on data set CLPHO6 of Ferguson, Ruhl, McKervey & Browne [Acta Cryst. (1992), C48, 2262–2264].

```
loop_
_geom_contact_atom_site_label_1
_geom_contact_atom_site_label_2
_geom_contact_distance
_geom_contact_site_symmetry_1
_geom_contact_site_symmetry_2
_geom_contact_publ_flag
O(1) O(2) 2.735(3) . . yes
H(01) O(2) 1.82 . . no
```

```
_geom_contact_atom_site_label_1
_geom_contact_atom_site_label_2 (char
```

The labels of two atom sites that are within contact distance. The labels must match atom site label codes in the atom list.

Appears in list as essential element of loop structure. Must match parent data name _atom_site_label. [geom_contact]

geom contact distance

(numb, su)

The interatomic contact distance in ångströms.

Appears in list containing _geom_contact_atom_site_label_.

The permitted range is $0.0 \rightarrow \infty$. [geom contact]

geom contact publ flag

(char)

This code signals whether the contact distance is referred to in a publication or should be placed in a list of significant contact distances.

Appears in list containing _geom_contact_atom_site_label_

The data value must be one of the following:

no do not include distance in special list

n abbreviation for 'no'

yes do include distance in special list

y abbreviation for 'yes'

Where no value is given, the assumed value is 'no'.

[geom contact]

```
_geom_contact_site_symmetry_1
geom contact site symmetry 2
```

(char)

The symmetry code of each atom site as the symmetry-equivalent position number 'n' and the cell translation number 'klm'. These numbers are combined to form the code 'n klm' or n_{l} klm. The character string n_{l} klm is composed as follows: n_{l} refers to the symmetry operation that is applied to the coordinates stored in $_{l}$ atom_site_fract_x, _atom_site_fract_y and _atom_site_fract_z. It must match a number given in _space_group_symop_id. k, l and m refer to the translations that are subsequently applied to the symmetry-transformed coordinates to generate the atom used in calculating the contact. These translations (x, y, z) are related to (k, l, m) by the relations k = 5 + x, l = 5 + y, m = 5 + z. By adding 5 to the translations, the use of negative numbers is avoided.

Appears in list containing _geom_contact_atom_site_label_.

Examples: '.' (no symmetry or translation to site), '4' (4th symmetry operation applied),

'7_645' (7th symmetry position: +a on x, -b on y). [geom_contact]

GEOM_HBOND

Data items in the GEOM_HBOND category record details about hydrogen bonds as calculated from the ATOM, CELL and SYMMETRY data.

Example 1 – based on $C_{14}H_{13}ClN_2O.H_2O$, reported by Palmer, Puddle & Lisgarten [Acta Cryst. (1993), C49, 1777–1779].

```
loop_
geom hbond atom site label D
geom hbond atom site label H
geom hbond atom site label A
_geom_hbond_distance_DH
_geom_hbond_distance_HA
geom hbond distance DA
_geom_hbond_angle_DHA
geom_hbond_publ_flag
N6
    HN6
         OW
               0.888(8)
                        1.921(12)
                                   2.801(8)
                                              169.6(8)
                                                        yes
OW
    HO2
         07
               0.917(6)
                        1.923(12)
                                    2.793(8)
                                              153.5(8)
                                                        yes
OW
    HO1
         N10 0.894(8) 1.886(11) 2.842(8) 179.7(9)
                                                        yes
```

geom hbond angle DHA

(numb, su)

Angle in degrees defined by the three sites <code>_geom_hbond_atom_</code> site_label_D, *_H and *_A. The site at *_H (the hydrogen atom participating in the interaction) is at the apex of the angle.

Appears in list containing geom hbond atom site label. [geom hbond]

```
_geom_hbond_atom_site_label_D
_geom_hbond_atom_site_label_H
geom_hbond_atom_site_label_A
```

The labels of three atom sites (respectively, the donor atom, hydrogen atom and acceptor atom) participating in a hydrogen bond. These must match labels specified as <code>_atom_site_label</code> in the atom list.

```
Appears in list as essential element of loop structure. Must match parent data name _atom_site_label. [geom_hbond]
```

```
_geom_hbond_distance_DH
_geom_hbond_distance_HA
_geom_hbond_distance_DA
```

(numb, su)

Distances in ångströms between the donor and hydrogen (*_DH), hydrogen and acceptor (*_HA) and donor and acceptor (*_DA) sites in a hydrogen bond.

```
Appears in list containing geom_hbond_atom_site_label_. The permitted range is 0.0 \to \infty. [geom_hbond]
```

geom hbond publ flag

(char)

This code signals whether the hydrogen-bond information is referred to in a publication or should be placed in a table of significant hydrogen-bond geometry.

```
Appears in \ list \ containing \ \_\texttt{geom\_hbond\_atom\_site\_label\_}.
```

```
The data value must be one of the following:

no do not include bond in special list

n abbreviation for 'no'

yes do include bond in special list

y abbreviation for 'yes'
```

Where no value is given, the assumed value is 'no'.

[geom hbond]

(char)

```
_geom_hbond_site_symmetry_D
_geom_hbond_site_symmetry_H
_geom_hbond_site_symmetry_A
```

The symmetry code of each atom site as the symmetry-equivalent position number 'n' and the cell translation number 'klm'. These numbers are combined to form the code 'n klm' or n_klm . The character string n_klm is composed as follows: n refers to the symmetry operation that is applied to the coordinates stored in $_atom_site_fract_x$, $_atom_site_fract_y$ and $_atom_site_fract_z$. It must match a number given in $_space_group_symop_id$. k, l and m refer to the translations that are subsequently applied to the symmetry-transformed coordinates to generate the atom used in calculating the hydrogen bond. These translations (x, y, z) are related to (k, l, m) by the relations k = 5 + x, l = 5 + y, m = 5 + z. By adding 5 to the translations, the use of negative numbers is avoided.

```
Appears in list containing geom_hbond_atom_site_label_. Examples: '.' (no symmetry or translation to site), '4' (4th symmetry operation applied), '7_645' (7th symmetry position: +a on x, -b on y). [geom_hbond]
```

GEOM_TORSION

Data items in the GEOM_TORSION category record details about interatomic torsion angles as calculated from the ATOM, CELL and SYMMETRY data.

```
Example 1 – based on data set CLPHO6 of Ferguson, Ruhl, McKervey & Browne [Acta Cryst. (1992), C48, 2262–2264].
```

```
100p
_geom_torsion_atom_site_label_1
_geom_torsion_atom_site_label_2
_geom_torsion_atom_site_label_3
 geom torsion atom site label 4
_geom_torsion
 geom torsion site symmetry 1
geom torsion site symmetry 2
 geom torsion site symmetry 3
 _geom_torsion_site_symmetry_4
 _geom_torsion_publ_flag
C(9)
     O(2) C(7)
                            71.8(2)
                    C(2)
C(7)
      0(2)
             C(9)
                    C(10) -168.0(3)
                                               2 666
                                                      yes
C(10) O(3)
             C(8)
                    C(6)
                          -167.7(3)
                                                      yes
                           -69.7(2)
                                               2_666
C(8) O(3)
             C(10)
                    C(9)
                                                      yes
0(1)
                    C(3)
                          -179.5(4)
      C(1)
             C(2)
                                                      no
0(1)
     C(1)
            C(2)
                    C(7)
                            -0.6(1)
                                                      no
```

geom torsion

(numb, su)

The torsion angle in degrees bounded by the four atom sites identified by the _geom_torsion_atom_site_label_ codes. These must match labels specified as _atom_site_label in the atom list. The torsion-angle definition should be that of Klyne and Prelog.

Reference: Klyne, W. & Prelog, V. (1960). Experientia, 16, 521-523.

Appears in list containing _geom_torsion_atom_site_label_. [geom_torsion]

```
_geom_torsion atom site label 1
geom torsion atom site label 2
geom torsion atom site label 3
geom torsion atom site label 4
```

The labels of the four atom sites which define the torsion angle specified by geom torsion. These must match codes specified as atom site label in the atom list. The torsion-angle definition should be that of Klyne and Prelog. The vector direction *_label_2 to *_label_3 is the viewing direction, and the torsion angle is the angle of twist required to superimpose the projection of the vector between site 2 and site 1 onto the projection of the vector between site 3 and site 4. Clockwise torsions are positive, anticlockwise torsions are negative.

Reference: Klyne, W. & Prelog, V. (1960). Experientia, 16, 521-523.

Appears in list as essential element of loop structure. Must match parent data name atom site label. [geom torsion]

geom torsion publ flag

This code signals whether the torsion angle is referred to in a publication or should be placed in a table of significant torsion angles.

Appears in list containing _geom_torsion_atom_site_label_.

The data value must be one of the following:

do not include angle in special list no abbreviation for 'no' do include angle in special list yes abbreviation for 'yes'

Where no value is given, the assumed value is 'no'.

[geom torsion]

```
geom torsion site symmetry 1
geom torsion site symmetry 2
geom torsion site symmetry 3
geom torsion site symmetry 4
```

The symmetry code of each atom site as the symmetry-equivalent position number 'n' and the cell translation number 'klm'. These numbers are combined to form the code 'n klm' or n klm. The character string n klm is composed as follows: n refers to the symmetry operation that is applied to the coordinates stored in _atom_site_fract_x, _atom_site_fract_y and _atom_site_fract_z. It must match a number given in space group symop id. k, l and m refer to the translations that are subsequently applied to the symmetry-transformed coordinates to generate the atom used in calculating the angle. These translations (x, y, z) are related to (k, l, m) by the relations k = 5 + x, l = 5 + y, m = 5 + z. By adding 5 to the translations, the use of negative numbers is avoided.

Appears in list containing _geom_torsion_atom_site_label_.

Examples: '.' (no symmetry or translation to site), '4' (4th symmetry operation applied),

```
'7_645' (7th symmetry position: +a on x, -b on y).
                                                                 [geom torsion]
```

JOURNAL

Data items in the JOURNAL category record details about the book-keeping by the journal staff when processing a CIF submitted for publication. The creator of a CIF will not normally specify these data items. The data names are not defined in the dictionary because they are for journal use only.

```
Example 1 - based on Acta Cryst. file for entry HL0007 [Willis, Beckwith & Tozer
(1991). Acta Cryst. C47, 2276-22771.
```

```
_journal_date_recd_electronic
                                91-04-15
journal date from coeditor
                                91-04-18
91-04-18
journal date printers first
journal date proofs out
                                91-08-07
iournal coeditor code
                                HL0007
journal techeditor code
                                C910963
_journal_coden_ASTM
                                ACSCEE
_journal_name_full
                         'Acta Crystallographica Section C'
_journal_year
                                1991
_journal_volume
journal issue
                                NOV91
iournal page first
                                2276
                                2277
_journal_page_last
```

```
journal coden ASTM
journal coden Cambridge
journal coeditor address
journal coeditor code
journal coeditor email
journal coeditor fax
journal coeditor name
_journal_coeditor notes
_journal_coeditor_phone
_journal_data_validation number
_journal_date_accepted
_journal_date_from_coeditor
_journal_date_to_coeditor
journal_date_printers_final
_journal_date_printers first
journal date proofs in
journal date proofs out
_journal_date_recd copyright
_journal_date recd electronic
journal date recd hard copy
_journal_issue
_journal_language
_journal_name_full
_journal_page_first
_journal_page last
journal paper category
_journal_paper_doi
journal_suppl_publ_number
journal suppl publ pages
journal techeditor address
_journal_techeditor code
_journal_techeditor email
_journal_techeditor_fax
_journal_techeditor name
_journal_techeditor notes
_journal_techeditor phone
_journal_volume
journal year
                                            (char)
Data items specified by the journal staff.
```

[journal]

JOURNAL_INDEX

Data items in the JOURNAL INDEX category are used to list terms used to generate the journal indexes. The creator of a CIF will not normally specify these data items.

4. DATA DICTIONARIES

```
_journal_index_subterm
_journal_index_term
_journal_index_type (char)
Indexing terms supplied by the journal staff.
```

[journal index]

PUBL

Data items in the PUBL category are used when submitting a manuscript for publication. They refer either to the paper as a whole, or to specific named elements within a paper (such as the title and abstract, or the *Comment* and *Experimental* sections of *Acta Crystallographica Section C*). The data items in the PUBL_BODY category should be used for the text of other submissions. Typically, each journal will supply a list of the specific items it requires in its *Notes for Authors*.

Example 1 – based on Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

```
_publ_section_title
; trans-3-Benzoyl-2-(tert-butyl)-4-(iso-butyl)-
1,3-oxazolidin-5-one
;

_publ_section_abstract
; The oxazolidinone ring is a shallow envelope
    conformation with the tert-butyl and iso-butyl groups
    occupying trans-positions with respect to the ring. The
    angles at the N atom sum to 356.2\%, indicating a very
    small degree of pyramidalization at this atom. This is
    consistent with electron delocalization between the N
    atom and the carbonyl centre [N-C=O = 1.374(3)\%A].

There is 2 for the Column Column Column Detail Advanced

The column Column Co
```

Example 2 – based on $C_{31}H_{48}N_4O_4$, reported by Coleman, Patrick, Andersen & Rettig [Acta Cryst. (1996), C52, 1525–1527].

```
_publ_section_title
; Hemiasterlin methyl ester
;

_publ_section_title_footnote
; IUPAC name: methyl 2,5-dimethyl-4-2-[3-methyl-2-methylamino-3-(N-methylbenzo[b]pyrrol-3-yl)butanamido]-3,3-dimethyl-N-methyl-butanamido-2-hexenoate.
;
```

publ contact author

(char)

The name and address of the author submitting the manuscript and data block. This is the person contacted by the journal editorial staff. It is preferable to use the separate data items_publ_contact_author_name and _publ_contact_author_address.

```
Example:
```

```
Example:
; Professor George Ferguson
Department of Chemistry and Biochemistry
University of Guelph
Ontario
Canada
N1G 2W1
```

publ contact author address

(char)

The address of the author submitting the manuscript and data block. This is the person contacted by the journal editorial staff.

```
Example:
```

```
; Department of Chemistry and Biochemistry
University of Guelph
Ontario
Canada
N1G 2W1
; [publ]
```

publ contact author email

(char)

E-mail address in a form recognizable to international networks. The format of e-mail addresses is given in Section 3.4, *Address Specification*, of *Internet Message Format*, RFC 2822, P. Resnick (Editor), Network Standards Group, April 2001.

Examples: 'name@host.domain.country', 'bm@iucr.org'. [publ]

_publ_contact_author_fax

(char)

Facsimile telephone number of the author submitting the manuscript and data block. The recommended style is the international dialing prefix, followed by the area code in parentheses, followed by the local number with no spaces. The earlier convention of including the international dialing prefix in parentheses is no longer recommended.

Examples: '12 (34) 9477334', '12 () 349477334'. [publ]

publ contact author id iucr

(char)

Identifier in the IUCr contact database of the author submitting the manuscript and data block. This identifier may be available from the *World Directory of Crystallographers* (http://wdc.iucr.org).

Example: '2985'. [pub1]

_publ_contact_author_name

(char)

The name of the author submitting the manuscript and data block. This is the person contacted by the journal editorial staff.

Example: 'Professor George Ferguson'. [publ]

_publ_contact_author_phone

(char)

Telephone number of the author submitting the manuscript and data block. The recommended style is the international dialing pre-fix, followed by the area code in parentheses, followed by the local number and any extension number prefixed by 'x', with no spaces. The earlier convention of including the international dialing prefix in parentheses is no longer recommended.

Examples: '12 (34) 9477330', '12 () 349477330', '12 (34) 9477330x5543'.

[publ]

publ contact letter

(char)

A letter submitted to the journal editor by the contact author.

[publ]

_publ_manuscript_creation

(char)

A description of the word-processor package and computer used to create the word-processed manuscript stored as _publ_manuscript processed.

Example: 'Tex file created by FrameMaker on a Sun 3/280'. [publ]

_publ_manuscript_processed

(char)

The full manuscript of a paper (excluding possibly the figures and the tables) output in ASCII characters from a word processor. Information about the generation of this data item must be specified in the data item _publ_manuscript_creation.

[publ]

publ manuscript text

(char)

The full manuscript of a paper (excluding figures and possibly the tables) output as standard ASCII text.

[publ]

[publ]

publ requested category

(cho

The category of paper submitted. For submission to *Acta Crystallographica Section C* or *Acta Crystallographica Section E*, *only* the codes indicated for use with these journals should be used.

The data value must be one of the following:

```
FΑ
           Full article
FΤ
           Full submission – inorganic (Acta C)
FO
           Full submission – organic (Acta C)
FΜ
           Full submission – metal-organic (Acta C)
CT
           CIF-access paper – inorganic (Acta C) (no longer in use)
           CIF-access paper – organic (Acta C) (no longer in use)
CO
           CIF-access paper – metal-organic (Acta C) (no longer in use)
CM
           Electronic submission – inorganic (Acta E)
EI
ΕO
           Electronic submission – organic (Acta E)
ΕM
           Electronic submission - metal-organic (Acta E)
OI
           Inorganic compounds (Acta E)
           Organic compounds (Acta E)
00
QM
           Metal-organic compounds (Acta E)
ΑD
           Addenda and Errata (Acta C, Acta E)
SC
           Short communication
```

Where no value is given, the assumed value is 'FA'.

_publ_requested_coeditor_name

The name of the co-editor whom the authors would like to handle the submitted manuscript.

[publ]

[publ]

publ requested journal

The name of the journal to which the manuscript is being submitted.

[publ]

(char)

```
publ section title
publ section title footnote
publ section synopsis
publ section abstract
publ section comment
publ section introduction
_publ_section_experimental
_publ_section_exptl_prep
_publ_section_exptl_refinement
_publ_section exptl solution
publ section discussion
publ section acknowledgements
publ section references
publ section related literature
publ section figure captions
publ section table legends
publ section keywords
```

The sections of a manuscript if submitted in parts. As an alternative, see _publ_manuscript_text and _publ_manuscript_ processed. The _publ_section_exptl_prep, _publ_section_exptl_refinement and _publ_section_exptl_solution items are preferred for separating the chemical preparation, refinement and structure solution aspects of the experimental description.

```
[publ]
```

PUBL_AUTHOR

Data items in the PUBL_AUTHOR category record details of the authors of a manuscript submitted for publication.

```
Example 1 - based on Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276-2277].

loop_
_publ_author_name
_publ_author_address

'Willis, Anthony C.'
; Research School of Chemistry
Australian National University
GPO Box 4
Canberra, ACT
Australia 2601
;
```

publ author address

May appear in list containing _publ_author_name.

(char

The address of a publication author. If there is more than one author, this will be looped with publ author name.

```
Example:

; Department
Institute
Street
City and postcode
COUNTRY
; [publ_author]
```

publ author email

(char

The e-mail address of a publication author. If there is more than one author, this will be looped with <code>_publ_author_name</code>. The format of e-mail addresses is given in Section 3.4, *Address Specification*, of *Internet Message Format*, RFC 2822, P. Resnick (Editor), Network Standards Group, April 2001.

```
May appear in list containing _publ_author_name.

Examples: 'name@host.domain.country', 'bm@iucr.org'.
```

_publ_author footnote

(char)

[publ_author]

A footnote accompanying an author's name in the list of authors of a paper. Typically indicates sabbatical address, additional affiliations or date of decease.

```
May appear in list containing _publ_author_name.

Examples: 'On leave from U. Western Australia',

'Also at Department of Biophysics'. [publ_author]
```

_publ_author_id_iucr

(char)

Identifier in the IUCr contact database of a publication author. This identifier may be available from the *World Directory of Crystallographers* (http://wdc.iucr.org).

```
May appear in list.

Example: '2985'. [publ_author]
```

publ author name

(char

The name of a publication author. If there are multiple authors, this will be looped with <code>_publ_author_address</code>. The family name(s), followed by a comma and including any dynastic components, precedes the first names or initials.

```
May appear in list as essential element of loop structure.
```

```
Examples: 'Bleary, Percival R.', 'O'Neil, F.K.', 'Van den Bossche, G.', 'Yang, D.-L.', 'Simonov, Yu.A.', 'M\"uller, H.A.', 'Ross II, C.R.'.
```

[publ_author]

PUBL_BODY

Data items in the PUBL_BODY category permit the labelling of different text sections within the body of a paper. Note that these should not be used in a paper which has a standard format with sections tagged by specific data names (such as in *Acta Crystallographica Section C*). Typically, each journal will supply a list of the specific items it requires in its *Notes for Authors*.

Example 1 – based on a paper by R. Restori & D. Schwarzenbach [Acta Cryst. (1996), A52, 369–378].

```
loop
_publ_body_element
_publ_body_label
_publ_body_title
_publ_body_format
publ body contents
                                                            cif
     section 1
                          Introduction
; X-ray diffraction from a crystalline material provides
  information on the thermally and spatially averaged
  electron density in the crystal...
                          Theory
     section
                                                             tex
; In the rigid-atom approximation, the dynamic electron
 density of an atom is described by the convolution
 product of the static atomic density and a probability
  density function,
  \rho = \rho (\beta r) = \rho (\beta r) * P(\beta r) . \geq (1)
Example 2 – based on a paper by R. J. Papoular, Y. Vekhter & P. Coppens [Acta
Cryst. (1996), A52, 397-407].
loop_
publ body element
_publ_body_label
_publ_body_title
_publ_body_contents
```

```
section 3
; The two-channel method for retrieval of the deformation electron density
;
.
. subsection 3.1 'The two-channel entropy S[\D\r(r)]'; As the wide dynamic range involved in the total electron density...
;
subsection 3.2
'Uniform vs informative prior model densities'
subsubsection 3.2.1 'Use of uniform models'
; Straightforward algebra leads to expressions analogous to...
```

_publ_body_contents

(char)

A text section of a paper.

Appears in list containing _publ_body_label. [publ_body]

publ body element

(char)

The functional role of the associated text section.

```
Appears in list containing _publ_body_label.
```

The data value must be one of the following:

```
section
subsection
subsubsection
appendix
footnote
```

[publ_body]

```
publ body format
```

(char)

Code indicating the appropriate typesetting conventions for accented characters and special symbols in the text section.

```
Appears in list containing publ body label.
The data value must be one of the following:
            no coding for special symbols
  ascii
            CIF convention
  cif
  latex
            LaTeX
            Rich Text Format
  rtf
  sgml
            SGML (ISO 8879)
            TeX
  t.ex
  troff
            troff or nroff
```

Where no value is given, the assumed value is 'cif'.

[publ body]

_publ_body_label

(char)

Code identifying the section of text. The combination of this with publ body element must be unique.

Appears in list as essential element of loop structure.

```
Examples: '1', '1.1', '2.1.3'. [publ_body]
```

publ body title

(char)

Title of the associated section of text.

Appears in list containing _publ_body_label. [publ_body]

PUBL MANUSCRIPT INCL

Data items in the PUBL_MANUSCRIPT_INCL category allow the authors of a manuscript submitted for publication to list data names that should be added to the standard request list used by the journal printing software. Although these fields are primarily intended to identify CIF data items that the author wishes to include in a published paper, they can also be used to identify data names created so that non-CIF items can be included in the publication. Note that *_item names must be enclosed in single quotes.

Example ${\it I}$ – directive to include a hydrogen-bonding table, including cosmetic headings in comments.

```
publ manuscript incl extra item
publ_manuscript_incl_extra info
_publ_manuscript_incl_extra_defn
# Include Hydrogen Bonding Geometry Description
                                    explanation
 Name
                                                   standard?
  '_geom_hbond_atom_site_label_D'
                                    'H-bond donor'
                                                       ves
                                                       yes
   geom_hbond_atom_site_label_H'
                                    'H-bond hydrogen'
   _geom_hbond_atom_site_label_A'
                                    'H-bond acceptor'
                                                       yes
                                                       yes
   _geom_hbond_distance_DH'
                                    'H-bond D-H'
   _geom_hbond_distance_HA'
                                    'H-bond H...A'
                                                       yes
   geom hbond distance DA'
                                    'H-bond D...A'
                                                       yes
  '_geom_hbond_angle_DHA'
                                    'H-bond D-H...A'
                                                       yes
```

Example 2 – hypothetical example including both standard CIF data items and a non-CIF quantity which the author wishes to list.

```
publ_manuscript_incl_extra_item
publ_manuscript_incl_extra_info
publ_manuscript_incl_extra_defn
'_atom_site_symmetry_multiplicity'
    'to emphasise special sites' yes
'_chemical_compound_source'
    'rare material, unusual source' yes
'_reflns_d_resolution_high'
    'limited data is a problem here' yes
'_crystal_magnetic_permeability'
    'unusual value for this material' no
```

(char)

publ manuscript incl extra defn

Flags whether the corresponding data item marked for inclusion in a journal request list is a standard CIF definition or not.

Appears in list containing _publ_manuscript_incl_extra_item.

The data value must be one of the following:

no not a standard CIF data name
n abbreviation for 'no'
yes a standard CIF data name
y abbreviation for 'yes'

Where no value is given, the assumed value is 'yes'. [publ_manuscript_incl]

publ manuscript incl extra info

A short note indicating the reason why the author wishes the corresponding data item marked for inclusion in the journal request list to be published.

Appears in list containing _publ_manuscript_incl_extra_item.

[publ_manuscript_incl]

_publ_manuscript_incl_extra_item

Specifies the inclusion of specific data into a manuscript which are not normally requested by the journal. The values of this item are the extra data names (which *must* be enclosed in single quotes) that will be added to the journal request list.

Appears in list as essential element of loop structure.

[publ manuscript incl]

REFINE

Data items in the REFINE category record details about the structure-refinement parameters.

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

```
refine special details
                            sfls: F calc weight full matrix
_refine_ls_structure_factor_coef
refine ls matrix type
                                    full
refine_ls_weighting_scheme
                                   calc
refine ls weighting details
                                   'w=1/(u^2^(F)+0.0004F^2^)'
refine ls hydrogen treatment
                                   refxvz
                                   Zachariasen
refine ls extinction method
refine ls extinction coef
                                   3514 (42)
_refine_ls_extinction_expression
; Larson, A. C. (1970). "Crystallographic Computing", edited
 by F. R. Ahmed. Eq. (22) p. 292. Copenhagen: Munksgaard.
refine ls abs structure details
; The absolute configuration was assigned to agree with that
 of its precursor 1-leucine at the chiral centre C3.
_refine_ls_number_reflns
                                   1408
_refine_ls_number_parameters
                                   272
_refine_ls_number_restraints
                                   0
refine ls number constraints
refine ls R factor all
                                    .038
refine ls R factor qt
                                    .034
_refine_ls_wR_factor_all
                                    .044
refine ls wR factor gt
                                    . 042
_refine_ls_goodness_of_fit_all
                                  1.462
refine_ls_goodness_of_fit_gt
                                  1.515
refine_ls_shift/su_max
                                    .535
refine ls shift/su mean
                                   .044
refine diff density min
                                   -.108
_refine_diff_density_max
                                    .131
```

```
_refine_diff_density_max
_refine_diff_density_min
refine_diff_density_rms
```

(numb, su)

The largest and smallest values and the root-mean-square deviation, in electrons per ångström cubed, of the final difference electron density. The *_rms value is measured with respect to the arithmetic mean density and is derived from summations over each grid point in the asymmetric unit of the cell. This quantity is useful for assessing the significance of *_min and *_max values, and also for defining suitable contour levels.

refine ls abs structure details

(char)

The nature of the absolute structure and how it was determined.

[refine]

refine ls abs structure Flack

(numb, su)

The measure of absolute structure as defined by Flack (1983). For centrosymmetric structures, the only permitted value, if the data name is present, is 'inapplicable', represented by '.'. For noncentrosymmetric structures, the value must lie in the 99.97% Gaussian confidence interval $-3u \le x \le 1 + 3u$ and a standard uncertainty (e.s.d.) u must be supplied. The <code>_enumeration_range</code> of $0.0 \rightarrow 1.0$ is correctly interpreted as meaning $(0.0-3u) \le x \le (1.0+3u)$.

Reference: Flack, H. D. (1983). Acta Cryst. A39, 876–881.

The permitted range is $0.0 \rightarrow 1.0$.

[refine]

refine ls abs structure Rogers

(numb, su)

The measure of absolute structure as defined by Rogers (1981). The value must lie in the 99.97% Gaussian confidence interval $-1 - 3u \le \eta \le 1 + 3u$ and a standard uncertainty (e.s.d.) u must be supplied. The _enumeration_range of $-1.0 \to 1.0$ is correctly interpreted as meaning $(-1.0 - 3u) \le \eta \le (1.0 + 3u)$.

Reference: Rogers, D. (1981). Acta Cryst. A37, 734–741. The permitted range is $-1.0 \rightarrow 1.0$. [refine]

refine ls d res high

(numb)

The smallest value in ångströms of the interplanar spacings of the reflections used in the refinement. This is called the highest resolution

The permitted range is $0.0 \rightarrow \infty$.

[refine]

refine ls d res low

(numb)

The largest value in ångströms of the interplanar spacings of the reflections used in the refinement. This is called the lowest resolution.

The permitted range is $0.0 \rightarrow \infty$.

[refine]

refine_ls_extinction_coef

(numb, su)

The extinction coefficient used to calculate the correction factor applied to the structure-factor data. The nature of the extinction coefficient is given in the definitions of <code>_refine_ls_extinction_expression</code> and <code>_refine_ls_extinction_method</code>. For the 'Zachariasen' method it is the r^* value; for the 'Becker–Coppens type 1 isotropic' method it is the 'g' value and for 'Becker–Coppens type 2 isotropic' corrections it is the ' ρ ' value. Note that the magnitude of these values is usually of the order of $10\,000$.

References: Becker, P. J. & Coppens, P. (1974). *Acta Cryst.* A**30**, 129–147, 148–153. Zachariasen, W. H. (1967). *Acta Cryst.* **23**, 558–564. Larson, A. C. (1967). *Acta Cryst.* **23**, 664–665.

Example: '3472 (52)' (Zachariasen coefficient $r^* = 0.347(5)$ E04).

[refine]

refine ls extinction expression

(char)

A description of or reference to the extinction-correction equation used to apply the data item <code>_refine_ls_extinction_coef</code>. This information must be sufficient to reproduce the extinction-correction factors applied to the structure factors.

Example:

```
; Larson, A. C. (1970). "Crystallographic Computing", edited by F. R. Ahmed. Eq. (22), p. 292. Copenhagen: Munksquard.
```

[refine]

[refine]

refine ls extinction method

A description of the extinction-correction method applied. This description should include information about the correction method, either 'Becker-Coppens' or 'Zachariasen'. The latter is sometimes referred to as the 'Larson' method even though it employs Zachariasen's formula. The Becker-Coppens procedure is referred to as 'type 1' when correcting secondary extinction dominated by the mosaic spread; as 'type 2' when secondary extinction is dominated by particle size and includes a primary extinction component; and as 'mixed' when there is a mixture of types 1 and 2. For the Becker-Coppens method, it is also necessary to set the mosaic distribution as either 'Gaussian' or 'Lorentzian' and the nature of the extinction as 'isotropic' or 'anisotropic'. Note that if either the 'mixed' or 'anisotropic' corrections are applied, the multiple coefficients cannot be contained in * extinction coef and must be listed in _refine_special_details.

References: Becker, P. J. & Coppens, P. (1974). Acta Cryst. A30, 129-147, 148-153. Zachariasen, W. H. (1967). Acta Cryst. 23, 558–564. Larson, A. C. (1967). *Acta Cryst.* **23**, 664–665.

Where no value is given, the assumed value is 'Zachariasen'

Examples: 'B-C type 2 Gaussian isotropic', 'none'. [refine]

refine ls F calc details

(char)

Details concerning the evaluation of the structure factors using the expression given in refine 1s F calc formula.

Examples: 'Gaussian integration using 16 points', Bessel functions expansion up to 5th order. Bessel functions estimated accuracy: better than 0.001 electrons.

[refine]

refine ls F calc formula

Analytical expression used to calculate the structure factors.

[refine]

(char)

(numb)

_refine_ls_F_calc_precision

This item gives an estimate of the precision resulting from the numerical approximations made during the evaluation of the structure factors using the expression given in refine 1s F calc formula following the method outlined in _refine_ls_F_calc_details. For X-ray diffraction the result is given in electrons.

The permitted range is $0.0 \rightarrow \infty$. [refine]

refine ls goodness of fit all

The least-squares goodness-of-fit parameter S for all reflections after the final cycle of refinement. Ideally, account should be taken of parameters restrained in the least-squares refinement. See also refine 1s restrained S definitions.

$$S = \left(\frac{\sum |w|Y_{\text{obs}} - Y_{\text{calc}}|^2}{N_{\text{ref}} - N_{\text{param}}}\right)^{1/2},$$

where $Y_{\rm obs}$ = the observed coefficients (see _refine_ls_ $structure_factor_coef$), Y_{calc} = the calculated coefficients (see $_{refine_ls_structure_factor_coef}$, w = the least-squaresreflection weight $(1/u^2)$, u = the standard uncertainty, $N_{\text{ref}} =$ the number of reflections used in the refinement, N_{param} = the number of refined parameters and the sum is taken over the specified reflections.

The permitted range is $0.0 \to \infty$. [refine]

refine ls goodness of fit gt

The least-squares goodness-of-fit parameter S for significantly intense reflections (see reflns threshold expression) after the final cycle of refinement. Ideally, account should be taken of parameters restrained in the least-squares refinement. See also _refine_ls_restrained_S_ definitions.

$$S = \left(\frac{\sum |w|Y_{\text{obs}} - Y_{\text{calc}}|^2|}{N_{\text{ref}} - N_{\text{param}}}\right)^{1/2},$$

where $Y_{\rm obs}$ = the observed coefficients (see refine 1s $structure_factor_coef$), Y_{calc} = the calculated coefficients (see $_{\tt refine_ls_structure_factor_coef)}$, w = the least-squaresreflection weight $(1/u^2)$, u = the standard uncertainty, $N_{\text{ref}} =$ the number of reflections used in the refinement, N_{param} = the number of refined parameters; the sum is taken over the specified reflec-

The permitted range is $0.0 \rightarrow \infty$.

Related item: refine 1s goodness of fit obs (alternate). [refine]

refine ls goodness of fit obs (numb, su)

This definition has been superseded and is retained here only for archival purposes. Use instead _refine_ls_goodness_of_fit_gt.

The least-squares goodness-of-fit parameter S for observed reflections (see reflns observed criterion) after the final cycle of refinement. Ideally, account should be taken of parameters restrained in the leastsquares refinement. See also _refine_ls_restrained_S_ definitions.

$$S = \left(\frac{\sum \left| w | Y_{\text{obs}} - Y_{\text{calc}}|^2 \right|}{N_{\text{ref}} - N_{\text{param}}}\right)^{1/2},$$

where Y_{obs} = the observed coefficients (see refine 1s structure factor coef), Y_{calc} = the calculated coefficients (see refine 1s structure factor coef), w = the least-squares reflection weight $(1/u^2)$, u = the standard uncertainty, $N_{ref} = the$ number of reflections used in the refinement, N_{param} = the number of refined parameters; the sum is taken over the specified reflections.

The permitted range is $0.0 \rightarrow \infty$.

[refine]

refine ls goodness of fit ref

The least-squares goodness-of-fit parameter S for all reflections included in the refinement after the final cycle of refinement. Ideally, account should be taken of parameters restrained in the leastsquares refinement. See also refine 1s restrained S definitions.

$$S = \left(\frac{\sum |w|Y_{\text{obs}} - Y_{\text{calc}}|^2}{N_{\text{ref}} - N_{\text{param}}}\right)^{1/2},$$

where $Y_{\rm obs}$ = the observed coefficients (see _refine_ls_ $structure_factor_coef$), Y_{calc} = the calculated coefficients (see $_{\text{refine_ls_structure_factor_coef}}$, w = the least-squaresreflection weight $(1/u^2)$, u = the standard uncertainty, $N_{\text{ref}} =$ the number of reflections used in the refinement, N_{param} = the number of refined parameters; the sum is taken over the specified reflec-

The permitted range is $0.0 \rightarrow \infty$.

[refine]

(char)

refine ls hydrogen treatment

Treatment of hydrogen atoms in the least-squares refinement.

The data value must be one of the following:

refall refined all H-atom parameters refxyz refined H-atom coordinates only refU refined H-atom U's only noref no refinement of H-atom parameters H-atom parameters constrained constr mixed some constrained, some independent undef H-atom parameters not defined

Where no value is given, the assumed value is 'undef'.

[refine]

refine ls matrix type

Type of matrix used to accumulate the least-squares derivatives. The data value must be one of the following:

full full

fullcycle full with fixed elements per cycle atomblock block diagonal per atom

userblock user-defined blocks
diagonal elements only
sparse selected elements only

Where no value is given, the assumed value is 'full'.

[refine]

(numb)

refine ls number constraints

The number of constrained (non-refined or dependent) parameters in the least-squares process. These may be due to symmetry or any other constraint process (e.g. rigid-body refinement). See also _atom_site_constraints and _atom_site_refinement_flags. A general description of constraints may appear in _refine_special_details.

The permitted range is $0 \to \infty$. Where no value is given, the assumed value is '0'.

[refine]

refine ls number parameters

(numb)

The number of parameters refined in the least-squares process. If possible, this number should include some contribution from the restrained parameters. The restrained parameters are distinct from the constrained parameters (where one or more parameters are linearly dependent on the refined value of another). Least-squares restraints often depend on geometry or energy considerations and this makes their direct contribution to this number, and to the goodness-of-fit calculation, difficult to assess.

The permitted range is $0 \to \infty$. [refine]

refine ls number reflns

(numb)

The number of unique reflections contributing to the least-squares refinement calculation.

The permitted range is $0 \to \infty$. [refine]

refine ls number restraints

The number of restrained parameters. These are parameters which are not directly dependent on another refined parameter. Restrained parameters often involve geometry or energy dependencies. See also _atom_site_constraints and _atom_site_refinement_flags. A general description of refinement constraints may appear in _refine_special_details.

The permitted range is $0 \to \infty$. [refine]

refine ls R factor all

(numb)

Residual factor for all reflections satisfying the resolution limits established by <code>_refine_ls_d_res_high</code> and <code>_refine_ls_d_res_low</code>. This is the conventional R factor. See also <code>_refine_ls_wR_factor_</code> definitions.

$$R = \frac{\sum |F_{\text{obs}} - F_{\text{calc}}|}{\sum |F_{\text{obs}}|},$$

where $F_{\rm obs}$ = the observed structure-factor amplitudes, $F_{\rm calc}$ = the calculated structure-factor amplitudes and the sum is taken over the specified reflections.

The permitted range is $0.0 \to \infty$. [refine]

refine_ls_R_factor_gt

(numb)

Residual factor for the reflections (with number given by reflns_number_gt) judged significantly intense (i.e. satisfying the threshold specified by reflns_threshold_expression) and included in the refinement. The reflections also satisfy the resolution limits established by refine_ls_d_res_high and refine_ls_d_res_low. This is the conventional R factor. See also refine_ls_wR_factor_definitions.

$$R = \frac{\sum |F_{\text{obs}} - F_{\text{calc}}|}{\sum |F_{\text{obs}}|},$$

where $F_{\rm obs}$ = the observed structure-factor amplitudes, $F_{\rm calc}$ = the calculated structure-factor amplitudes and the sum is taken over the specified reflections.

The permitted range is $0.0 \to \infty$.

Related item: _refine_ls_R_factor_obs (alternate).

refine ls R factor obs

(numb)

This definition has been superseded and is retained here only for archival purposes. Use instead refine ls_R factor_gt.

Residual factor for the reflections classified as 'observed' (see _reflns_observed_criterion) and included in the refinement.

The reflections also satisfy the resolution limits established by _refine_ls_d_res_high and _refine_ls_d_res_low. This is the conventional R factor. See also _refine_ls_wR_factor_definitions.

$$R = \frac{\sum |F_{\text{obs}} - F_{\text{calc}}|}{\sum |F_{\text{obs}}|},$$

where $F_{\rm obs}$ = the observed structure-factor amplitudes, $F_{\rm calc}$ = the calculated structure-factor amplitudes and the sum is taken over the specified reflections.

The permitted range is $0.0 \rightarrow \infty$.

[refine]

refine ls R Fsqd factor

(numb)

Residual factor $R(F^2)$, calculated on the squared amplitudes of the observed and calculated structure factors, for significantly intense reflections (satisfying <code>reflns_threshold_expression</code>) and included in the refinement. The reflections also satisfy the resolution limits established by <code>refine_ls_d_res_high</code> and <code>refine_ls_d_res_low</code>.

$$R(F^2) = \frac{\sum |F_{\text{obs}}^2 - F_{\text{calc}}^2|}{\sum |F_{\text{obs}}^2|},$$

where $F_{\rm obs}^2$ = squares of the observed structure-factor amplitudes, $F_{\rm calc}^2$ = squares of the calculated structure-factor amplitudes and the sum is taken over the specified reflections.

The permitted range is $0.0 \rightarrow \infty$.

[refine]

refine ls R I factor

(numb

Residual factor R(I) for significantly intense reflections (satisfying _reflns_threshold_expression) and included in the refinement. This is most often calculated in Rietveld refinements against powder data, where it is referred to as R_B or $R_{\rm Bragg}$.

$$R(I) = \frac{\sum |I_{\text{obs}} - I_{\text{calc}}|}{\sum |I_{\text{obs}}|},$$

where $I_{\rm obs}$ = the net observed intensities, $I_{\rm calc}$ = the net calculated intensities and the sum is taken over the specified reflections. The permitted range is $0.0 \to \infty$. [refine]

refine ls restrained S all

(numb)

The least-squares goodness-of-fit parameter S' for all reflections after the final cycle of least-squares refinement. This parameter explicitly includes the restraints applied in the least-squares process. See also _refine_ls_goodness_of_fit_ definitions.

$$S' = \left(\frac{\sum |w|Y_{\text{obs}} - Y_{\text{calc}}|^2 |+ \sum_r |w_r|P_{\text{calc}} - P_{\text{targ}}|^2 |}{N_{\text{ref}} + N_{\text{restr}} - N_{\text{param}}}\right)^{1/2},$$

where $Y_{\rm obs}$ = the observed coefficients (see _refine_ls_structure_factor_coef), $Y_{\rm calc}$ = the calculated coefficients (see _refine_ls_structure_factor_coef), w = the least-squares reflection weight [1/square of standard uncertainty (e.s.d.)], $P_{\rm calc}$ = the calculated restraint values, $P_{\rm targ}$ = the target restraint values, w_r = the restraint weight, $N_{\rm ref}$ = the number of reflections used in the refinement (see _refine_ls_number_reflns_obs), $N_{\rm restr}$ = the number of refined parameters (see _refine_ls_number_parameters); the sum \sum is taken over the specified reflections and the sum \sum_r is taken over the restraints.

The permitted range is $0.0 \rightarrow \infty$.

[refine]

[refine]

refine 1s restrained S gt

The least-squares goodness-of-fit parameter S' for significantly intense reflections (satisfying reflns threshold expression) after the final cycle of least-squares refinement. This parameter explicitly includes the restraints applied in the least-squares process. See also refine 1s goodness of fit definitions.

$$S' = \left(\frac{\sum |w|Y_{\text{obs}} - Y_{\text{calc}}|^2 |+ \sum_r |w_r|P_{\text{calc}} - P_{\text{targ}}|^2 |}{N_{\text{ref}} + N_{\text{restr}} - N_{\text{param}}}\right)^{1/2},$$

where Y_{obs} = the observed coefficients (see _refine_ls_ structure factor coef), Y_{calc} = the calculated coefficients (see $_{\tt refine_ls_structure_factor_coef)}$, w = the least-squaresreflection weight [1/square of standard uncertainty (e.s.d.)], P_{calc} = the calculated restraint values, P_{targ} = the target restraint values, w_r = the restraint weight, N_{ref} = the number of reflections used in the refinement (see _refine_ls_ number_reflns_obs), N_{restr} = the number of restraints (see refine_ls_number_restraints) and $N_{\rm param}$ = the number of refined parameters (see _refine_ls_number_parameters); the sum \sum is taken over the specified reflections and the sum \sum_r is taken over the restraints.

The permitted range is $0.0 \to \infty$.

Related item: _refine_ls_restrained_S_obs (alternate).

[refine]

refine ls restrained S obs

This definition has been superseded and is retained here only for archival purposes. Use instead refine 1s restrained S gt.

The least-squares goodness-of-fit parameter S' for observed reflections after the final cycle of least-squares refinement. This parameter explicitly includes the restraints applied in the least-squares process. See also $\verb| _refine_ls_goodness_of_fit| \textit{ definitions}.$

$$S' = \left(\frac{\sum \left|w|Y_{\text{obs}} - Y_{\text{calc}}|^2\right| + \sum_r \left|w_r|P_{\text{calc}} - P_{\text{targ}}|^2\right|}{N_{\text{ref}} + N_{\text{restr}} - N_{\text{param}}}\right)^{1/2},$$

where $Y_{\rm obs}$ = the observed coefficients (see <code>_refine_ls_structure_</code> factor coef), Y_{calc} = the calculated coefficients (see refine 1s structure_factor_coef), w = the least-squares reflection weight [1/square of standard uncertainty (e.s.d.)], P_{calc} = the calculated restraint values, P_{targ} = the target restraint values, w_r = the restraint weight, N_{ref} = the number of reflections used in the refinement (see $_{\tt refine_ls_number_reflns_obs}), N_{\tt restr} = the number of restraints$ (see $_$ refine $_$ ls $_$ number $_$ restraints) and N_{param} = the number of refined parameters (see _refine_1s_number_parameters); the sum \sum is taken over the specified reflections and the sum \sum_r is taken over the restraints.

The permitted range is $0.0 \rightarrow \infty$.

[refine]

refine ls shift/esd max

This definition has been superseded and is retained here only for archival purposes. Use instead _refine_ls_shift/su_max.

The largest ratio of the final least-squares parameter shift to the final standard uncertainty (s.u., formerly described as estimated standard deviation, e.s.d.).

The permitted range is $0.0 \rightarrow \infty$.

[refine]

refine ls shift/esd mean

(numb)

This definition has been superseded and is retained here only for archival purposes. Use instead _refine_ls_shift/su_mean.

The average ratio of the final least-squares parameter shift to the final standard uncertainty (s.u., formerly described as estimated standard deviation, e.s.d.).

The permitted range is $0.0 \rightarrow \infty$.

[refine]

refine ls shift/su max

The largest ratio of the final least-squares parameter shift to the final standard uncertainty.

The permitted range is $0.0 \rightarrow \infty$.

 $Related \ item: \verb| refine_ls_shift/esd_max| (alternate).$

[refine]

refine ls shift/su max lt

An upper limit for the largest ratio of the final least-squares parameter shift to the final standard uncertainty. This item is used when the largest value of the shift divided by the final standard uncertainty is too small to measure.

The permitted range is $0.0 \to \infty$.

Related item: _refine_ls_shift/su_max (alternate).

[refine]

refine ls shift/su mean

(numb)

The average ratio of the final least-squares parameter shift to the final standard uncertainty.

The permitted range is $0.0 \rightarrow \infty$.

Related item: _refine_ls_shift/esd_mean (alternate).

[refine]

refine ls shift/su mean lt

(numb)

An upper limit for the average ratio of the final least-squares parameter shift to the final standard uncertainty. This item is used when the average value of the shift divided by the final standard uncertainty is too small to measure.

The permitted range is $0.0 \rightarrow \infty$.

Related item: _refine_ls_shift/su_mean (alternate).

[refine]

refine ls structure factor coef

(char)

Structure-factor coefficient |F|, F^2 or I used in the least-squares refinement process.

The data value must be one of the following:

structure-factor magnitude Fsqd structure factor squared

net intensity Inet

Where no value is given, the assumed value is 'F'.

[refine]

refine ls weighting details

A description of special aspects of the weighting scheme used in the least-squares refinement. Used to describe the weighting when the value of _refine_ls_weighting_scheme is specified as 'calc'. Example:

```
; Sigdel model of Konnert-Hendrickson:
 Sigdel = Afsig + Bfsig*(sin(\q)/\l - 1/6)
 Afsig = 22.0, Bfsig = 150.0 at the beginning of refinement.
```

Afsig = 16.0, Bfsig = 60.0 at the end of refinement.

[refine]

refine ls weighting scheme

The weighting scheme applied in the least-squares process. The standard code may be followed by a description of the weight (but see refine 1s weighting details for a preferred approach).

The data value must be one of the following:

based on measured s.u.'s siqma unit unit or no weights applied calculated weights applied

Where no value is given, the assumed value is 'sigma'.

[refine]

refine ls wR factor all

Weighted residual factors for all reflections. The reflections also satisfy the resolution limits established by _refine_ls_d_res_ high and refine 1s d res low. See also the refine 1s R factor_definitions.

$$wR = \left(\frac{\sum |w|Y_{\text{obs}} - Y_{\text{calc}}|^2}{\sum |wY_{\text{obs}}^2|}\right)^{1/2},$$

where Y_{obs} = the observed amplitude specified by _refine_ls_ $structure_factor_coef$, Y_{calc} = the calculated amplitude specified by refine 1s structure factor coef, w = the leastsquares weight and the sum is taken over the specified reflections. The permitted range is $0.0 \rightarrow \infty$.

refine ls wR factor gt

(numb

Weighted residual factors for significantly intense reflections (satisfying _reflns_threshold_expression) included in the refinement. The reflections also satisfy the resolution limits established by _refine_ls_d_res_high and _refine_ls_d_res_low. See also the _refine_ls_R_factor_definitions.

$$wR = \left(\frac{\sum |w|Y_{\text{obs}} - Y_{\text{calc}}|^2|}{\sum |wY_{\text{obs}}^2|}\right)^{1/2},$$

where $Y_{\rm obs}$ = the observed amplitude specified by <code>_refine_ls_structure_factor_coef</code>, $Y_{\rm calc}$ = the calculated amplitude specified by <code>_refine_ls_structure_factor_coef</code>, w = the least-squares weight and the sum is taken over the specified reflections. The permitted range is $0.0 \rightarrow \infty$.

Related item: _refine_ls_wR_factor_obs (alternate). [refine]

_refine_ls_wR_factor_obs

(numb)

This definition has been superseded and is retained here only for archival purposes. Use instead _refine_ls_wR_factor_gt.

Weighted residual factors for the reflections classified as 'observed' (see _reflns_observed_criterion) and included in the refinement. The reflections also satisfy the resolution limits established by _refine_ls_d_res_high and _refine_ls_d_res_low. See also the _refine_ls_R_factor_definitions.

$$wR = \left(\frac{\sum \left|w|Y_{\text{obs}} - Y_{\text{calc}}|^2\right|}{\sum \left|wY_{\text{obs}}^2\right|}\right)^{1/2},$$

where $Y_{\rm obs}$ = the observed amplitude specified by <code>_refine_ls_structure_factor_coef</code>, $Y_{\rm calc}$ = the calculated amplitude specified by <code>_refine_ls_structure_factor_coef</code>, w = the least-squares weight and the sum is taken over the specified reflections.

The permitted range is $0.0 \to \infty$. [refine]

refine ls wR factor ref

(num

Weighted residual factors for all reflections included in the refinement. The reflections also satisfy the resolution limits established by refine_ls_d_res_high and refine_ls_d_res_low. See also the refine ls R factor definitions.

$$wR = \left(\frac{\sum |w|Y_{\text{obs}} - Y_{\text{calc}}|^2}{\sum |wY_{\text{obs}}^2|}\right)^{1/2},$$

where $Y_{\rm obs}$ = the observed amplitude specified by <code>_refine_ls_structure_factor_coef</code>, $Y_{\rm calc}$ = the calculated amplitude specified by <code>_refine_ls_structure_factor_coef</code>, w = the least-squares weight and the sum is taken over the specified reflections. The permitted range is $0.0 \rightarrow \infty$. [refine]

refine special details

(char)

Description of special aspects of the refinement process.

[refine]

REFINE_LS_CLASS

Data items in the REFINE_LS_CLASS category record details (for each reflection class separately) about the reflections used for the structure refinement.

Example 1 – example for a modulated structure extracted from van Smaalen [J. Phys. Condens. Matter (1991), 3, 1247–1263.]

1000

```
_refine_ls_class_R_factor_gt
_refine_ls_class_code
0.057 'Main'
0.074 'Com'
0.064 'NbRefls'
0.046 'LaRefls'
0.112 'Sat1'
0.177 'Sat2'
```

refine ls class code

(char)

The code identifying a certain reflection class. This code must match a reflns class code.

Appears in list. Must match parent data name _reflns_class_code.

Examples: '1', 'm1', 's2'. [refine_ls_class]

_refine_ls_class_d_res_high (numb

For each reflection class, the highest resolution in ångströms for the reflections used in the refinement. This is the lowest d value in a reflection class.

Appears in list containing **_refine_ls_class_code**.

The permitted range is $0.0 \rightarrow \infty$.

[refine ls class]

refine_ls_class_d_res_low

(numb)

For each reflection class, the lowest resolution in angstroms for the reflections used in the refinement. This is the highest d value in a reflection class.

Appears in list containing refine ls class code.

The permitted range is $0.0 \to \infty$.

[refine_ls_class]

_refine_ls_class_R_factor_all refine ls class R factor gt

(numb

For each reflection class, the residual factors for all reflections, and for significantly intense reflections (see _reflns_threshold_expression), included in the refinement. The reflections also satisfy the resolution limits established by _refine_ls_class_d_res_high and _refine_ls_class_d_res_low. This is the conventional R factor.

$$R = \frac{\sum |F_{\text{obs}} - F_{\text{calc}}|}{\sum |F_{\text{obs}}|},$$

where $F_{\rm obs}$ = the observed structure-factor amplitudes, $F_{\rm calc}$ = the calculated structure-factor amplitudes and the sum is taken over the specified reflections. See also <code>refine_ls_class_wr_factor_all</code> definitions.

Appears in list containing _refine_ls_class_code.

The permitted range is $0.0 \to \infty$.

[refine_ls_class]

refine_ls_class_R_Fsqd_factor

(numb

For each reflection class, the residual factor $R(F^2)$ calculated on the squared amplitudes of the observed and calculated structure factors for the reflections judged significantly intense (i.e. satisfying the threshold specified by $_{\tt reflns_threshold_expression}$) and included in the refinement. The reflections also satisfy the resolution limits established by $_{\tt refine_ls_class_d_res_high}$ and $_{\tt refine_ls_class_d_res_low}$.

$$R(F^2) = \frac{\sum |F_{\text{obs}}^2 - F_{\text{calc}}^2|}{\sum |F_{\text{obs}}^2|},$$

where F_{obs}^2 = squares of the observed structure-factor amplitudes, F_{calc}^2 = squares of the calculated structure-factor amplitudes and the sum is taken over the specified reflections.

Appears in list containing _refine_ls_class_code.

The permitted range is $0.0 \rightarrow \infty$.

[refine_ls_class]

refine ls class R I factor

(numb)

For each reflection class, the residual factor R(I) for the reflections judged significantly intense (*i.e.* satisfying the threshold specified by $_{\tt reflns_threshold_expression}$) and included in the refinement. This is most often calculated in Rietveld refinements against powder data, where it is referred to as R_B or $R_{\tt Bragg}$.

$$R(I) = \frac{\sum |I_{\text{obs}} - I_{\text{calc}}|}{\sum |I_{\text{obs}}|},$$

where I_{obs} = the net observed intensities, I_{calc} = the net calculated intensities and the sum is taken over the specified reflections.

Appears in list containing refine 1s class code.

The permitted range is $0.0 \to \infty$.

[refine_ls_class]

refine ls class wR factor all (numi

For each reflection class, the weighted residual factors for all reflections included in the refinement. The reflections also satisfy the resolution limits established by _refine_ls_class_d res high and refine ls class d res low.

$$wR = \left(\frac{\sum |w|Y_{\text{obs}} - Y_{\text{calc}}|^2|}{\sum |wY_{\text{obs}}^2|}\right)^{1/2},$$

where $Y_{\rm obs}$ = the observed amplitudes specified by <code>_refine_ls_structure_factor_coef</code>, $Y_{\rm calc}$ = the calculated amplitudes specified by <code>_refine_ls_structure_factor_coef</code>, w = the least-squares weights and the sum is taken over the reflections of this class. See also <code>_refine_ls_class_R_factor_definitions</code>.

Appears in list containing _refine_ls_class_code.

The permitted range is $0.0 \rightarrow \infty$.

[refine_ls_class]

REFLN

Data items in the REFLN category record details about the reflections used to determine the ATOM_SITE data items. The REFLN data items refer to individual reflections and must be included in looped lists. The REFLNS data items specify the parameters that apply to all reflections. The REFLNS data items are not looped.

Example 1 – based on data set fetod of Todres, Yanovsky, Ermekov & Struchkov [Acta Cryst. (1993), C49, 1352–1354].

```
loop_
 refln index h
 refln index k
 _refln_index l
 _refln_F_squared_calc
 _refln_F_squared_meas
 refln F squared sigma
 _refln_include_status
                    85.57
                                 58.90
                                            1.45 o
       0
                 15718.18
                              15631.06
                                            30.40 o
           0
                              49840.09
                                           61.86 o
       0
           0
                 55613.11
   5
                   246.85
                               241.86
                                           10.02 o
       0
           0
   6
       0
           0
                    82.16
                                 69.97
                                            1.93 o
                                           11.78 o
   7
       0
           0
                  1133.62
                                947.79
                               2453.33
                                            20.44 o
       0
           0
                  2558.04
                                393.66
   10
                   283.70
                                171.98
                                             4.26 o
```

```
Example 2 - based on standard test data set p6122 of the Xtal distribution
[Hall, King & Stewart (1995). Xtal3.4 User's Manual. University of Western Aus
refln index h
refln index k
refln index l
refln_F_meas
_refln_F_calc
refln_F_sigma
refln include status
_refln_scale_group_code
          12
               42.599
                        40.855
                                  2.131
                42.500
                        42.507
                                  4.719
                        57.976
                                  4.719
                59.172
                89 694
                        94.741
                                  4 325
                51.743
                        52,241
                                  3.850
                 9.294
                        10.318
                 6.755
                         7.102
                30.693
                        31,171
                                  2.668
                12.324
                        12.085
                                  2.391
    0
                15.348
                        15.122
                                  2.239
           10
               17.622
                        19.605
                                  1.997
```

_refln_A_calc refln A meas

(numb)

The calculated and measured structure-factor component A (in electrons for X-ray diffraction).

$$A = |F| \cos(\text{phase}).$$

Appears in list containing _refln_index_.

[refln]

(numb)

The calculated and measured structure-factor component \boldsymbol{B} (in electrons for X-ray diffraction).

$$B = |F| \sin(\text{phase}).$$

Appears in list containing _refln_index_.

[refln]

${\tt refln_class_code}$

(char

The code identifying the class to which this reflection has been assigned. This code must match a value of <code>reflns_class_code</code>. Reflections may be grouped into classes for a variety of purposes. For example, for modulated structures each reflection class may be defined by the number $m = \sum |m_i|$, where the m_i are the integer coefficients that, in addition to h, k, l, index the corresponding diffraction vector in the basis defined for the reciprocal lattice.

Appears in list containing <code>refln_index</code>. Must match parent data name <code>_reflns_class_code</code>. [refln]

refln crystal id

(char)

Code identifying each crystal if multiple crystals are used. Is used to link with _exptl_crystal_id in the _exptl_crystal_ list.

Appears in list containing _refln_index_. Must match parent data name _exptl_crystal_id. [refln]

refln d spacing

(numb)

The d spacing in angströms for this reflection. This is related to the $(\sin \theta)/\lambda$ value by the expression <code>_refln_d_spacing = 2/(_refln_sint/lambda)</code>.

Appears in list containing _refln_index_.

The permitted range is $0.0 \to \infty$. [refln]

```
refln F calc
refln F meas
 refln F sigma
```

(numb)

The calculated, measured and standard uncertainty (derived from measurement) of the structure factors (in electrons for X-ray diffraction).

Appears in list containing _refln_index_. [refln]

```
_refln_F_squared_calc
_refln_F_squared meas
refln F squared sigma
```

Calculated, measured and estimated standard uncertainty (derived from measurement) of the squared structure factors (in electrons squared for X-ray diffraction).

Appears in list containing _refln_index_. [refln]

refln include status

(char)

Classification of a reflection indicating its status with respect to inclusion in the refinement and the calculation of R factors.

Appears in list containing _refln_index_.

Related item: _refln_observed_status (alternate).

The data value must be one of the following:

```
(lower-case letter o for 'observed') satisfies _refine_ls_d_
0
          res high, satisfies refine ls d res low and exceeds
            reflns_threshold_expression
         satisfies _refine_ls_d_res_high, satisfies _refine_ls_
          d_res_low and does not exceed _reflns_threshold_
          expression
         systematically absent reflection
         unreliable measurement - not used
х
h
         does not satisfy refine ls d res high
```

does not satisfy _refine_ls_d_res_low Where no value is given, the assumed value is 'o'.

[refln]

```
refln index h
refln index k
refln index 1
```

1

Miller indices of the reflection. The values of the Miller indices in the REFLN category must correspond to the cell defined by the cell lengths and cell angles in the CELL category.

Appears in list as essential element of loop structure.

[refln]

```
refln intensity calc
refln intensity meas
refln intensity sigma
```

The calculated, measured and standard uncertainty (derived from measurement) of the intensity, all in the same arbitrary units as refln intensity meas.

Appears in list containing _refln_index_.

[refln]

refln mean path length tbar

(numb)

Mean path length in millimetres through the crystal for this reflection.

Appears in list containing _refln_index_.

The permitted range is $0.0 \rightarrow \infty$.

[refln]

refln observed status

(char)

This definition has been superseded and is retained here only for archival purposes. Use instead refln include status.

Classification of a reflection indicating its status with respect to inclusion in the refinement and the calculation of R factors.

Appears in list containing _refln_index_.

The data value must be one of the following:

```
satisfies _refine_ls_d_res_high, satisfies _refine_ls_
0
                                         _reflns_observed
                     and observed by
          d res low
          criterion
        satisfies _refine_ls_d_res_high, satisfies _refine_ls_
          d res low and unobserved by reflns observed
          criterion
        systematically absent reflection
        unreliable measurement - not used
х
```

h does not satisfy _refine_ls_d_res_high does not satisfy _refine_ls_d_res_low

Where no value is given, the assumed value is 'o'.

[refln]

```
refln phase calc
```

(numb)

[refln]

The calculated structure-factor phase in degrees.

Appears in list containing _refln_index_.

refln phase meas

(numb, su)

The measured structure-factor phase in degrees.

Appears in list containing _refln_index_. [refln]

refln refinement status

(char)

Status of a reflection in the structure-refinement process.

Appears in list containing _refln_index_. The data value must be one of the following:

incl included in least-squares process

excl excluded from least-squares process

excluded due to extinction extn

Where no value is given, the assumed value is 'incl'.

[refln]

refln scale group code

(char)

Code identifying the structure-factor scale. This code must correspond to one of the reflns_scale_group_code values.

Appears in list containing refln index . Must match parent data name _reflns_scale_group_code.

Examples: '1', '2', '3', 's1', 'A', 'B', 'c1', 'c2', 'c3'.

refln sint/lambda

[refln]

[refln]

The $(\sin \theta)/\lambda$ value in reciprocal angströms for this reflection.

Appears in list containing refln index .

The permitted range is $0.0 \rightarrow \infty$.

refln symmetry epsilon

(numb)

The symmetry reinforcement factor corresponding to the number of times the reflection indices are generated identically from the space-group symmetry operations.

Appears in list containing _refln_index_.

The permitted range is $1 \rightarrow 48$.

[refln]

refln symmetry multiplicity

The number of reflections symmetry-equivalent under the Laue symmetry to the present reflection. In the Laue symmetry, Friedel opposites (hkl and -h-k-l) are equivalent. Tables of symmetryequivalent reflections are available in International Tables for Crystallography Volume A (2002), Chapter 10.1.

Appears in list containing _refln_index_.

The permitted range is $1 \rightarrow 48$.

[refln]

refln wavelength

(numb)

The mean wavelength in ångströms of the radiation used to measure this reflection. This is an important parameter for data collected using energy-dispersive detectors or the Laue method.

Appears in list containing _refln_index_.

The permitted range is $0.0 \rightarrow \infty$.

[refln]

refln wavelength id

(char)

Code identifying the wavelength in the diffrn radiation list. See diffrn radiation wavelength id.

Appears in list containing _refln_index_. Must match parent data name

_diffrn_radiation_wavelength_id. [refln]

REFLNS

Data items in the REFLNS category record details about the reflections used to determine the ATOM_SITE data items. The REFLN data items refer to individual reflections and must be included in looped lists. The REFLNS data items specify the parameters that apply to all reflections. The REFLNS data items are not looped.

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

```
reflns limit h min
                                    n
reflns limit h max
                                    6
_reflns_limit_k_min
                                    0
reflns limit k max
                                    17
reflns limit l min
                                    0
reflns limit 1 max
                                    22
reflns number total
                                    1592
_reflns_number_gt
                                    1408
_reflns_threshold_expression
                                    'F > 6.0u(F)'
_reflns_d_resolution_high
                                    0.8733
reflns d resolution low
                                    11.9202
```

```
_reflns_d_resolution_high
  reflns d_resolution_low
```

(numb

The highest and lowest resolution in ångströms for the reflections. These are the smallest and largest d values.

The permitted range is $0.0 \rightarrow \infty$.

[reflns]

reflns_Friedel_coverage

(numb)

The proportion of Friedel-related reflections present in the number of 'independent' reflections specified by the item reflns number total. This proportion is calculated as the ratio

$$\frac{[N(\text{crystal class}) - N(\text{Laue symmetry})]}{N(\text{Laue symmetry})}$$

where, working from the $_diffrn_refln_$ list, $N(crystal\ class)$ is the number of reflections obtained on averaging under the symmetry of the crystal class and $N(Laue\ symmetry)$ is the number of reflections obtained on averaging under the Laue symmetry.

Examples: (a) For centrosymmetric structures, _reflns_friedel_coverage is necessarily equal to 0.0 as the crystal class is identical to the Laue symmetry. (b) For whole-sphere data for a crystal in the space group P1, _reflns_friedel_coverage is equal to 1.0, as no reflection hkl is equivalent to -h - k - l in the crystal class and all Friedel pairs $\{hkl; -h - k - l\}$ have been measured. (c) For whole-sphere data in space group Pmm2, _reflns_friedel_coverage will be < 1.0 because although reflections hkl and -h - k - l are not equivalent when hkl indices are nonzero, they are when l = 0. (d) For a crystal in the space group Pmm2, measurements of the two inequivalent octants $h \ge 0$, $k \ge 0$, whereas measurements of the two equivalent octants $k \ge 0$, $k \ge 0$ will lead to a value of zero for reflns friedel coverage.

The permitted range is $0.0 \rightarrow 1.0$. [reflns]

```
_reflns_limit_h_max
_reflns_limit_h_min
_reflns_limit_k_max
_reflns_limit_k_min
_reflns_limit_l_max
_reflns_limit_l_min
```

reflns_limit_1_min (numb)

Miller indices limits for the reported reflections. These need not be the same as the _diffrn_reflns_limit_ values.

[reflns]

reflns number gt

(numb)

The number of reflections in the <code>refln_</code> list (not the <code>_diffrn_refln_</code> list) that are significantly intense, satisfying the criterion specified by <code>_reflns_threshold_expression</code>. This may include Friedel-equivalent reflections (i.e. those which are

symmetry-equivalent under the Laue symmetry but inequivalent under the crystal class) according to the nature of the structure and the procedures used. Special characteristics of the reflections included in the <code>_refln_</code> list should be given in the item <code>reflns special details</code>.

The permitted range is $0 \to \infty$.

Related item: reflns number observed (alternate).

[reflns]

reflns number observed

(numb)

This definition has been superseded and is retained here only for archival purposes. Use instead <code>reflns_number_gt</code>.

The number of 'observed' reflections in the <code>_refln_</code> list (not the <code>_diffrn_refln_</code> list). The observed reflections satisfy the threshold criterion specified by <code>_reflns_threshold_expression</code> (or the deprecated item <code>_reflns_observed_criterion</code>). They may include Friedel-equivalent reflections according to the nature of the structure and the procedures used. Special characteristics of the reflections included in the <code>_refln_</code> list should be given in the item <code>_reflns_special_details</code>. The permitted range is $0 \to \infty$. [reflns]

reflns number total

(numb)

The total number of reflections in the <code>_refln_</code> list (not the <code>_diffrn_refln_</code> list). This may include Friedel-equivalent reflections (i.e. those which are symmetry-equivalent under the Laue symmetry but inequivalent under the crystal class) according to the nature of the structure and the procedures used. Special characteristics of the reflections included in the <code>_refln_</code> list should be given in the item <code>_reflns_special_details</code>.

The permitted range is $0 \to \infty$.

[reflns]

reflns observed criterion

(char)

This definition has been superseded and is retained here only for archival purposes. Use instead _reflns_threshold_expression.

The criterion used to classify a reflection as 'observed'. This criterion is usually expressed in terms of a $\sigma(I)$ or $\sigma(F)$ threshold.

Example: 'I>2u(I)'. [reflns]

reflns special details

(char)

Description of the properties of the reported reflection list that are not given in other data items. In particular, this should include information about the averaging (or not) of symmetry-equivalent reflections including Friedel pairs.

[reflns]

reflns threshold expression

(char)

The threshold, usually based on multiples of u(I), $u(F^2)$ or u(F), that serves to identify significantly intense reflections, the number of which is given by <code>reflns_number_gt</code>. These reflections are used in the calculation of <code>refine_ls_R_factor_gt</code>.

Related item: _reflns_observed_criterion (alternate).

Example: 'I>2u(I)'. [reflns]

REFLNS_CLASS

Data items in the REFLNS_CLASS category record details, for each reflection class, about the reflections used to determine the structural parameters.

Example 1 – corresponding to the one-dimensional incommensurately modulated structure of K_2SeO_4 .

Loop_ _reflns_class_number_gt _reflns_class_code _ 584 'Main' _ 226 'Sat1' _ 50 'Sat2'

reflns class code

(char)

The code identifying a certain reflection class.

Appears in list. May match child data name(s): _refln_class_code,

_refine_ls_class_code.

Examples: '1', 'm1', 's2'. [reflns_class]

reflns class d res high

(numb

For each reflection class, the highest resolution in ångströms for the reflections used in the refinement. This is the smallest d value. Appears in list containing reflns class code.

The permitted range is $0.0 \rightarrow \infty$.

[reflns class]

reflns class d res low

(numb)

For each reflection class, the lowest resolution in angströms for the reflections used in the refinement. This is the largest d value.

Appears in list containing _reflns_class_code.

The permitted range is $0.0 \rightarrow \infty$.

[reflns_class]

reflns class description

(char)

Description of each reflection class.

Appears in list containing _reflns_class_code. Examples: 'm=1 first order satellites',

'H0L0 common projection reflections'.

[reflns_class]

_reflns_class_number_gt

(numb)

For each reflection class, the number of significantly intense reflections (see _reflns_threshold_expression) in the _refln_ list (not the _diffrn_refln_ list). This may include Friedel-equivalent reflections (i.e. those which are symmetry-equivalent under the Laue symmetry but inequivalent under the crystal class) according to the nature of the structure and the procedures used. Special characteristics of the reflections included in the _refln_ list should be given in the item _reflns_special_details.

Appears in list containing _reflns_class_code.

The permitted range is $0.0 \rightarrow \infty$.

[reflns class]

reflns class number total

(num

For each reflection class, the total number of reflections in the <code>refln_</code> list (not the <code>diffrn_refln_</code> list). This may include Friedel-equivalent reflections (i.e. those which are symmetry-equivalent under the Laue symmetry but inequivalent under the crystal class) according to the nature of the structure and the procedures used. Special characteristics of the reflections included in the <code>refln_</code> list should be given in the item <code>reflns_special_details</code>.

Appears in list containing reflns_class_code.

The permitted range is $0.0 \rightarrow \infty$.

[reflns_class]

_reflns_class_R_factor_all reflns class R factor gt

(numb)

For each reflection class, the residual factors for all reflections, and for significantly intense reflections (see _reflns_threshold_expression), included in the refinement. The reflections also satisfy the resolution limits established by _reflns_class_d_res_high and _reflns_class_d_res_low. This is the conventional R factor.

$$R = \frac{\sum |F_{\text{obs}} - F_{\text{calc}}|}{\sum |F_{\text{obs}}|},$$

where $F_{\rm obs}$ = the observed structure-factor amplitudes, $F_{\rm calc}$ = the calculated structure-factor amplitudes and the sum is taken over the reflections of this class. See also <code>_reflns_class_wr</code> factor all definitions.

Appears in list containing _reflns_class_code.

The permitted range is $0.0 \rightarrow \infty$.

[reflns_class]

reflns class R Fsqd factor (number 1)

For each reflection class, the residual factor $R(F^2)$ calculated on the squared amplitudes of the observed and calculated structure factors, for the reflections judged significantly intense (i.e. satisfying the threshold specified by <code>reflns_threshold_expression</code>) and included in the refinement. The reflections also satisfy the resolution limits established by <code>reflns_class_d_res_high</code> and <code>reflns_class_d_res_low</code>.

$$R(F^2) = \frac{\sum |F_{\text{obs}}^2 - F_{\text{calc}}^2|}{\sum |F_{\text{obs}}^2|},$$

where $F_{\rm obs}^2$ = squares of the observed structure-factor amplitudes, $F_{\rm calc}^2$ = squares of the calculated structure-factor amplitudes and the sum is taken over the reflections of this class.

Appears in list containing _reflns_class_code.

The permitted range is $0.0 \rightarrow \infty$.

[reflns_class]

reflns class R I factor

(num

For each reflection class, the residual factor R(I) for the reflections judged significantly intense (*i.e.* satisfying the threshold specified by $\tt reflns_threshold_expression$) and included in the refinement. This is most often calculated in Rietveld refinements against powder data, where it is referred to as R_B or R_{Bragg} .

$$R(I) = \frac{\sum |I_{\text{obs}} - I_{\text{calc}}|}{\sum |I_{\text{obs}}|},$$

where $I_{\rm obs}$ = the net observed intensities, $I_{\rm calc}$ = the net calculated intensities and the sum is taken over the reflections of this class.

Appears in list containing _reflns_class_code.

The permitted range is $0.0 \rightarrow \infty$.

reflns class wR factor all

numh

[reflns class]

For each reflection class, the weighted residual factors for all reflections included in the refinement. The reflections also satisfy the resolution limits established by <code>reflns_class_d_res_high</code> and <code>reflns_class_d_res_low</code>.

$$wR = \left(\frac{\sum |w|Y_{\text{obs}} - Y_{\text{calc}}|^2|}{\sum |wY_{\text{obs}}^2|}\right)^{1/2},$$

where $Y_{\rm obs}$ = the observed amplitudes specified by _refine_ls_structure_factor_coef, $Y_{\rm calc}$ = the calculated amplitudes specified by _refine_ls_structure_factor_coef, w = the least-squares weights and the sum is taken over the reflections of this class. See also _reflns_class_R factor_definitions.

Appears in list containing _reflns_class_code.

The permitted range is $0.0 \rightarrow \infty$.

[reflns class]

REFLNS_SCALE

Data items in the REFLNS_SCALE category record details about the structure-factor scales. They are referenced from within the REFLN list through refln scale group code.

Example 1 – based on standard test data set p6122 of the Xtal distribution [Hall, King & Stewart (1995). Xtal3.4 User's Manual. University of Western Australia].

loop_

_reflns_scale_group_code

_reflns_scale_meas_F

1 .895447

2 .912743

reflns scale group code

(char)

The code identifying a scale <code>reflns_scale_meas</code>. These are linked to the <code>refln_</code> list by the <code>refln_scale_group_code</code>. These codes need not correspond to those in the <code>_diffrn_scale_</code> list.

Appears in list as essential element of loop structure. May match child data name(s):

_refln_scale_group_code.

[reflns_scale]

_reflns_scale_meas_F

reflns_scale_meas_F_squared reflns scale meas intensity

(numb, su)

Scales associated with reflns scale group code.

Appears in list containing reflns scale group code.

The permitted range is $0.0 \rightarrow \infty$. [reflns_scale]

REFLNS_SHELL

Data items in the REFLNS SHELL category record details about the reflections used to determine the ATOM SITE data items, as broken down by shells of resolution.

Example 1 – based on PDB entry 5HVP and laboratory records for the structure corresponding to PDB entry 5HVP.

```
loop_
reflns shell d res high
reflns shell d res low
_reflns_shell_meanI_over_uI_gt
reflns shell number measured gt
_reflns_shell_number_unique_gt
reflns_shell_percent_possible_gt
reflns shell Rmerge F gt
 31.38
        3.82 69.8
                     9024
                           2540
                                 96.8
                                        1.98
  3.82 3.03 26.1
                     7413
                          2364
                                 95.1
                                        3.85
  3.03
        2.65 10.5
                           2123
                                        6.37
                     5640
                                 86.2
  2.65
        2.41
               6.4
                     4322
                          1882
                                 76.8
                                        8.01
   2.41
        2.23
                4.3
                     3247
                           1714
                                 70.4
                                        9.86
   2.23
        2.10
                3.1
                     1140
                            812
                                 33.3
                                       13.99
```

reflns shell d res high

The highest resolution in angströms for the reflections in this shell. This is the smallest *d* value.

Appears in list.

The permitted range is $0.0 \rightarrow \infty$.

[reflns shell]

reflns shell d res low

(numb)

The lowest resolution in angströms for the reflections in this shell. This is the largest *d* value.

Appears in list.

The permitted range is $0.0 \rightarrow \infty$.

[reflns shell]

reflns shell meanI over sigI all

This definition has been superseded and is retained here only for archival purposes. Use instead _reflns_shell_meanI_over_uI_all.

The ratio of the mean of the intensities of all reflections in this shell to the mean of the standard uncertainties of the intensities of all reflections in the resolution shell.

Appears in list.

[reflns shell]

reflns shell meanI over sigI gt

This definition has been superseded and is retained here only for archival purposes. Use instead _reflns_shell_meanI_over_uI_gt.

The ratio of the mean of the intensities of the significantly intense reflections (see reflns threshold expression) in this shell to the mean of the standard uncertainties of the intensities of the significantly intense reflections in the resolution shell.

Appears in list.

[reflns_shell]

reflns shell meanI over sigI obs

This definition has been superseded and is retained here only for archival purposes. Use instead reflns shell meanI over sigI gt.

The ratio of the mean of the intensities of the reflections classified as `observed' (see $_reflns_observed_criterion$) in this shell to the mean of the standard uncertainties of the intensities of the 'observed' reflections in the resolution shell.

Appears in list.

[reflns shell]

reflns_shell_meanI_over_uI_all

The ratio of the mean of the intensities of all reflections in this shell to the mean of the standard uncertainties of the intensities of all reflections in the resolution shell.

Appears in list

Related item: _reflns_shell_meanI_over_sigI_all (alternate).

[reflns shell]

reflns shell meanI over uI qt

The ratio of the mean of the intensities of the significantly intense reflections (see reflns threshold expression) in this shell to the mean of the standard uncertainties of the intensities of the significantly intense reflections in the resolution shell.

Appears in list.

Related items:

_reflns_shell_meanI_over_sigI_gt (alternate),

reflns shell meanI over sigI obs (alternate).

[reflns shell]

reflns shell number measured all (numb) The total number of reflections measured for this resolution shell.

Appears in list.

The permitted range is $0.0 \rightarrow \infty$.

[reflns shell]

reflns shell number measured gt

The number of significantly intense reflections (see reflns threshold expression) measured for this resolution shell.

Appears in list.

The permitted range is $0.0 \rightarrow \infty$.

Related item: reflns shell number measured obs (alternate).

[reflns_shell]

reflns shell number measured obs

(numb)

This definition has been superseded and is retained here only for archival purposes. Use instead reflns shell number measured gt.

The number of reflections classified as 'observed' (see _reflns_ observed criterion) measured for this resolution shell.

Appears in list.

The permitted range is $0.0 \rightarrow \infty$.

[reflns_shell]

reflns shell number possible

(numb)

The number of unique reflections it is possible to measure in this reflection shell.

Appears in list.

The permitted range is $0 \to \infty$.

[reflns_shell]

reflns shell number unique all

The total number of measured reflections resulting from merging measured symmetry-equivalent reflections for this resolution shell. Appears in list

The permitted range is $0 \to \infty$.

[reflns_shell]

reflns shell number unique gt

The total number of significantly intense reflections (see _reflns_threshold_expression) resulting from merging measured symmetry-equivalent reflections for this resolution shell. Appears in list.

The permitted range is $0 \to \infty$.

Related item: _reflns_shell_number_unique_obs (alternate). [reflns_shell]

reflns shell number unique obs

This definition has been superseded and is retained here only for archival purposes. Use instead reflns shell number unique gt.

The total number of reflections classified as 'observed' (see reflns observed_criterion) resulting from merging measured symmetryequivalent reflections for this resolution shell.

Appears in list.

The permitted range is $0 \to \infty$.

[reflns_shell]

reflns shell percent possible all

The percentage of geometrically possible reflections represented by all reflections measured for this resolution shell.

Appears in list.

The permitted range is $0.0 \rightarrow 100.0$.

[reflns shell]

reflns_shell_percent_possible_gt

The percentage of geometrically possible reflections represented by significantly intense reflections (see reflns threshold expression) measured for this resolution shell.

Appears in list.

The permitted range is $0.0 \rightarrow 100.0$.

Related item: _reflns_shell_percent_possible_obs (alternate).

[reflns shell]

reflns shell percent possible obs

This definition has been superseded and is retained here only for archival purposes. Use instead refins_shell_percent_possible_gt.

The percentage of geometrically possible reflections represented by reflections classified as 'observed' (see _reflns_observed_criterion) measured for this resolution shell.

Appears in list.

The permitted range is $0.0 \rightarrow 100.0$.

[reflns shell]

reflns shell Rmerge F all

(num

The value of $R_{\text{merge}}(F)$ for all reflections in a given shell.

$$R_{ ext{merge}} = rac{\sum_i (\sum_j |F_j - \langle F
angle|)}{\sum_i (\sum_i \langle F
angle)},$$

where F_j = the amplitude of the jth observation of reflection i, $\langle F \rangle$ = the mean of the amplitudes of all observations of reflection i, \sum_i is taken over all reflections and \sum_j is taken over all observations of each reflection.

Appears in list

The permitted range is $0.0 \to \infty$.

[reflns shell]

reflns_shell_Rmerge_F_gt

(numi

The value of $R_{\text{merge}}(F)$ for significantly intense reflections (see reflns threshold expression) in a given shell.

$$R_{ ext{merge}} = rac{\sum_i (\sum_j |F_j - \langle F
angle |)}{\sum_i (\sum_j \langle F
angle)},$$

where F_j = the amplitude of the jth observation of reflection i, $\langle F \rangle$ = the mean of the amplitudes of all observations of reflection i, \sum_i is taken over all reflections and \sum_j is taken over all observations of each reflection.

Appears in list

The permitted range is $0.0 \rightarrow \infty$.

Related item: _reflns_shell_Rmerge_F_obs (alternate). [reflns_shell]

reflns_shell_Rmerge_F_obs

(numb

This definition has been superseded and is retained here only for archival purposes. Use instead _reflns_shell_Rmerge_F_gt.

The value of $R_{merge}(F)$ for reflections classified as 'observed' (see _reflns_observed_criterion) in a given shell.

$$R_{ ext{merge}} = rac{\sum_i (\sum_j |F_j - \langle F
angle|)}{\sum_i (\sum_i \langle F
angle)},$$

where F_j = the amplitude of the jth observation of reflection i, $\langle F \rangle$ = the mean of the amplitudes of all observations of reflection i, \sum_i is taken over all reflections and \sum_j is taken over all observations of each reflection.

The permitted range is $0.0 \rightarrow \infty$

[reflns shell]

reflns shell Rmerge I all

(numb

The value of $R_{\text{merge}}(I)$ for all reflections in a given shell.

$$R_{\text{merge}}(I) = \frac{\sum_{i} (\sum_{j} |I_{j} - \langle I \rangle|)}{\sum_{i} (\sum_{j} \langle I \rangle)},$$

where I_j = the intensity of the jth observation of reflection i, $\langle I \rangle$ = the mean of the intensities of all observations of reflection i, \sum_i is taken over all reflections and \sum_j is taken over all observations of each reflection.

Appears in list

The permitted range is $0.0 \rightarrow \infty$.

[reflns_shell]

reflns shell Rmerge I gt

numb)

The value of $R_{\text{merge}}(I)$ for significantly intense reflections (see reflns threshold expression) in a given shell.

$$R_{ ext{merge}}(I) = rac{\sum_i (\sum_j |I_j - \langle I
angle|)}{\sum_i (\sum_j \langle I
angle)},$$

where I_j = the intensity of the jth observation of reflection i, $\langle I \rangle$ = the mean of the intensities of all observations of reflection i, \sum_i is taken over all reflections and \sum_j is taken over all observations of each reflection.

Appears in list.

The permitted range is $0.0 \rightarrow \infty$.

Related item: _reflns_shell_Rmerge_I_obs (alternate). [re

[reflns shell]

reflns shell Rmerge I obs

(numb)

This definition has been superseded and is retained here only for archival purposes. Use instead <code>reflns_shell_Rmerge_I_gt</code>.

The value of $R_{\text{merge}}(I)$ for reflections classified as 'observed' (see reflns observed criterion) in a given shell.

$$R_{ ext{merge}}(I) = rac{\sum_i (\sum_j |I_j - \langle I
angle|)}{\sum_i (\sum_i \langle I
angle)},$$

where I_j = the intensity of the jth observation of reflection i, $\langle I \rangle$ = the mean of the intensities of all observations of reflection i, \sum_i is taken over all reflections and \sum_j is taken over all observations of each reflection.

The permitted range is $0.0 \rightarrow \infty$.

[reflns_shell]

SPACE_GROUP

Contains all the data items that refer to the space group as a whole, such as its name or crystal system. They may be looped, for example, in a list of space groups and their properties. Only a subset of the SPACE GROUP category items appear in the core dictionary. The remainder are found in the symmetry CIF dictionary. Space-group types are identified by their number as given in International Tables for Crystallography Vol. A. Specific settings of the space groups can be identified either by their Hall symbol or by specifying their symmetry operations. The commonly used Hermann-Mauguin symbol determines the spacegroup type uniquely but several different Hermann-Mauguin symbols may refer to the same space-group type. A Hermann-Mauguin symbol contains information on the choice of the basis, but not on the choice of origin. Different formats for the Hermann-Mauguin symbol are found in the symmetry CIF dictionary.

Example 1 – the monoclinic space group No. 15 with unique axis b.

_space_group_id 1
_space_group_name_H-M_alt 'C 2/c'
_space_group_IT_number 15
_space_group_name_Hall '-C 2yc'
_space_group_crystal_system monoclini

_space_group_crystal_system

(char

The name of the system of geometric crystal classes of space groups (crystal system) to which the space group belongs. Note that rhombohedral space groups belong to the trigonal system.

May appear in list containing _space_group_id.

Related item: _symmetry_cell_setting (alternate).

The data value must be one of the following

triclinic

monoclinic

orthorhombic

tetragonal

trigonal

hexagonal

cubic [space_group]

space group id

This is an identifier needed if space group items are looped.

Appears in list as essential element of loop structure. May match child data name(s):

_space_group_symop_sg_id. [space_group]

space group IT number

The number as assigned in International Tables for Crystallography Vol. A, specifying the proper affine class (i.e. the orientationpreserving affine class) of space groups (crystallographic spacegroup type) to which the space group belongs. This number defines the space-group type but not the coordinate system in which it is expressed.

May appear in list containing _space_group_id.

The permitted range is $1 \rightarrow 230$.

Related item: _symmetry_Int_Tables_number (alternate). [space_group]

space group name H-M alt

_space_group_name_H-M alt allows any Hermann-Mauguin symbol to be given. The way in which this item is used is determined by the user and in general is not intended to be interpreted by computer. It may, for example, be used to give one of the extended Hermann-Mauguin symbols given in Table 4.3.2.1 of International Tables for Crystallography Vol. A (2002) or a Hermann-Mauguin symbol for a conventional or unconventional setting. Each component of the space-group name is separated by a space or an underscore. The use of a space is strongly recommended. The underscore is only retained because it was used in older files. It should not be used in new CIFs. Subscripts should appear without special symbols. Bars should be given as negative signs before the numbers to which they apply. The commonly used Hermann-Mauguin symbol determines the space-group type uniquely but a given space-group type may be described by more than one Hermann-Mauguin symbol. The space-group type is best described using _space_group_IT_number. The Hermann-Mauguin symbol may contain information on the choice of basis. but not on the choice of origin. To define the setting uniquely, use space group name Hall or list the symmetry operations.

May appear in list containing _space_group_id.

Related item: _symmetry_space_group_name_H-M (alternate).

Example:

; loop. _space_group_id

_space_group_name_H-M_alt

'C m c m'

'C 2/c 2/m 21/m

'Amam'

(three examples for space group No. 63)

[space_group]

space group name Hall

Space-group symbol defined by Hall. Each component of the space-group name is separated by a space or an underscore. The use of a space is strongly recommended. The underscore is only retained because it was used in older files. It should not be used in new CIFs. space group name Hall uniquely defines the space group and its reference to a particular coordinate system.

References: Hall, S. R. (1981). Acta Cryst. A37, 517-525; erratum (1981), A37, 921. [See also International Tables for Crystallography, Vol. B (2001), Chapter 1.4, Appendix 1.4.2].

May appear in list containing space group id.

Related item: _symmetry_space_group_name_Hall (alternate).

Examples: 'P 2c -2ac' (equivalent to $Pca2_1$), '-I 4bd 2ab 3' (equivalent to $Ia\bar{3}d$).

[space_group]

SPACE_GROUP_SYMOP

Contains information about the symmetry operations of the space

Example 1 – the symmetry operations for the space group $P2_1/c$.

space_group_symop_id

space group symop operation xyz

x,y,z 2

-x,-y,-z

3 -x, 1/2+y, 1/2-z

x,1/2-y,1/2+z

space group symop id

(char)

An arbitrary identifier that uniquely labels each metry operation in the list. In order for the defaults work correctly, the identity operation should have _space_group_symop_id Or _symmetry_equiv_pos_site_id set to 1, and _space_group_symop_operation_xyz symmetry equiv pos as xyz set to x, y, z; i.e. the operation labelled 1 should be the identity operation.

Appears in list as essential element of loop structure.

Related item: _symmetry_equiv_pos_site_id (alternate). Where no value is given, the assumed value is '1'. [space group symop]

space group symop operation xyz

A parsable string giving one of the symmetry operations of the space group in algebraic form. If W is a matrix representation of the rotational part of the symmetry operation defined by the positions and signs of x, y and z, and \mathbf{w} is a column of translations defined by fractions, an equivalent position x' is generated from a given position x by

$$x' = Wx + w$$
.

When a list of symmetry operations is given, it must contain a complete set of coordinate representatives which generates all the operations of the space group by the addition of all primitive translations of the space group. Such representatives are to be found as the coordinates of the general-equivalent position in International Tables for Crystallography Vol. A (2002), to which it is necessary to add any centring translations shown above the general-equivalent position. That is to say, it is necessary to list explicitly all the symmetry operations required to generate all the atoms in the unit cell defined by the setting used. In order for the defaults to work correctly, the identity operation should have _space_group_symop_id Or _symmetry_equiv_pos_site_id 1, and _space_group_symop_operation_xyz $\verb"symmetry_equiv_pos_as_xyz"$ set to x, y, z; *i.e.* the operation labelled 1 should be the identity operation.

May appear in list containing space group symop id.

Related item: _symmetry_equiv_pos_as_xyz (alternate). Where no value is given, the assumed value is 'x,y,z'.

Example: 'x, 1/2-y, 1/2+z' (glide reflection through the plane (x, 1/4, z), with glide vector (1/2)c). [space_group_symop]

space group symop sg id

This must match a particular value of space group id, allowing the symmetry operation to be identified with a particular space

May appear in list. containing _space_group_symop_id. Must match parent data name _space_group_id. [space_group_symop]

SYMMETRY

Data items in the SYMMETRY category record details about the space-group symmetry.

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

```
_symmetry_cell_setting orthorhombic
_symmetry_space_group_name_H-M 'P 21 21 21'
_symmetry_space_group_name_Hall 'P 2ac 2ab'
```

symmetry cell setting

(char)

This definition has been superseded and is retained here only for archival purposes. Use instead _space_group_crystal_system.

The cell settings for this space-group symmetry.

The data value must be one of the following:

triclinic
monoclinic
orthorhombic
tetragonal
rhombohedral
trigonal
hexagonal
cubic

[symmetry]

symmetry Int Tables number

(numb)

This definition has been superseded and is retained here only for archival purposes. Use instead _space_group_IT_number.

Space-group number from International Tables for Crystallography Vol. A (2002).

The permitted range is $1 \rightarrow 230$.

[symmetry]

symmetry space group name H-M (char

This definition has been superseded and is retained here only for archival purposes. Use instead _space_group_name_H-M_alt.

Hermann—Mauguin space-group symbol. Note that the Hermann—Mauguin symbol does not necessarily contain complete information about the symmetry and the space-group origin. If used, always supply the full symbol from International Tables for Crystallography Vol. A (2002) and indicate the origin and the setting if it is not implicit. If there is any doubt that the equivalent positions can be uniquely deduced from this symbol, specify the _symmetry_equiv_pos_as_xyz or * Hall data items as well. Leave spaces between symbols referring to different axes.

Examples: 'P 1 21/m 1', 'P 2/n 2/n 2/n (origin at -1)', 'R -3 2/m'.

[symmetry]

_symmetry_space_group_name_Hall

(cha

This definition has been superseded and is retained here only for archival purposes. Use instead _space_group_name_Hall.

Space-group symbol as described by Hall. This symbol gives the space-group setting explicitly. Leave spaces between the separate components of the symbol.

Reference: Hall, S. R. (1981). Acta Cryst. A37, 517–525; erratum (1981), A37, 921.

Examples: '-P 2ac 2n', '-R 3 2"', 'P 61 2 2 (0 0 -1)'. [symmetry]

SYMMETRY_EQUIV

Data items in the SYMMETRY_EQUIV category list the symmetry-equivalent positions for the space group.

Example 1 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].

```
loop_
_symmetry_equiv_pos_as_xyz
_x,+y,+z 1/2-x,-y,1/2+z 1/2+x,1/2-y,-z -x,1/2+y,1/2-z
```

```
Example 2 – based on data set TOZ of Willis, Beckwith & Tozer [Acta Cryst. (1991), C47, 2276–2277].
```

Formally, the value of **symmetry_equiv_pos_site_id** can be any unique character string; it is recommended that it be assigned the sequence number of the list of equivalent positions for compatibility with older files in which it did not appear.

symmetry equiv pos as xyz

(char)

This definition has been superseded and is retained here only for archival purposes. Use instead _space_group_symop_operation_xyz.

Symmetry-equivalent position in the 'xyz' representation. Except for the space group P1, these data will be repeated in a loop. The format of the data item is as per International Tables for Crystallography Vol. A. (2002). All equivalent positions should be entered, including those for lattice centring and a centre of symmetry, if present. In order for the defaults to work correctly, the identity operation should have _space_group_symop_id or _symmetry_equiv_pos_site_id set to 1, and _space_group_symop_operation_xyz or _symmetry_equiv_pos_as_xyz set to x, y, z; i.e. the operation labelled 1 should be the identity operation.

May appear in list. Where no value is given, the assumed value is 'x, y, z'.

Example: '-y+x, -y, 1/3+z'. [symmetry_equiv]

symmetry equiv pos site id

(numb)

This definition has been superseded and is retained here only for archival purposes. Use instead ${\tt space_group_symop_id}$.

A code identifying each entry in the _symmetry_equiv_pos_as_xyz list. It is normally the sequence number of the entry in that list, and should be identified with the code 'n' in _geom_*_symmetry_ codes of the form 'n_klm'. In order for the defaults to work correctly, the identity operation should have _space_group_symop_id or _symmetry_equiv_pos_site_id set to 1, and _space_group_symop_operation_xyz or _symmetry_equiv_pos_as_xyz set to x, y, z; i.e. the operation labelled 1 should be the identity operation.

Appears in list containing _symmetry_equiv_pos_as_xyz. Where no value is given, the assumed value is '1'. [symmetry equiv]

VALENCE_PARAM

Data items in the VALENCE_PARAM category define the parameters used for calculating bond valences from bond lengths. In addition to the parameters, a pointer is given to the reference (in VALENCE_REF) from which the bond-valence parameters were taken.

 $\label{lem:example 1-abond-valence parameter list with accompanying references.}$

```
1000
_valence_param_id
_{
m valence\_param\_atom\_1}
_valence_param_atom_1_valence
_valence_param_atom_2
valence_param_atom_2_valence
valence param Ro
valence param B
valence param ref id
valence param details
     Cu 2 O -2 1.679 0.37 a .
 1
     Cu 2 O -2 1.649 0.37 j .
     Cu 2 N -3 1.64 0.37 m '2-coordinate N'
 3
     Cu 2 N -3 1.76 0.37 m '3-coordinate N'
100p
valence_ref_id
valence ref reference
    'Brown & Altermatt (1985), Acta Cryst. B41, 244-247'
    'Liu & Thorp (1993), Inorg. Chem. 32, 4102-4205'
    'See, Krause & Strub (1998), Inorg. Chem. 37, 5369-5375'
```

4. DATA DICTIONARIES

valence param atom 1

(char)

The element symbol of the first atom forming the bond whose bond-valence parameters are given in this category.

Appears in list containing _valence_param_id.

[valence param]

valence param atom 1 valence

(numb)

The valence (formal charge) of the first atom whose bond-valence parameters are given in this category.

Appears in list containing _valence_param_id.

[valence param]

valence param atom 2

(char)

The element symbol of the second atom forming the bond whose bond-valence parameters are given in this category.

Appears in list containing _valence_param_id.

[valence_param]

valence param atom 2 valence

(numb)

The valence (formal charge) of the second atom whose bond-valence parameters are given in this category.

Appears in list containing _valence_param_id.

[valence param]

valence param B

(numb)

The bond-valence parameter B used in the expression

$$s = \exp[(R_o - R)/B],$$

where s is the valence of a bond of length R.

Appears in list containing _valence_param_id.

[valence param]

valence param details

(char)

Details of or comments on the bond-valence parameters.

Appears in list containing valence param id.

[valence param]

valence param id

(char)

An identifier for the valence parameters of a bond between the given atoms.

Appears in list.

[valence_param]

valence param ref id

(char)

An identifier which links to the reference to the source from which the bond-valence parameters are taken. A child of valence ref id, which it must match.

Appears in list containing _valence_param_id. Must match parent data name valence ref id. [valence param]

valence param Ro

(numb)

The bond-valence parameter R_o used in the expression

$$s = \exp[(R_o - R)/B],$$

where s is the valence of a bond of length R.

Appears in list containing _valence_param_id.

[valence_param]

VALENCE_REF

Data items in the VALENCE_REF category list the references from which the bond-valence parameters have been taken.

valence ref id

(char)

An identifier for items in this category. Parent of _valence_param ref id, which must have the same value.

Appears in list containing _valence_ref_id. May match child data name(s):

_valence_param_ref_id.

[valence ref]

valence ref reference

(char)

Literature reference from which the valence parameters identified by valence param id were taken.

Appears in list containing _valence_ref_id.

[valence_ref]